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PART 2 RF EXPOSURE EVALUATION REPORT

Applicant Name:
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United States

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Test Site/Location:
PCTEST, Columbia, MD, USA
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FCC ID: **ZNFF100VM**

APPLICANT: **LG ELECTRONICS U.S.A., INC.**

DUT Type: Portable Handset
Application Type: Certification
FCC Rule Part(s): CFR §2.1093
Model: LM-F100VM
Additional Model(s): LMF100VM, F100VM, LM-F101V, LMF101V, F101V
Device Serial Numbers: 00310, 00377, 01698

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them. Test results reported herein relate only to the item(s) tested.

Randy Ortanez
President

ACCREDITED
CERT #2041.01

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1 DEVICE UNDER TEST

1.1 Device Overview

Band & Mode	Operating Modes	Tx Frequency
Cell. CDMA/EVDO	Voice/Data	824.70 - 848.31 MHz
PCS CDMA/EVDO	Voice/Data	1851.25 - 1908.75 MHz
GSM/GPRS/EDGE 850	Voice/Data	824.20 - 848.80 MHz
GSM/GPRS/EDGE 1900	Voice/Data	1850.20 - 1909.80 MHz
UMTS 850	Voice/Data	826.40 - 846.60 MHz
UMTS 1750	Voice/Data	1712.4 - 1752.6 MHz
UMTS 1900	Voice/Data	1852.4 - 1907.6 MHz
LTE Band 12	Voice/Data	699.7 - 715.3 MHz
LTE Band 13	Voice/Data	779.5 - 784.5 MHz
LTE Band 14	Voice/Data	790.5 - 795.5 MHz
LTE Band 5 (Cell)	Voice/Data	824.7 - 848.3 MHz
LTE Band 66 (AWS)	Voice/Data	1710.7 - 1779.3 MHz
LTE Band 4 (AWS)	Voice/Data	1710.7 - 1754.3 MHz
LTE Band 2 (PCS)	Voice/Data	1850.7 - 1909.3 MHz
LTE Band 30	Voice/Data	2307.5 - 2312.5 MHz
LTE Band 48	Voice/Data	3552.5 - 3697.5 MHz
LTE Band 41	Voice/Data	2498.5 - 2687.5 MHz
NR Band n5 (Cell)	Data	826.5 - 846.5 MHz
NR Band n66 (AWS)	Data	1712.5 - 1777.5 MHz
NR Band n2 (PCS)	Data	1852.5 - 1907.5 MHz
2.4 GHz WLAN	Voice/Data	2412 - 2462 MHz
U-NII-1	Voice/Data	5180 - 5240 MHz
U-NII-2A	Voice/Data	5260 - 5320 MHz
U-NII-2C	Voice/Data	5500 - 5720 MHz
U-NII-3	Voice/Data	5745 - 5825 MHz
Bluetooth	Data	2402 - 2480 MHz
NFC	Data	13.56 MHz
WMC	Data	500 Hz - 4 kHz
NR Band n260	Data	37000 - 40000 MHz
NR Band n261	Data	27500 - 28350 MHz

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1.2 Time-Averaging Algorithm for RF Exposure Compliance

The device under test (DUT) contains:

a. Qualcomm® SM7250 modem supporting 2G/3G/4G/5G NR WWAN technologies

Qualcomm® SM7250 modem is enabled with Qualcomm® Smart Transmit feature. This feature performs time averaging algorithm in real time to control and manage transmitting power and ensure the time-averaged RF exposure is in compliance with FCC requirements all the time.

The Smart Transmit algorithm maintains the time-averaged transmit power, in turn, time-averaged RF exposure of SAR_design_target or PD_design_target, below the predefined time-averaged power limit (i.e., Plimit for sub-6 radio, and input.power.limit for 5G mmW NR), for each characterized technology and band.

Smart Transmit allows the device to transmit at higher power instantaneously, as high as P_{max}, when needed, but enforces power limiting to maintain time-averaged transmit power to P_{limit} for frequencies < 6 GHz and *input.power.limit* for frequencies > 6 GHz.

Note that the device uncertainty for sub-6GHz WWAN is 1.0dB for this DUT, the device uncertainty for mmW is 2.1 dB, and the reserve power margin is 3 dB.

This purpose of the Part 2 report is to demonstrate the DUT complies with FCC RF exposure requirement under Tx varying transmission scenarios, thereby validity of Qualcomm® Smart Transmit feature implementation in this device. It serves to compliment the Part 0 and Part 1 Test Reports to justify compliance per FCC.

1.3 Part 2 Test Reduction for Multiple Filings

Per FCC guidance, number of test cases for Part 2 evaluation can be reduced in the case of multiple filings using the same chipset after full part 2 testing on the first filing. While the same chipset and Smart Transmit algorithm are used in this model, DUT with the final SW was tested for power measurements to verify the integration. The essential test cases in power measurement are required to ensure the Smart Transmit performs as expected in the new design, but the SAR measurements can be excluded per FCC guidance.

1.4 Bibliography

Report Type	Report Serial Number
Part 0 SAR Test Report	Rev.A
Part 1 SAR Test Report	1M2006150096-01-R1.ZNF
Part 0 Power Density Test Report	Rev.A
Part 1 Power Density Test Report	1M2006150096-22-R1.ZNF
Power Density Simulation Report	Rev.A
RF Exposure Compliance Summary	1M2006150096-24.ZNF

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2 RF EXPOSURE LIMITS

2.1 Uncontrolled Environment

UNCONTROLLED ENVIRONMENTS are defined as locations where there is the exposure of individuals who have no knowledge or control of their exposure. The general population/uncontrolled exposure limits are applicable to situations in which the general public may be exposed or in which persons who are exposed as a consequence of their employment may not be made fully aware of the potential for exposure or cannot exercise control over their exposure. Members of the general public would come under this category when exposure is not employment-related; for example, in the case of a wireless transmitter that exposes persons in its vicinity.

2.2 Controlled Environment

CONTROLLED ENVIRONMENTS are defined as locations where there is exposure that may be incurred by persons who are aware of the potential for exposure, (i.e. as a result of employment or occupation). In general, occupational/controlled exposure limits are applicable to situations in which persons are exposed as a consequence of their employment, who have been made fully aware of the potential for exposure and can exercise control over their exposure. This exposure category is also applicable when the exposure is of a transient nature due to incidental passage through a location where the exposure levels may be higher than the general population/uncontrolled limits, but the exposed person is fully aware of the potential for exposure and can exercise control over his or her exposure by leaving the area or by some other appropriate means.

2.3 RF Exposure Limits for Frequencies Below 6 GHz

Table 2-1
SAR Human Exposure Specified in ANSI/IEEE C95.1-1992 and Health Canada Safety Code 6

HUMAN EXPOSURE LIMITS		
	UNCONTROLLED ENVIRONMENT *General Population* (W/kg) or (mW/g)	CONTROLLED ENVIRONMENT *Occupational* (W/kg) or (mW/g)
Peak Spatial Average SAR Head	1.6	8.0
Whole Body SAR	0.08	0.4
Peak Spatial Average SAR Hands, Feet, Ankle, Wrists, etc.	4.0	20

1. The Spatial Peak value of the SAR averaged over any 1 gram of tissue (defined as a tissue volume in the shape of a cube) and over the appropriate averaging time.
2. The Spatial Average value of the SAR averaged over the whole body.
3. The Spatial Peak value of the SAR averaged over any 10 grams of tissue (defined as a tissue volume in the shape of a cube) and over the appropriate averaging time.

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2.4 RF Exposure Limits for Frequencies Above 6 GHz

Per §1.1310 (d)(3), the MPE limits are applied for frequencies above 6 GHz. Power Density is expressed in units of W/m^2 or mW/cm^2.

Peak Spatially Averaged Power Density was evaluated over a circular area of 4 cm^2 per interim FCC Guidance for near-field power density evaluations per October 2018 TCB Workshop notes.

Table 2-2
Human Exposure Limits Specified in FCC 47 CFR §1.1310

Human Exposure to Radiofrequency (RF) Radiation Limits		
Frequency Range [MHz]	**Power Density** [mW/cm^2]	**Averaging Time** [Minutes]
(A) Limits for Occupational / Controlled Environments		
1,500 – 100,000	5.0	6
(B) Limits for General Population / Uncontrolled Environments		
1,500 – 100,000	1.0	30

Note: 1.0 mW/cm^2 is 10 W/m^2

2.5 Time Averaging Windows for FCC Compliance

Per October 2018 TCB Workshop Notes, the below time-averaging windows can be used for assessing time-averaged exposures for devices that are capable of actively monitoring and adjusting power output over time to comply with exposure limits.

Interim Guidance	Frequency (GHz)	Maximum Averaging Time (sec)
SAR	< 3	100
	3 – 6	60
MPE	6 - 10	30
	10 - 16	14
	16 – 24	8
	24 – 42	4
	42 – 95	2

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3 TIME VARYING TRANSMISSION TEST CASES

To validate the time averaging feature and demonstrate the compliance in Tx varying transmission conditions, the following transmission scenarios are covered in the Part 2 test:

1. During a time-varying Tx power transmission: To prove that the Smart Transmit feature accounts for Tx power variations in time accurately.
2. During a call disconnect and re-establish scenario: To prove that the Smart Transmit feature accounts for history of past Tx power transmissions accurately.
3. During a technology/band handover: To prove that the Smart Transmit feature functions correctly during transitions in technology/band.
4. During a DSI (Device State Index) change: To prove that the Smart Transmit feature functions correctly during transition from one device state (DSI) to another.
5. During an antenna (or beam) switch: To prove that the Smart Transmit feature functions correctly during transitions in antenna (such as AsDiv scenario) or beams (different antenna array configurations) or beams (different antenna array configurations).
6. SAR vs. PD exposure switching during sub-6+mmW transmission: To prove that the Smart Transmit feature functions correctly and ensures total RF exposure compliance during transitions in SAR dominant exposure, SAR+PD exposure, and PD dominant exposure scenarios.
7. During time window switch: To prove that the Smart Transmit feature correctly handles the transition from one time window to another specified by FCC, and maintains the normalized time-averaged RF exposure to be less than normalized FCC limit of 1.0 at all times.
8. SAR exposure switching between two active radios (radio1 and radio2): To prove that the Smart Transmit feature functions correctly and ensures total RF exposure compliance when exposure varies among SAR_radio1 only, SAR_radio1 + SAR_radio2, and SAR_radio2 only scenarios.

As described in Part 0 report, the RF exposure is proportional to the Tx power for a SAR- and PD-characterized wireless device. Thus, feature validation in Part 2 can be effectively performed through conducted (for f < 6GHz) and radiated (for f ⩾ 6GHz) power measurement. Therefore, the compliance demonstration under dynamic transmission conditions and feature validation are done in conducted/radiated power measurement setup for transmission scenario 1 through 8.

To add confidence in the feature validation, the time-averaged SAR and PD measurements are also performed but only performed for transmission scenario 1 to avoid the complexity in SAR and PD measurement (such as, for scenario 3 requiring change in SAR probe calibration file to accommodate different bands and/or tissue simulating liquid).

The strategy for testing in Tx varying transmission condition is outlined as follows:

- Demonstrate the total RF exposure averaged over FCC defined time windows does not exceed FCC's SAR and PD limits, through <u>time-averaged power</u> measurements
    - Measure conducted Tx power (for *f* < 6GHz) versus time, and radiated Tx power (EIRP for f > 10GHz) versus time.
    - Convert it into RF exposure and divide by respective FCC limits to get normalized exposure versus time.
    - Perform running time-averaging over FCC defined time windows.
    - Demonstrate that the total normalized time-averaged RF exposure is less than 1 for all transmission scenarios (i.e., transmission scenarios 1, 2, 3, 4, 5, 6, 7, and 8) at all times.

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Mathematical expression:

For < 6 GHz transmission only:

$$1g_or_10gSAR(t) = \frac{conducted_Tx_power(t)}{conducted_Tx_power_P_{limit}} * 1g_or_10gSAR_P_{limit} \quad (1a)$$

$$\frac{\frac{1}{T_{SAR}}\int_{t-T_{SAR}}^{t} 1g_or_10gSAR(t)dt}{FCC\ SAR\ limit} \leq 1 \quad (1b)$$

For sub-6+mmW transmission:

$$1g_or_10gSAR(t) = \frac{conducted_Tx_power(t)}{conducted_Tx_power_P_{limit}} * 1g_or_10gSAR_P_{limit} \quad (2a)$$

$$4cm^2PD(t) = \frac{radiated_Tx_power(t)}{radiated_Tx_power_input.power.limit} * 4cm^2PD_input.power.limit \quad (2b)$$

$$\frac{\frac{1}{T_{SAR}}\int_{t-T_{SAR}}^{t} 1g_or_10gSAR(t)dt}{FCC\ SAR\ limit} + \frac{\frac{1}{T_{PD}}\int_{t-T_{PD}}^{t} 4cm^2PD(t)dt}{FCC\ 4cm^2\ PD\ limit} \leq 1 \quad (2c)$$

where, $conducted_Tx_power(t)$, $conducted_Tx_power_P_{limit}$, and $1g_or_10gSAR_P_{limit}$ correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at P_{limit}, and measured *1gSAR or 10gSAR* values at P_{limit} corresponding to sub-6 transmission. Similarly, $radiated_Tx_power(t)$, $radiated_Tx_power_input.power.limit$, and $4cm^2PD_input.power.limit$ correspond to the measured instantaneous radiated Tx power, radiated Tx power at *input.power.limit* (i.e., radiated power limit), and 4cm^{2}PD value at *input.power.limit* corresponding to mmW transmission. Both P_{limit} and *input.power.limit* are the parameters pre-defined in Part 0 and loaded via Embedded File System (EFS) onto the EUT. T_{SAR} is the FCC defined time window for sub-6 radio; T_{PD} is the FCC defined time window for mmW radio.

- Demonstrate the total RF exposure averaged over FCC defined time windows does not exceed FCC's SAR and PD limits, through time-averaged SAR and PD measurements. Note as mentioned earlier, this measurement is performed for transmission scenario 1 only.
    - For sub-6 transmission only, measure instantaneous SAR versus time; for LTE+sub6 NR transmission, request low power (or all-down bits) on LTE so that measured SAR predominantly corresponds to sub6 NR.
    - For LTE + mmW transmission, measure instantaneous E-field versus time for mmW radio and instantaneous conducted power versus time for LTE radio.
    - Convert it into RF exposure and divide by respective FCC limits to obtain normalized exposure versus time.
    - Perform time averaging over FCC defined time window.
    - Demonstrate that the total normalized time-averaged RF exposure is less than 1 for transmission scenario 1 at all times.

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Mathematical expression:

- For sub-6 transmission only:

$$1g_or_10gSAR(t) = \frac{pointSAR(t)}{pointSAR_P_{limit}} * 1g_or_10gSAR(t)_P_{limit} \quad (3a)$$

$$\frac{\frac{1}{T_{SAR}}\int_{t-T_{SAR}}^{t} 1g_or_10gSAR(t)dt}{FCC\ SAR\ limit} \leq 1 \quad (3b)$$

- For LTE+mmW transmission:

$$1g_or_10gSAR(t) = \frac{conducted_Tx_power(t)}{conducted_Tx_power_P_{limit}} * 1g_or_10gSAR_P_{limit} \quad (4a)$$

$$4cm^2PD(t) = \frac{[pointE(t)]^2}{[pointE_input.power.limit]^2} * 4cm^2PD_input.power.limit \quad (4b)$$

$$\frac{\frac{1}{T_{SAR}}\int_{t-T_{SAR}}^{t} 1g_or_10gSAR(t)dt}{FCC\ SAR\ limit} + \frac{\frac{1}{T_{PD}}\int_{t-T_{PD}}^{t} 4cm^2PD(t)dt}{FCC\ 4cm^2PD\ limit} \leq 1 \quad (4c)$$

where, $pointSAR(t)$, $pointSAR_P_{limit}$, and $1g_or_10gSAR_P_{limit}$ correspond to the measured instantaneous point SAR, measured point SAR at P_{limit}, and measured *1gSAR* or 10gSAR values at P_{limit} corresponding to sub-6 transmission. Similarly, $pointE(t)$, $pointE_input.power.limit$, and $4cm^2PD_input.power.limit$ correspond to the measured instantaneous E-field, E-field at *input.power.limit*, and 4cm^{2}PD value at *input.power.limit* corresponding to mmW transmission.

Note: cDASY6 measurement system by Schmid & Partner Engineering AG (SPEAG) of Zurich, Switzerland measures relative E-field, and provides ratio of $\frac{[pointE(t)]^2}{[pointE_input.power.limit]^2}$ versus time.

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4 FCC MEASUREMENT PROCEDURES (FREQ < 6 GHZ)

This chapter provides the test plan and test procedure for validating Qualcomm Smart Transmit feature for sub-6 transmission. The 100 seconds time window for operating f < 3GHz is used as an example to detail the test procedures in this chapter. The same test plan and test procedures described in this chapter apply to 60 seconds time window for operating f ≥ 3GHz.

4.1 Test sequence determination for validation

Following the FCC recommendation, two test sequences having time-variation in Tx power are predefined for sub-6 (*f* < 6 GHz) validation:

- Test sequence 1: request DUT's Tx power to be at maximum power, measured P_{max}†, for 80s, then requesting for half of the maximum power, i.e., measured $P_{max}/2$, for the rest of the time.
- Test sequence 2: request DUT's Tx power to vary with time. This sequence is generated relative to measured P_{max}, measured P_{limit} and calculated $P_{reserve}$ (= measured P_{limit} in dBm - *Reserve_power_margin* in dB) of DUT based on measured P_{limit}.

The details for generating these two test sequences is described and listed in Appendix C.

NOTE: For test sequence generation, "measured P_{limit}" and "measured P_{max}" are used instead of the "P_{limit}" specified in EFS entry and "P_{max}" specified for the device, because the Smart Transmit feature operates against the actual power level of the "P_{limit}" that was calibrated for the DUT. The "measured P_{limit}" accurately reflects what the feature is referencing to, therefore, it should be used during feature validation testing. The RF tune up and device-to-device variation are already considered in Part 0 report prior to determining P_{limit}.

4.2 Test configuration selection criteria for validating Smart Transmit feature

For validating the Smart Transmit feature, this section provides the general guidance to select test cases.

4.2.1 Test configuration selection for time-varying Tx power transmission

The Smart Transmit time averaging feature operation is independent of bands, modes, and channels for a given technology. Hence, validation of Smart Transmit in one band/mode/channel per technology is sufficient. Two bands per technology are proposed and selected for this testing to provide high confidence in this validation.

The criteria for the selection are based on the P_{limit} values determined in Part 0 report. Select two bands* in each supported technology that correspond to least** and highest*** P_{limit} values that are less than P_{max} for validating Smart Transmit.

* If one P_{limit} level applies to all the bands within a technology, then only one band needs to be tested. In this case, within the bands having the same P_{limit}, the radio configuration (e.g., # of RBs, channel#) and device position that correspond to the highest *measured* 1gSAR at P_{limit} shown in Part 1 report is selected.

** In case of multiple bands having the same least P_{limit} within the technology, then select the band having the highest *measured* 1gSAR at P_{limit}.

*** The band having a higher P_{limit} needs to be properly selected so that the power limiting enforced by Smart Transmit can be validated using the pre-defined test sequences. If the highest P_{limit} in a technology is too high where the power limiting enforcement is not needed when testing with the pre-defined test sequences, then the

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next highest level is checked. This process is continued within the technology until the second band for validation testing is determined.

4.2.2 Test configuration selection for change in call

The criteria to select a test configuration for call-drop measurement is:

- Select technology/band with least P_{limit} among all supported technologies/bands, and select the radio configuration (e.g., # of RBs, channel#) in this technology/band that corresponds to the highest *measured* 1gSAR at P_{limit} listed in Part 1 report.
- In case of multiple bands having same least P_{limit}, then select the band having the highest *measured* 1gSAR at P_{limit} in Part 1 report.

This test is performed with the DUT's Tx power requested to be at maximum power, the above band selection will result in Tx power enforcement (i.e., DUT forced to have Tx power at $P_{reserve}$) for longest duration in one FCC defined time window. The call change (call drop/reestablish) is performed during the Tx power enforcement duration (i.e., during the time when DUT is forced to have Tx power at $P_{reserve}$). One test is sufficient as the feature operation is independent of technology and band.

4.2.3 Test configuration selection for change in technology/band

The selection criteria for this measurement is, for a given antenna, to have DUT switch from a technology/band with lowest P_{limit} within the technology group (in case of multiple bands having the same P_{limit}, then select the band with highest *measured* 1gSAR at P_{limit}) to a technology/band with highest P_{limit} within the technology group, in case of multiple bands having the same P_{limit}, then select the band with lowest *measured* 1gSAR at P_{limit} in Part 1 report, or vice versa.

This test is performed with the DUT's Tx power requested to be at maximum power, the technology/band switch is performed during Tx power enforcement duration (i.e., during the time when DUT is forced to have Tx power at $P_{reserve}$).

4.2.4 Test configuration selection for change in antenna

The criteria to select a test configuration for antenna switch measurement is:

- Whenever possible and supported by the DUT, first select antenna switch configuration within the same technology/band (i.e., same technology and band combination).
- Then, select any technology/band that supports multiple Tx antennas, and has the highest difference in P_{limit} among all supported antennas.
- In case of multiple bands having same difference in P_{limit} among supported antennas, then select the band having the highest *measured* 1gSAR at P_{limit} in Part 1 report.

This test is performed with the DUT's Tx power requested to be at maximum power in selected technology/band, and antenna change is conducted during Tx power enforcement duration (i.e., during the time when DUT is forced to have Tx power at $P_{reserve}$).

4.2.5 Test configuration selection for change in DSI

The criteria to select a test configuration for DSI change test is

- Select a technology/band having the $P_{limit} < P_{max}$ within any technology and DSI group, and for the same technology/band having a different P_{limit} in any other DSI group. Note that the selected DSI transition need to be supported by the device.

This test is performed with the DUT's Tx power requested to be at maximum power in selected technology/band, and DSI change is conducted during Tx power enforcement duration (i.e., during the time when DUT is forced to have Tx power at $P_{reserve}$).

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4.2.6 Test configuration selection for change in time window

FCC specifies different time window for time averaging based on operation frequency. The criteria to select a test configuration for validating Smart Transmit feature and demonstrating the compliance during the change in time window is

- Select any technology/band that has operation frequency classified in one time window defined by FCC (such as 100-seconds time window), and its corresponding P_{limit} is less than P_{max} if possible.
- Select the 2nd technology/band that has operation frequency classified in a different time window defined by FCC (such as 60-seconds time window), and its corresponding P_{limit} is less than P_{max} if possible.
- Note it is preferred both P_{limit} values of two selected technology/band less than corresponding P_{max}, but if not possible, at least one of technologies/bands has its P_{limit} less than P_{max}.

This test is performed with the EUT's Tx power requested to be at maximum power in selected technology/band. Test for one pair of time windows selected is sufficient as the feature operation is the same.

4.2.7 Test configuration selection for SAR exposure switching

If supported, the test configuration for SAR exposure switching should cover

1. SAR exposure switch when two active radios are in the same time window
2. SAR exposure switch when two active radios are in different time windows. One test with two active radios in any two different time windows is sufficient as Smart Transmit operation is the same for RF exposure switch in any combination of two different time windows. For device supporting LTE + mmW NR, this test is covered in SAR vs PD exposure switch validation.

The Smart Transmit time averaging operation is independent of the source of SAR exposure (for example, LTE vs. Sub6 NR) and ensures total time-averaged RF exposure compliance. Hence, validation of Smart Transmit in any one simultaneous SAR transmission scenario (i.e., one combination for LTE + Sub6 NR transmission) is sufficient, where the SAR exposure varies among SAR_{radio1} only, SAR_{radio1} + SAR_{radio2}, and SAR_{radio2} only scenarios.

The criteria to select a test configuration for validating Smart Transmit feature during SAR exposure switching scenarios is

- Select any two < 6GHz technologies/bands that the EUT supports simultaneous transmission (for example, LTE+Sub6 NR).
- Among all supported simultaneous transmission configurations, the selection order is
  1. select one configuration where both P_{limit} of radio1 and radio2 is less than their corresponding P_{max}, preferably, with different P_{limits}. If this configuration is not available, then,
  2. select one configuration that has P_{limit} less than its P_{max} for at least one radio. If this can not be found, then,
  3. select one configuration that has P_{limit} of radio1 and radio2 greater than P_{max} but with least ($P_{limit} – P_{max}$) delta.

Test for one simultaneous transmission scenario is sufficient as the feature operation is the same.

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4.3 Test procedures for conducted power measurements

This section provides general conducted power measurement procedures to perform compliance test under dynamic transmission scenarios described in Section 3. In practice, an adjustment can be made in these procedures. The justification/clarification may be provided.

4.3.1 Time-varying Tx power transmission scenario

This test is performed with the two pre-defined test sequences described in Section 4.1 for all the technologies and bands selected in Section 4.2.1. The purpose of the test is to demonstrate the effectiveness of power limiting enforcement and that the time-averaged SAR (corresponding time-averaged Tx power) does not exceed the FCC limit at all times (see Eq. (1a) and (1b)).

Test procedure

1. Measure P_{max}, measure P_{limit} and calculate $P_{reserve}$ (= measured P_{limit} in dBm – *Reserve_power_margin* in dB) and follow Section 4.1 to generate the test sequences for all the technologies and bands selected in Section 4.2.1. Both test sequence 1 and test sequence 2 are created based on measured P_{max} and measured P_{limit} of the DUT. Test condition to measure P_{max} and P_{limit} is:
    a. Measure P_{max} with Smart Transmit <u>disabled</u> and callbox set to request maximum power.
    b. Measure P_{limit} with Smart Transmit <u>enabled</u> and *Reserve_power_margin* set to 0 dB, callbox set to request maximum power.
2. Set *Reserve_power_margin* to actual (intended) value (3dB for this DUT based on Part 1 report) and reset power on DUT to enable Smart Transmit, establish radio link in desired radio configuration, with callbox requesting the DUT's Tx power to be at pre-defined test sequence 1, measure and record Tx power versus time, and then convert the conducted Tx power into 1gSAR or 10gSAR value (see Eq. (1a)) using measured P_{limit} from above Step 1. Perform running time average to determine time-averaged power and 1gSAR or 10gSAR versus time as illustrated in Figure 4-1 where using 100-seconds time window as an example.

    Note: In Eq.(1a), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the measured worst-case 1gSAR or 10gSAR value at P_{limit} for the corresponding technology/band/antenna/DSI reported in Part 1 report.

    Note: For an easier computation of the running time average, 0 dBm can be added at the beginning of the test sequences the length of the responding time window, for example, add 0dBm for 100-seconds so the running time average can be directly performed starting with the first 100-seconds data using excel spreadsheet. This technique applies to all tests performed in this Part 2 report for easier time-averaged computation using excel spreadsheet.

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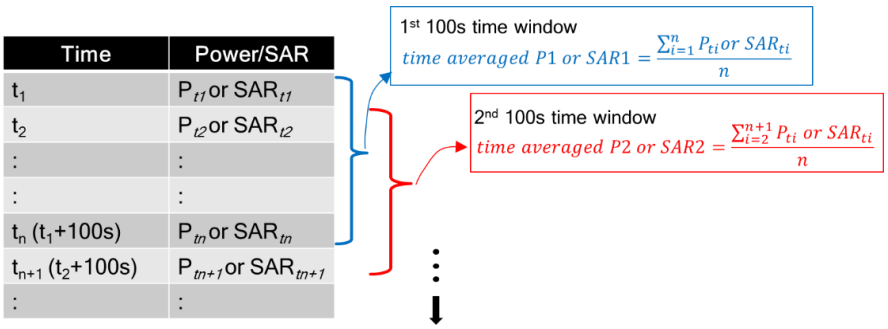

Figure 4-1
Running Average Illustration

3. Make one plot containing:
   a. Instantaneous Tx power versus time measured in Step 2,
   b. Requested Tx power used in Step 2 (test sequence 1),
   c. Computed time-averaged power versus time determined in Step 2,
   d. Time-averaged power limit (corresponding to FCC SAR limit of 1.6 W/kg for 1gSAR or 4.0W/kg for 10gSAR) given by

$$Time\ avearged\ power\ limit = meas.P_{limit} + 10 \times \log(\frac{FCC\ SAR\ limit}{meas.SAR_Plimit}) \qquad (5a)$$

where $meas.P_{limit}$ and $meas.SAR_Plimit$ correspond to measured power at P_{limit} and measured SAR at P_{limit}.

4. Make another plot containing:
   a. Computed time-averaged 1gSAR or 10gSAR versus time determined in Step 2
   b. FCC $1gSAR_{limit}$ of 1.6W/kg or FCC $10gSAR_{limit}$ of 4.0W/kg.
5. Repeat Steps 2 ~ 4 for pre-defined test sequence 2 and replace the requested Tx power (test sequence 1) in Step 2 with test sequence 2.
6. Repeat Steps 2 ~ 5 for all the selected technologies and bands.
7. The validation criteria are, at all times, the time-averaged power versus time shown in Step 3 plot shall not exceed the time-averaged power limit (defined in Eq. (5a)), in turn, the time-averaged 1gSAR or 10gSAR versus time shown in Step 4 plot shall not exceed the FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR (i.e., Eq. (1b)).

4.3.2 Change in call scenario

This test is to demonstrate that Smart Transmit feature accurately accounts for the past Tx powers during time-averaging when a new call is established.

The call disconnects and re-establishment needs to be performed during power limit enforcement, i.e., when the DUT's Tx power is at $P_{reserve}$ level, to demonstrate the continuity of RF exposure management and limiting in call change scenario. In other words, the RF exposure averaged over any FCC defined time window (including the time windows containing the call change) does not exceed FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

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Test procedure

1. Measure P_{limit} for the technology/band selected in Section 4.2.2. Measure P_{limit} with Smart Transmit enabled and *Reserve_power_margin* set to 0 dB, callbox set to request maximum power.
2. Set *Reserve_power_margin* to actual (intended) value and reset power on DUT to enable Smart Transmit.
3. Establish radio link with callbox in the selected technology/band.
4. Request DUT's Tx power at 0 dBm for at least one time window specified for the selected technology/band, followed by requesting DUT's Tx power to be at maximum power for about ~60 seconds, and then drop the call for ~10 seconds. Afterwards, re-establish another call in the same radio configuration (i.e., same technology/band/channel) and continue callbox requesting DUT's Tx power to be at maximum power for the remaining time of at least another full duration of the specified time window. Measure and record Tx power versus time. Once the measurement is done, extract instantaneous Tx power versus time, convert the measured conducted Tx power into 1gSAR or 10gSAR value using Eq. (1a), and then perform the running time average to determine time-averaged power and 1gSAR or 10gSAR versus time.

   NOTE: In Eq.(1a), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the measured worst-case 1gSAR or 10gSAR value at P_{limit} for the corresponding technology/band/antenna/DSI reported in Part 1 report.

5. Make one plot containing: (a) instantaneous Tx power versus time, (b) requested power, (c) computed time-averaged power, (d) time-averaged power limit calculated using Eq.(5a).
6. Make another plot containing: (a) computed time-averaged 1gSAR or 10gSAR versus time, and (b) FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

The validation criteria are, at all times, the time-averaged power versus time shall not exceed the time-averaged power limit (defined in Eq.(5a)), in turn, the time-averaged 1gSAR or 10gSAR versus time shall not exceed the FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR (i.e., Eq. (1b)).

4.3.3 Change in technology and band

This test is to demonstrate the correct power control by Smart Transmit during technology switches and/or band handovers.

Similar to the change in call test in Section 4.3.2, to validate the continuity of RF exposure limiting during the transition, the technology and band handover needs to be performed when DUT's Tx power is at $P_{reserve}$ level (i.e., during Tx power enforcement) to make sure that the DUT's Tx power from previous $P_{reserve}$ level to the new $P_{reserve}$ level (corresponding to new technology/band). Since the P_{limit} could vary with technology and band, Eq. (1a) can be written as follows to convert the instantaneous Tx power in 1gSAR or 10gSAR exposure for the two given radios, respectively:

$$1g_or_10gSAR_1(t) = \frac{conducted_Tx_power_1(t)}{conducted_Tx_power_P_{limit_1}} * 1g_or_10gSAR_P_{limit_1} \quad (6a)$$

$$1g_or_10gSAR_2(t) = \frac{conducted_Tx_power_2(t)}{conducted_Tx_power_P_{limit_2}} * 1g_or_10gSAR_P_{limit_2} \quad (6b)$$

$$\frac{1}{T_{SAR}}\left[\int_{t-T_{SAR}}^{t_1} \frac{1g_or_10gSAR_1(t)}{FCC\ SAR\ limit} dt + \int_{t-T_{SAR}}^{t} \frac{1g_or_10gSAR_2(t)}{FCC\ SAR\ limit} dt\right] \leq 1 \quad (6c)$$

where, *conducted_Tx_power_1(t)*, *conducted_Tx_power_*P_{limit_1}, and *1g_or_10gSAR_*P_{limit_1} correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at P_{limit}, and measured *1gSAR* or *10gSAR* value at P_{limit} of technology1/band1; *conducted_Tx_power_2(t)*,

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*conducted_Tx_power_*$P_{limit_2}(t)$, and *1g_or_10gSAR_*P_{limit_2} correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at P_{limit}, and measured *1gSAR* or *10gSAR* value at P_{limit} of technology2/band2. Transition from technology1/band1 to the technology2/band2 happens at time-instant 't_1'.

Test procedure

1. Measure P_{limit} for both the technologies and bands selected in Section 4.2.3. Measure P_{limit} with Smart Transmit enabled and *Reserve_power_margin* set to 0 dB, callbox set to request maximum power.
2. Set *Reserve_power_margin* to actual (intended) value and reset power on DUT to enable Smart Transmit
3. Establish radio link with callbox in first technology/band selected.
4. Request DUT's Tx power at 0 dBm for at least one time window specified for the selected technology/band, followed by requesting DUT's Tx power to be at maximum power for about ~60 seconds, and then switch to second technology/band selected. Continue with callbox requesting DUT's Tx power to be at maximum power for the remaining time of at least another full duration of the specified time window. Measure and record Tx power versus time for the full duration of the test.
5. Once the measurement is done, extract instantaneous Tx power versus time, and convert the conducted Tx power into 1gSAR or 10gSAR value using Eq. (6a) and (6b) and corresponding measured P_{limit} values from Step 1 of this section. Perform the running time average to determine time-averaged power and 1gSAR or 10gSAR versus time.

   NOTE: In Eq.(6a) & (6b), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the measured worst-case 1gSAR or 10gSAR value at P_{limit} for the corresponding technology/band/antenna/DSI reported in Part 1 report.

6. Make one plot containing: (a) instantaneous Tx power versus time, (b) requested power, (c) computed time-averaged power, (d) time-averaged power limit calculated using Eq.(5a).
7. Make another plot containing: (a) computed time-averaged 1gSAR or 10gSAR versus time, and (b) FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

The validation criteria are, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed the FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR (i.e., Eq. (6c)).

4.3.4 Change in antenna

This test is to demonstrate the correct power control by Smart Transmit during antenna switches from one antenna to another. The test procedure is identical to Section 4.3.3, by replacing technology/band switch operation with antenna switch. The validation criteria are, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

NOTE: If the DUT does not support antenna switch within the same technology/band, but has multiple antennas to support different frequency bands, then the antenna switch test is included as part of change in technology and band (Section 4.3.3) test.

4.3.5 Change in DSI

This test is to demonstrate the correct power control by Smart Transmit during DSI switches from one DSI to another. The test procedure is identical to Section 4.3.3, by replacing technology/band switch operation with DSI switch. The validation criteria are, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

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4.3.6 Change in time window

This test is to demonstrate the correct power control by Smart Transmit during the change in averaging time window when a specific band handover occurs. FCC specifies time-averaging windows of 100s for Tx frequency < 3GHz, and 60s for Tx frequency between 3GHz and 6GHz.

To validate the continuity of RF exposure limiting during the transition, the band handover test needs to be performed when EUT handovers from operation band less than 3GHz to greater than 3GHz and vice versa. The equations (3a) and (3b) in Section 2 can be written as follows for transmission scenario having change in time window,

$$1gSAR_1(t) = \frac{conducted_Tx_power_1(t)}{conducted_Tx_power_P_{limit_1}} * 1g_or\ 10g_SAR_P_{limit_1} \quad (7a)$$

$$1gSAR_2(t) = \frac{conducted_Tx_power_2(t)}{conducted_Tx_power_P_{limit_2}} * 1g_or\ 10g_SAR_P_{limit_2} \quad (7b)$$

$$\frac{1}{T1_{SAR}}\left[\int_{t-T1_{SAR}}^{t_1} \frac{1g_or\ 10g_SAR_1(t)}{FCC\ SAR\ limit} dt\right] + \frac{1}{T2_{SAR}}\left[\int_{t-T2_{SAR}}^{t} \frac{1g_{or}10g_SAR_2(t)}{FCC\ SAR\ limit} dt\right] \leq 1 \quad (7c)$$

where, *conducted_Tx_power_1(t)*, *conducted_Tx_power_*P_{limit_1}*(t)*, and *1g_ or 10g_SAR_*P_{limit_1} correspond to the instantaneous Tx power, conducted Tx power at P_{limit}, and compliance *1g_ or 10g_SAR* values at P_{limit_1} of band1 with time-averaging window '$T1_{SAR}$'; *conducted_Tx_power_2(t)*, *conducted_Tx_power_*P_{limit_2}*(t)*, and *1g_ or 10g_SAR_*P_{limit_2} correspond to the instantaneous Tx power, conducted Tx power at P_{limit}, and compliance *1g_ or 10g_SAR* values at P_{limit_2} of band2 with time-averaging window '$T2_{SAR}$'. One of the two bands is less than 3GHz, another is greater than 3GHz. Transition from first band with time-averaging window '$T1_{SAR}$' to the second band with time-averaging window '$T2_{SAR}$' happens at time-instant 't_1'.

Test procedure

1. Measure P_{limit} for both the technologies and bands selected in Section 4.2.6. Measure P_{limit} with Smart Transmit <u>enabled</u> and *Reserve_power_margin* set to 0 dB, callbox set to request maximum power.
2. Set *Reserve_power_margin* to actual (intended) value and enable Smart Transmit

Transition from 100s time window to 60s time window, and vice versa

3. Establish radio link with callbox in the technology/band having 100s time window selected in Section 4.2.6.
4. Request EUT's Tx power to be at 0 dBm for at least 100 seconds, followed by requesting EUT's Tx power to be at maximum power for about ~140 seconds, and then switch to second technology/band (having 60s time window) selected in Section 4.2.6. Continue with callbox requesting EUT's Tx power to be at maximum power for about ~60s in this second technology/band, and then switch back to the first technology/band. Continue with callbox requesting EUT's Tx power to be at maximum power for at least another 100s. Measure and record Tx power versus time for the entire duration of the test.
5. Once the measurement is done, extract instantaneous Tx power versus time, and convert the conducted Tx power into 1gSAR or 10gSAR value (see Eq. (7a) and (7b)) using corresponding technology/band Step 1 result, and then perform 100s running average to determine time-averaged 1gSAR or 10gSAR versus time. Note that in Eq.(7a) & (7b), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the worst-case 1gSAR or 10gSAR value tested in Part 1 for the selected technologies/bands at P_{limit}.
6. Make one plot containing: (a) instantaneous Tx power versus time measured in Step 4.
7. Make another plot containing: (a) instantaneous 1gSAR versus time determined in Step 5, (b) computed time-averaged 1gSAR versus time determined in Step 5, and (c) corresponding regulatory $1gSAR_{limit}$ of 1.6W/kg or $10gSAR_{limit}$ of 4.0W/kg.

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Transition from 60s time window to 100s time window, and vice versa

8. Establish radio link with callbox in the technology/band having 60s time window selected in Section 4.2.6.

9. Request EUT's Tx power to be at 0 dBm for at least 60 seconds, followed by requesting EUT's Tx power to be at maximum power for about ~80 seconds, and then switch to second technology/band (having 100s time window) selected in Section 4.2.6. Continue with callbox requesting EUT's Tx power to be at maximum power for about ~100s in this second technology/band, and then switch back to the first technology/band. Continue with callbox requesting EUT's Tx power to be at maximum power for the remaining time for a total test time of 500 seconds. Measure and record Tx power versus time for the entire duration of the test.

10. Repeat above Step 5~7 to generate the plots

The validation criteria is, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed the regulatory $1gSAR_{limit}$ of 1.6W/kg or $10gSAR_{limit}$ of 4.0W/kg.

4.3.7 SAR exposure switching

This test is to demonstrate that Smart Transmit feature is accurately accounts for switching in exposures among SAR from radio1 only, SAR from both radio1 and radio2, and SAR from radio2 only scenarios, and ensures total time-averaged RF exposure complies with the FCC limit. Here, radio1 represents primary radio (for example, LTE anchor in a NR non-standalone mode call) and radio2 represents secondary radio (for example, sub6 NR or mmW NR). The detailed test procedure for SAR exposure switching in the case of LTE+Sub6 NR non-standalone mode transmission scenario is provided in APPENDIX D:

Test procedure:

1. Measure conducted Tx power corresponding to P_{limit} for radio1 and radio2 in selected band. Test condition to measure conducted P_{limit} is:
   - Establish device in call with the callbox for radio1 technology/band. Measure conducted Tx power corresponding to radio1 P_{limit} with Smart Transmit <u>enabled</u> and *Reserve_power_margin* set to 0 dB, callbox set to request maximum power.
   - Repeat above step to measure conducted Tx power corresponding to radio2 $\underline{P_{limit}}$. If radio2 is dependent on radio1 (for example, non-standalone mode of Sub6 NR requiring radio1 LTE as anchor), then establish radio1 + radio2 call with callbox, and request all down bits for radio1 LTE. In this scenario, with callbox requesting maximum power from radio2 Sub6 NR, measured conducted Tx power corresponds to radio2 $\underline{P_{limit}}$ (as radio1 LTE is at all-down bits)

2. Set *Reserve_power_margin* to actual (intended) value, with EUT setup for radio1 + radio2 call. In this description, it is assumed that radio2 has lower priority than radio1. Establish device in radio1+radio2 call, and request all-down bits or low power on radio1, with callbox requesting EUT's Tx power to be at maximum power in radio2 for at least one time window. After one time window, set callbox to request EUT's Tx power to be at maximum power on radio1, i.e., all-up bits. Continue radio1+radio2 call with both radios at maximum power for at least one time window, and drop (or request all-down bits on) radio2. Continue radio1 at maximum power for at least one time window. Record the conducted Tx power for both radio1 and radio2 for the entire duration of this test.

3. Once the measurement is done, extract instantaneous Tx power versus time for both radio1 and radio2 links. Convert the conducted Tx power for both these radios into 1gSAR or 10gSAR value (see Eq. (6a) and (6b)) using corresponding technology/band P_{limit} measured in Step 1, and then perform the running time average to determine time-averaged 1gSAR or 10gSAR versus time.

4. Make one plot containing: (a) instantaneous Tx power versus time measured in Step 2.

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5. Make another plot containing: (a) instantaneous 1gSAR versus time determined in Step 3, (b) computed time-averaged 1gSAR versus time determined in Step 3, and (c) corresponding regulatory $1gSAR_{limit}$ of 1.6W/kg or $10gSAR_{limit}$ of 4.0W/kg.

The validation criteria is, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed the regulatory $1gSAR_{limit}$ of 1.6W/kg or $10gSAR_{limit}$ of 4.0W/kg.

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5 FCC MEASUREMENT PROCEDURES (FREQ > 6 GHZ)

This section provides the test plan and test procedures for validating Qualcomm Smart Transmit feature for mmW transmission. For this EUT, millimeter wave (mmW) transmission is only in non-standalone mode, i.e., it requires an LTE link as anchor.

5.1 Test sequence for validation in mmW NR transmission

In 5G mmW NR transmission, the test sequence for validation is with the callbox requesting EUT's Tx power in 5G mmW NR at maximum power all the time.

5.2 Test configuration selection criteria for validating Smart Transmit feature

5.2.1 Test configuration selection for time-varying Tx power transmission

The Smart Transmit time averaging feature operation is independent of bands, modes, channels, and antenna configurations (beams) for a given technology. Hence, validation of Smart Transmit in any one band/mode/channel per technology is sufficient.

5.2.2 Test configuration selection for change in antenna configuration (beam)

The Smart Transmit time averaging feature operation is independent of bands, modes, channels, and antenna configurations (beams) for a given technology. Hence, validation of Smart Transmit with beam switch between any two beams is sufficient.

5.2.3 Test configuration selection for SAR vs. PD exposure switch during transmission

The Smart Transmit time averaging feature operation is independent of the nature of exposure (SAR vs. PD) and ensures total time-averaged RF exposure compliance. Hence, validation of Smart Transmit in any one band/mode/channel/beam for mmW + sub-6 (LTE) transmission is sufficient, where the exposure varies among SAR dominant scenario, SAR+PD scenario, and PD dominant scenario.

5.3 Test procedures for mmW radiated power measurements

Perform conducted power measurement (for f < 6GHz) and radiated power measurement (for f > 6GHz) for LTE + mmW transmission to validate Smart Transmit time averaging feature in the various transmission scenarios described in Section 3.

This section provides general conducted power measurement procedures to perform compliance test under dynamic transmission scenarios described in Section 3. In practice, an adjustment can be made in these procedures. The justification/clarification may be provided.

5.3.1 Time-varying Tx power scenario

The purpose of the test is to demonstrate the effectiveness of power limiting enforcement and that the time-averaged Tx power when converted into RF exposure values does not exceed the FCC limit at all times (see Eq. (2a), (2b) & (2c) in Section 3).

Test procedure:

1. Measure conducted Tx power corresponding to P_{limit} for LTE in selected band, and measure radiated Tx power corresponding to *input.power.limit* in desired mmW band/channel/beam by following below steps:

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a. Measure radiated power corresponding to mmW *input.power.limit* by setting up the EUT's Tx power in desired band/channel/beam at *input.power.limit* in Factory Test Mode (FTM). This test is performed in a calibrated anechoic chamber. Rotate the EUT to obtain maximum radiated Tx power, keep the EUT in this position and do not disturb the position of the EUT inside the anechoic chamber for the rest of this test.

b. Reset EUT to place in online mode and establish radio link in LTE, measure conducted Tx power corresponding to LTE P_{limit} with Smart Transmit enabled and *Reserve_power_margin* set to 0 dB, callbox set to request maximum power.

2. Set *Reserve_power_margin* to actual (intended) value and reset power on EUT to enable Smart Transmit. With EUT setup for a mmW NR call in the desired/selected LTE band and mmW NR band, perform the following steps:

   a. Establish LTE and mmW NR connection in desired band/channel/beam used in Step 1. As soon as the mmW connection is established, immediately request all-down bits on LTE link. With callbox requesting EUT's Tx power to be at maximum mmW power to test predominantly PD exposure scenario (as SAR exposure is less when LTE's Tx power is at low power).

   b. After 120s, request LTE to go all-up bits for at least 100s. SAR exposure is dominant. There are two scenarios:

      i If $P_{limit} < P_{max}$ for LTE, then the RF exposure margin (provided to mmW NR) gradually runs out (due to high SAR exposure). This results in gradual reduction in the 5G mmW NR transmission power and eventually seized 5G mmW NR transmission when LTE goes to $P_{reserve}$ level.

      ii If $P_{limit} \geq P_{max}$ for LTE, then the 5G mmW NR transmission's averaged power should gradually reduce but the mmW NR connection can sustain all the time (assuming TxAGC uncertainty = 0dB).

   c. Record the conducted Tx power of LTE and radiated Tx power of mmW for the full duration of this test of at least 300s.

3. Once the measurement is done, extract instantaneous Tx power versus time for both LTE and mmW links. Convert the conducted Tx power for LTE into 1gSAR or 10gSAR value using Eq. (2a) and P_{limit} measured in Step 1.b, and then divide by FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR to obtain instantaneous normalized 1gSAR or 10gSAR versus time. Perform 100s running average to determine normalized 100s-averaged 1gSAR or 10gSAR versus time.

   NOTE: In Eq.(2a), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the measured worst-case 1gSAR or 10gSAR value at P_{limit} for the corresponding technology/band/antenna/DSI reported in Part 1 report.

4. Similarly, convert the radiated Tx power for mmW into 4cm^{2}PD value using Eq. (2b) and the radiated Tx power limit (i.e., radiated Tx power at *input.power.limit*) measured in Step 1.a, then divide by FCC 4cm^{2}PD limit of 10W/m^2 to obtain instantaneous normalized 4cm^{2}PD versus time. Perform 4s running average to determine normalized 4s-averaged 4cm^{2}PD versus time.

   NOTE: In Eq.(2b), instantaneous radiated Tx power is converted into instantaneous 4cm^{2}PD by applying the worst-case 4cm^{2}PD value measured at *input.power.limit* for the selected band/beam in Part 1 report.

5. Make one plot containing: (a) instantaneous conducted Tx power for LTE versus time, (b) computed 100s-averaged conducted Tx power for LTE versus time, (c) instantaneous radiated Tx power for

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mmW versus time, as measured in Step 2, (d) computed 4s-averaged radiated Tx power for mmW versus time, and (e) time-averaged conducted and radiated power limits for LTE and mmW radio using Eq. (5a) & (5b), respectively:

$$Time\ avearged\ LTE\ power\ limit = meas.P_{limit} + 10 \times \log(\frac{FCC\ SAR\ limit}{meas.SAR_Plimit}) \quad (5a)$$

$$Time\ avearged\ mmW\ NR\ power\ limit = meas.EIRP_{input.power.limit} + 10 \times \log(\frac{FCC\ PD\ limit}{meas.PD_input.power.limit}) \quad (5b)$$

where $meas.EIRP_{input.power.limit}$ and $meas.PD_input.power.limit$ correspond to measured EIRP at *input.power.limit* and measured power density at *input.power.limit*.

6. Make another plot containing: (a) computed normalized 100s-averaged 1gSAR or 10gSAR versus time determined in Step 3, (b) computed normalized 4s-averaged 4cm^{2}PD versus time determined in Step 4, and (c) corresponding total normalized time-averaged RF exposure (sum of steps (6.a) and (6.b)) versus time.

The validation criteria are, at all times, the total normalized time-averaged RF exposure versus time determined in Step 6.c shall not exceed the normalized limit of 1.0 of FCC requirement (i.e., Eq. (2c)).

5.3.2 Switch in SAR vs. PD exposure during transmission

This test is to demonstrate that Smart Transmit feature is independent of the nature of exposure (SAR vs. PD), accurately accounts for switching in exposures among SAR dominant, SAR+PD, and PD dominant scenarios, and ensures total time-averaged RF exposure compliance.

Test procedure:

1. Measure conducted Tx power corresponding to P_{limit} for LTE in selected band, and measure radiated Tx power corresponding to *input.power.limit* in desired mmW band/channel/beam by following below steps:
   a. Measure radiated power corresponding to *input.power.limit* by setting up the EUT's Tx power in desired band/channel/beam at *input.power.limit* in FTM. This test is performed in a calibrated anechoic chamber. Rotate the EUT to obtain maximum radiated Tx power, keep the EUT in this position and do not disturb the position of the EUT inside the anechoic chamber for the rest of this test.
   b. Reset EUT to place in online mode and establish radio link in LTE, measure conducted Tx power corresponding to LTE P_{limit} with Smart Transmit enabled and *Reserve_power_margin* set to 0 dB, callbox set to request maximum power.
2. Set *Reserve_power_margin* to actual (intended) value and reset power in EUT, with EUT setup for LTE + mmW call, perform the following steps:
   a. Establish LTE (sub-6) and mmW NR connection with callbox.
   b. As soon as the mmW connection is established, immediately request all-down bits on LTE link. Continue LTE (all-down bits) + mmW transmission for more than 100s duration to test predominantly PD exposure scenario (as SAR exposure is negligible from all-down bits in LTE).
   c. After 120s, request LTE to go all-up bits, mmW transmission should gradually run out of RF exposure margin if LTE's $P_{limit} < P_{max}$ and seize mmW transmission (SAR only scenario); or mmW transmission should gradually reduce in Tx power and will sustain the connection if LTE's $P_{limit} > P_{max}$.
   d. After 75s, request LTE to go all-down bits, mmW transmission should start getting back RF exposure margin and resume transmission again.

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e. Record the conducted Tx power of LTE and radiated Tx power of mmW for the entire duration of this test of at least 300s.

3. Once the measurement is done, extract instantaneous Tx power versus time for both LTE and mmW links. Convert the conducted Tx power for LTE into 1gSAR or 10gSAR value using Eq. (2a) and P_{limit} measured in Step 1.b, and then divide by FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR to obtain instantaneous normalized 1gSAR or 10gSAR versus time. Perform 100s running average to determine normalized 100s-averaged 1gSAR or 10gSAR versus time.

NOTE: In Eq.(2a), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the measured worst-case 1gSAR or 10gSAR value at P_{limit} for the corresponding technology/band/antenna/DSI reported in Part 1 report.

4. Similarly, convert the radiated Tx power for mmW into 4cm^{2}PD value using Eq. (2b) and the radiated Tx power limit (i.e., radiated Tx power at *input.power.limit*) measured in Step 1.a, then divide this by FCC 4cm^{2}PD limit of 10W/m^2 to obtain instantaneous normalized 4cm^{2}PD versus time. Perform 4s running average to determine normalized 4s-averaged 4cm^{2}PD versus time.

NOTE: In Eq.(2b), instantaneous radiated Tx power is converted into instantaneous 4cm^{2}PD by applying the worst-case 4cm^{2}PD value measured at *input.power.limit* for the selected band/beam in Part 1 report.

5. Make one plot containing: (a) instantaneous conducted Tx power for LTE versus time, (b) computed 100s-averaged conducted Tx power for LTE versus time, (c) instantaneous radiated Tx power for mmW versus time, as measured in Step 2, (d) computed 4s-averaged radiated Tx power for mmW versus time, and (e) time-averaged conducted and radiated power limits for LTE and mmW radio using Eq. (5a) & (5b), respectively.

6. Make another plot containing: (a) computed normalized 100s-averaged 1gSAR or 10gSAR versus time determined in Step 3, (b) computed normalized 4s-averaged 4cm^{2}PD versus time determined in Step 4, and (c) corresponding total normalized time-averaged RF exposure (sum of steps (6.a) and (6.b)) versus time.

The validation criteria are, at all times, the total normalized time-averaged RF exposure versus time determined in Step 6.c shall not exceed the normalized limit of 1.0 of FCC requirement (i.e., Eq. (2c)).

5.3.3 Change in antenna configuration (beam)

This test is to demonstrate the correct power control by Smart Transmit during changes in antenna configuration (beam). Since the *input.power.limit* varies with beam, the Eq. (2a), (2b) and (2c) in Section 3 are written as below for transmission scenario having change in beam,

$$1g_or_10gSAR(t) = \frac{conducted_Tx_power(t)}{conducted_Tx_power_P_{limit}} * 1g_or_10gSAR_P_{limit} \qquad (8a)$$

$$4cm^2PD_1(t) = \frac{radiated_Tx_power_1(t)}{radiated_Tx_power_input.power.limit_1} * 4cm^2PD_input.power.limit_1 \qquad (8b)$$

$$4cm^2PD_2(t) = \frac{radiated_Tx_power_2(t)}{radiated_Tx_power_input.power.limit_2} * 4cm^2PD_input.power.limit_2 \qquad (8c)$$

$$\frac{\frac{1}{T_{SAR}}\int_{t-T_{SAR}}^{t} 1g_or_10gSAR(t)dt}{FCC\ SAR\ limit} + \frac{\frac{1}{T_{PD}}\left[\int_{t-T_{PD}}^{t_1} 4cm^2\mathrm{PD}_1(t)dt + \int_{t_1}^{t} 4cm^2\mathrm{PD}_2(t)dt\right]}{FCC4cm^2\ PD\ limit} \leq 1 \qquad (8d)$$

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where, $conducted_Tx_power(t)$, $conducted_Tx_power_P_{limit}$, and $1g_or_10gSAR_P_{limit}$ correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at P_{limit}, and measured *1gSAR or 10gSAR* values at P_{limit} corresponding to LTE transmission. Similarly, *radiated_Tx_power_1(t)*, *radiated_Tx_power_input.power.limit_1*, and *4cm²PD_input.power.limit_1* correspond to the measured instantaneous radiated Tx power, radiated Tx power at *input.power.limit*, and *4cm²PD* value at *input.power.limit* of beam 1; *radiated_Tx_power_2(t)*, *radiated_Tx_power_input.power.limit_2*, and *4cm²PD_input.power.limit_2* correspond to the measured instantaneous radiated Tx power, radiated Tx power at *input.power.limit*, and *4cm²PD* value at *input.power.limit* of beam 2 corresponding to mmW transmission.

Test procedure:

1. Measure conducted Tx power corresponding to P_{limit} for LTE in selected band, and measure radiated Tx power corresponding to *input.power.limit* in desired mmW band/channel/beam by following below steps:
    a. Measure radiated power corresponding to mmW *input.power.limit* by setting up the EUT's Tx power in desired band/channel at *input.power.limit* of beam 1 in FTM. Do not disturb the position of the EUT inside the anechoic chamber for the rest of this test. Repeat this Step 1.a for beam 2.
    b. Reset EUT to place in online mode and establish radio link in LTE, measure conducted Tx power corresponding to LTE P_{limit} with Smart Transmit enabled and *Reserve_power_margin* set to 0 dB, callbox set to request maximum power.
2. Set *Reserve_power_margin* to actual (intended) value and reset power in EUT, With EUT setup for LTE + mmW connection, perform the following steps:
    a. Establish LTE (sub-6) and mmW NR connection in beam 1. As soon as the mmW connection is established, immediately request all-down bits on LTE link with the callbox requesting EUT's Tx power to be at maximum mmW power.
    b. After beam 1 continues transmission for at least 20s, request the EUT to change from beam 1 to beam 2, and continue transmitting with beam 2 for at least 20s.
    c. Record the conducted Tx power of LTE and radiated Tx power of mmW for the entire duration of this test.
3. Once the measurement is done, extract instantaneous Tx power versus time for both LTE and mmW links. Convert the conducted Tx power for LTE into 1gSAR or 10gSAR value using the similar approach described in Step 3 of Section 5.3.2. Perform 100s running average to determine normalized 100s-averaged 1gSAR versus time.
4. Similarly, convert the radiated Tx power for mmW NR into 4cm²PD value using Eq. (8b), (8c) and the radiated Tx power limits (i.e., radiated Tx power at *input.power.limit*) measured in Step 1.a for beam 1 and beam 2, respectively, and then divide the resulted PD values by FCC 4cm²PD limit of 10W/m² to obtain instantaneous normalized 4cm²PD versus time for beam 1 and beam 2. Perform 4s running average to determine normalized 4s-averaged 4cm²PD versus time.

    NOTE: In Eq.(8b) and (8c), instantaneous radiated Tx power of beam 1 and beam 2 is converted into instantaneous 4cm²PD by applying the worst-case 4cm²PD value measured at the *input.power.limit* of beam 1 and beam 2 in Part 1 report, respectively.

5. Since the measured radiated powers for beam 1 and beam 2 in Step 1.a were performed at an arbitrary rotation of EUT in anechoic chamber, repeat Step 1.a of this procedure by rotating the EUT to determine maximum radiated power at *input.power.limit* in FTM mode for both beams separately.

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Re-scale the measured instantaneous radiated power in Step 2.c by the delta in radiated power measured in Step 5 and the radiated power measured in Step 1.a for plotting purposes in next Step. In other words, this step essentially converts measured instantaneous radiated power during the measurement in Step 2 into maximum instantaneous radiated power for both beams. Perform 4s running average to compute 4s-avearged radiated Tx power. Additionally, use these EIRP values measured at *input.power.limit* at respective peak locations to determine the EIRP limits (using Eq. (5b)) for both these beams.

6. Make one plot containing: (a) instantaneous conducted Tx power for LTE versus time, (b) computed 100s-averaged conducted Tx power for LTE versus time, (c) instantaneous radiated Tx power for mmW versus time, as obtained in Step 5, (d) computed 4s-averaged radiated Tx power for mmW versus time, as obtained in Step 5, and (e) time-averaged conducted and radiated power limits for LTE and mmW radio, respectively.

7. Make another plot containing: (a) computed normalized 100s-averaged 1gSAR versus time determined in Step 3, (b) computed normalized 4s-averaged 4cm^{2}PD versus time determined in Step 4, and (c) corresponding total normalized time-averaged RF exposure (sum of steps (6.a) and (6.b)) versus time.

The validation criteria are, at all times, the total normalized time-averaged RF exposure versus time determined in Step 6.c shall not exceed the normalized limit of 1.0 of FCC requirement (i.e., (8d)).

5.4 Test procedure for time-varying PD measurements

The following steps are used to perform the validation through PD measurement for transmission scenario 1 described in Section 3:

1. Place the EUT on the cDASY6 platform to perform PD measurement in the worst-case position/surface for the selected mmW band/beam. In PD measurement, the callbox is set to request maximum Tx power from EUT all the time. Hence, “path loss” calibration between callbox antenna and EUT is not needed in this test.

2. Time averaging feature validation:

   a. Measure conducted Tx power corresponding to P_{limit} for LTE in selected band, and measure point E-field corresponding to *input.power.limit* in desired mmW band/channel/beam by following the below steps:

      i. Measure conducted Tx power corresponding to LTE P_{limit} with Smart Transmit <u>enabled</u> and *Reserve_power_margin* set to 0 dB, with callbox set to request maximum power.

      ii. Measure point E-field at peak location of fast area scan corresponding to *input.power.limit* by setting up the EUT’s Tx power in desired mmW band/channel/beam at *input.power.limit* in FTM. Do not disturb the position of EUT and mmW cDASY6 probe.

   b. Set *Reserve_power_margin* to actual value (i.e., intended value) and reset power on EUT, place EUT in online mode. With EUT setup for LTE (sub-6) + mmW NR call, as soon as the mmW NR connection is established, request all-down bits on LTE link. Continue LTE (all-down bits) + mmW transmission for more than 100s duration to test predominantly PD exposure scenario. After 120s, request LTE to go all-up bits, mmW transmission should gradually reduce. Simultaneously, record the conducted Tx power of LTE transmission using power meter and point E-field (in terms of ratio of $\frac{[pointE(t)]^2}{[pointE_input.power.limit]^2}$) of mmW transmission using cDASY6 E-field probe at peak location identified in Step 2.a.ii for the entire duration of this test of at least 300s.

   c. Once the measurement is done, extract instantaneous conducted Tx power versus time for LTE transmission and $\frac{[pointE(t)]^2}{[pointE_input.power.limit]^2}$ ratio versus time from cDASY6 system for mmW

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transmission. Convert the conducted Tx power for LTE into 1gSAR or 10gSAR value using Eq. (4a) and P_{limit} measured in Step 2.a.i, and then divide this by FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR to obtain instantaneous normalized 1gSAR or 10gSAR versus time. Perform 100s running average to determine normalized 100s-averaged 1gSAR or 10gSAR versus time

NOTE: In Eq.(4a), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the measured worst-case 1gSAR or 10gSAR value at P_{limit} for the corresponding technology/band reported in Part 1 report.

d. Similarly, convert the point E-field for mmW transmission into 4cm^{2}PD value using Eq. (4b) and radiated power limit measured in Step 2.a.ii, and then divide this by FCC 4cm^{2}PD limit of 10W/m^2 to obtain instantaneous normalized 4cm^{2}PD versus time. Perform 4s running average to determine normalized 4s-averaged 4cm^{2}PD versus time.

e. Make one plot containing: (i) computed normalized 100s-averaged 1gSAR or 10gSAR versus time determined in Step 2.c, (ii) computed normalized 4s-averaged 4cm^{2}PD versus time determined in Step 2.d, and (iii) corresponding total normalized time-averaged RF exposure (sum of steps (2.e.i) and (2.e.ii)) versus time.

The validation criteria are, at all times, the total normalized time-averaged RF exposure versus time determined in Step 2.e.iii shall not exceed the normalized limit of 1.0 of FCC requirement (i.e., Eq. (4c)).

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6 MEASUREMENT TEST SETUP (FREQ < 6 GHZ)

6.1 Conducted Measurement Test setup

Legacy Test Setup

The Rohde & Schwarz CMW500 callbox was used in this test. The test setup schematic is shown in Figure 6-1a (Appendix B – Test Setup Photo 1) for measurements with a single antenna of DUT, and in Figure 6-1b (Appendix B – Test Setup Photo 2) for measurements involving antenna switch. For single antenna measurement, one port (RF1 COM) of the callbox is connected to the RF port of the DUT using a directional coupler. For technology/band switch measurement, one port (RF1 COM) of the callbox used for signaling two different technologies is connected to a combiner, which is in turn connected to a directional coupler. The other end of the directional coupler is connected to a splitter to connect to two RF ports of the DUT corresponding to the two antennas of interest. In the setups, power meter is used to tap the directional coupler for measuring the conducted output power of the DUT. For all legacy conducted tests, only RF1 COM port of the callbox is used to communicate with the DUT.

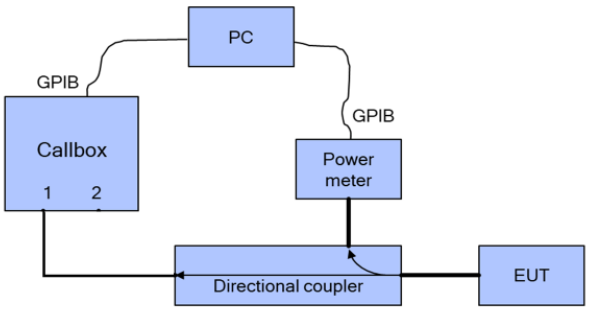
Note that for this EUT, antenna switch test is included within time-window switch test as the selected technology/band combinations for the time-window switch test are on two different antennas

All the path losses from RF port of DUT to the callbox RF COM port and to the power meter are calibrated and automatically entered as offsets in the callbox and the power meter via test scripts on the PC used to control callbox and power meter.

LTE+Sub6 NR test setup:

LTE conducted port and Sub6 NR conducted port are different on this EUT, therefore, the LTE and Sub6 NR signals for power meter measurement are performed on separate paths, as shown in Figure 6-1c (Appendix B – Test Setup Photo 3).

All the path losses from RF port of DUT to the callbox RF COM port and to the power meter are calibrated and automatically entered as offsets in the callbox and the power meter via test scripts on the PC used to control callbox and power meter.



(a) Appendix B – Test Setup Photo 1

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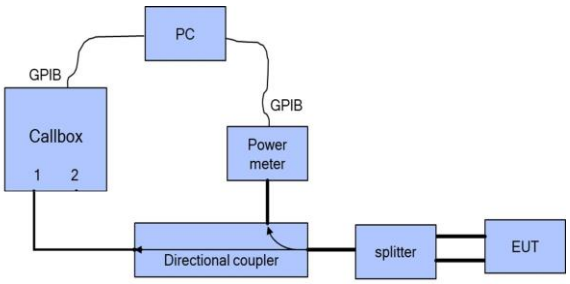
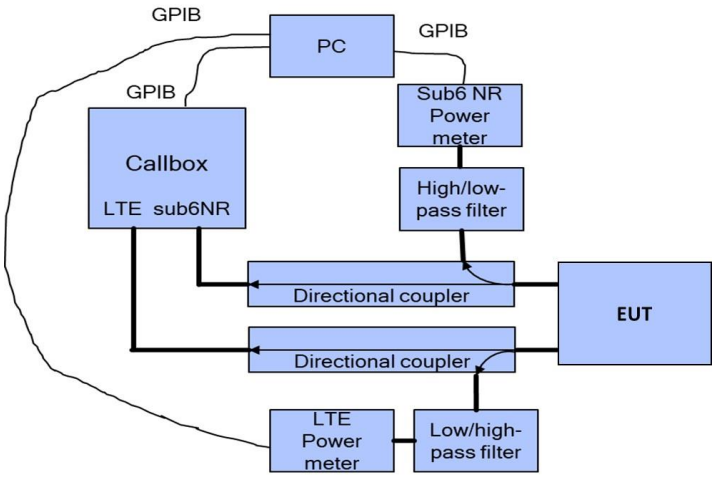


(b) Appendix B – Test Setup Photo 2



(c) Appendix B – Test Setup Photo 3

Figure 6-1
Conducted power measurement setup

Both the callbox and power meter are connected to the PC using GPIB cables. Two test scripts are custom made for automation, and the test duration set in the test scripts is 500 seconds.

For time-varying Tx power measurement, the PC runs the 1st test script to send GPIB commands to control the callbox's requested power versus time, while at the same time to record the conducted power measured at DUT RF port using the power meter. The commands sent to the callbox to request power are:

- 0dBm for 100 seconds
- test sequence 1 or test sequence 2 (defined in Section 4.1 and generated in Section 4.2.1), for 360 seconds
- stay at the last power level of test sequence 1 or test sequence 2 for the remaining time.

Power meter readings are periodically recorded every 100ms. A running average of this measured Tx power over 100 seconds is performed in the post-data processing to determine the 100s-time averaged power.

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For call drop, technology/band/antenna switch, and DSI switch tests, after the call is established, the callbox is set to request the DUT's Tx power at 0dBm for 100 seconds while simultaneously starting the 2nd test script runs at the same time to start recording the Tx power measured at DUT RF port using the power meter. After the initial 100 seconds since starting the Tx power recording, the callbox is set to request maximum power from the DUT for the rest of the test. Note that the call drop/re-establish, or technology/band/antenna switch or DSI switch is manually performed when the Tx power of DUT is at $P_{reserve}$ level. See Section 4.3 for detailed test procedure of call drop test, technology/band/antenna switch test and DSI switch test.

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7 MEASUREMENT TEST SETUP (FREQ > 6 GHZ)

7.1 Radiated Power Measurement Test setup

The Keysight Technologies E7515B UXM callbox is used in this test. The schematic of the setup is shown in Figure 7-1. The UXM callbox has two RF radio heads to up/down convert IF to mmW frequencies, which in turn are connected to two horn antennas for V- and H-polarizations for downlink communication. In the uplink, a directional coupler is used in the path of one of the horn antennas to measure and record radiated power using a Rohde & Schwarz NRP50S power sensor. Note here that the isolation of the directional coupler may not be sufficient to attenuate the downlink signal from the callbox, which will result in high noise floor masking the recording of radiated power from EUT. In that case, either lower the downlink signal strength emanating from the RF radio heads of callbox or add an attenuator between callbox radio heads and directional coupler. Additionally, note that since the measurements performed in this validation are all relative, measurement of EUT's radiated power in one polarization is sufficient. The EUT is placed inside an anechoic chamber with V- and H-pol horn antennas to establish the radio link as shown in Figure 7-1. The callbox's LTE port is directly connected to the EUT's RF port via a directional coupler to measure the EUT's conducted Tx power using a Rohde & Schwarz NRP8S power sensor. Additionally, EUT is connected to the PC via USB connection for sending beam switch command. Care is taken to route the USB cable and RF cable (for LTE connection) away from the EUT's mmW antenna modules.

Setup in Figure 7-1 is used for the test scenario 1, 5 and 6 described in Section 3. The test procedures described in Section 5 are followed. The path losses from the EUT to both the power meters are calibrated and used as offset in the power meter.

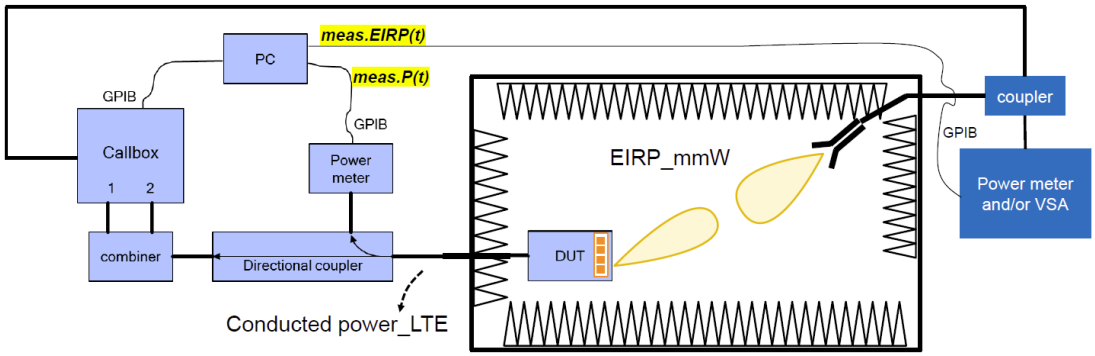

Figure 7-1
mmW NR radiated power measurement setup – Test Setup Photo 5

Both the callbox and power meters are connected to the PC using USB cables. Test scripts are custom made for automation of establishing LTE + mmW call, conducted Tx power recording for LTE and radiated Tx power recording for mmW. These tests are manually stopped after desired time duration. Test script is programmed to set LTE Tx power to all-down bits on the callbox immediately after the mmW link is established, and programmed to set toggle between all-up and all-down bits depending on the transmission scenario being evaluated. Similarly, test script is also programmed to send beam switch command manually to the EUT via USB connection. For all the tests, the callbox is set to request maximum Tx power in mmW NR radio from EUT all the time.

Test configurations for this validation are detailed in Section 5.2. Test procedures are listed in Section 5.3.

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7.2 Power Density Measurement Test setup

The measurement setup is similar to normal PD measurements, the EUT is positioned on cDASY6 platform, and is connected with the callbox (conducted for LTE and wirelessly for mmW). Keysight UXM callbox is set to request maximum mmW Tx power from EUT all the time. Hence, “path loss” calibration between callbox antenna and EUT is not needed in this test. The callbox’s LTE port is directly connected to the EUT’s RF port via a directional coupler to measure the EUT’s conducted Tx power using a Rohde & Schwarz NRP8S power sensor. Additionally, EUT is connected to the PC via USB connection for toggling between FTM and online mode with Smart Transmit enabled following the test procedures described Section 5.4.

Worst-surface of EUT (for the mmW beam being tested) is positioned facing up for PD measurement with cDASY6 mmW probe. Figure 7-2 shows the schematic of this measurement setup.

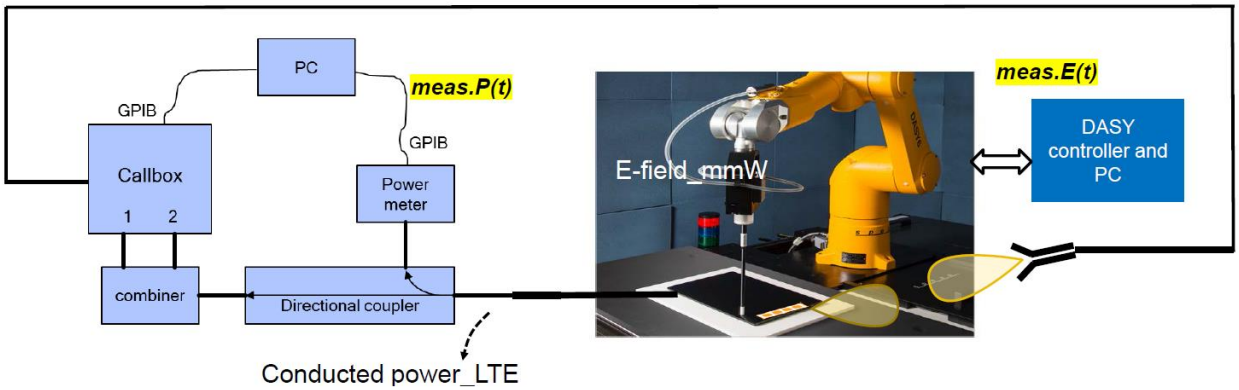

Figure 7-2
Power Density Measurement Setup – Test Setup Photo 4

Both callbox and power meters are connected to the PC using USB cables. Test scripts are custom made for automation of establishing LTE + mmW call, and for conducted Tx power recording of LTE transmission. These tests are manually stopped after desired time duration. Once the mmW link is established, LTE Tx power is programmed to toggle between all-up and all-down bits on the callbox. For all the tests, the callbox is set to request maximum Tx power in mmW NR radio from EUT all the time. Therefore, the calibration for the pathloss between the EUT and the horn antenna connected to the remote radio head of the callbox is not required.

Power meter readings are periodically recorded every 10ms on NR8S power sensor for LTE conducted Tx power. Time-averaged E-field measurements are performed using EUmmWV3 mmW probe at peak location of fast area scan. The distance between EUmmWV3 mmW probe tip to EUT surface is ~0.5 mm, and the distance between EUmmWV3 mmW probe sensor to probe tip is 1.5 mm. cDASY6 records relative point E-field (i.e., ratio $\frac{[pointE(t)]^2}{[pointE_input.power.limit]^2}$) versus time for mmW NR transmission.

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8 TEST CONFIGURATIONS (FREQ < 6 GHZ)

8.1 WWAN (sub-6) transmission

The P_{limit} values, corresponding to 1.01 W/kg (1gSAR) and 2.52 W/kg (10gSAR) of *SAR_design_target*, for technologies and bands supported by DUT are derived in Part 0 report and summarized in Table 8-1. Note all P_{limit} power levels entered in Table 8-1 correspond to average power levels after accounting for duty cycle in the case of TDD modulation schemes.

Table 8-1
P_{limit} for supported technologies and bands (P_{limit} in EFS file)

Exposure Scenario:		Head	Body-Worn	Phablet	Head Swivel	Phablet Swivel	Hotspot	Phablet	Maximum Tune-Up Output Power*
Averaging Volume:		1g	1g	10g	1g	10g	1g	10g	
Spacing:		0 mm	10 mm	3, 0, 3 mm	0 mm	3, 1, 3 mm	10 mm	0 mm	
DSI:		1			7		5	8	
Technology/Band	Antenna	**Plimit**							**Pmax**
CDMA/EVDO BC0	1	28.2			28.1		28.2		24.5
CDMA/EVDO BC1	2	26.7			24.5		22.5		24.5
GSM/GPRS/EDGE 850 MHz	1	29.6			27.6		29.6		24.8
GSM/GPRS/EDGE 1900 MHz	2	24.0			24.0		24.0		21.8
UMTS B5	1	28.6			27.7		28.6		24.5
UMTS B4	2	26.3			24.5		22.5		24.5
UMTS B2	2	26.7			24.5		22.5		24.5
LTE FDD B12	1	28.8			28.3		28.8		24.5
LTE FDD B12 ULCA	1	29.3			28.1		28.8		22.5
LTE FDD B13	1	28.9			30.3		28.9		24.5
LTE FDD B14	1	29.8			29.3		29.8		24.5
LTE FDD B5	1	30.8			29.7		30.8		24.5
LTE FDD B5 ULCA	1	30.9			29.4		30.8		22.5
LTE FDD B66/B4	2	25.4			24.5		22.5		24.5
LTE FDD B66 ULCA	3	24.8			24.4		24.8		22.5
LTE FDD B66 EN-DC	3	22.5			22.5		22.5		24.5
LTE FDD B2	2	25.7			23.7		22.5		24.5
LTE FDD B2 ULCA	3	23.8			24.7		23.8		22.5
LTE FDD B2 EN-DC	3	22.5			22.5		22.5		24.5
LTE FDD B30	2	27.0			26.2		24.0		24.5
LTE FDD B30 EN-DC	1	22.5			22.5		22.5		24.5
LTE TDD B48	9	19.5			19.5		19.5		21.0
LTE TDD B41	2	27.2			24.1		22.0		22.5
NR FDD n5	1	29.3			29.2		29.3		24.5
NR FDD n66	3	22.5			22.5		22.5		24.5
NR FDD n2	3	22.5			22.5		22.5		24.5

* Maximum tune up target power, P_{max}, is configured in NV settings in DUT to limit maximum transmitting power. This power is converted into peak power in NV settings for TDD schemes. The DUT maximum allowed output power is equal to P_{max} + 1 dB device uncertainty.

Based on selection criteria described in Section 4.2.1, the selected technologies/bands for testing time-varying test sequences are highlighted in yellow in Table 8-1. Per the manufacturer, the *Reserve_power_margin* (dB) is set to 3dB in EFS and is used in Part 2 test.

The radio configurations used in Part 2 test for selected technologies, bands, DSIs and antennas are listed in Table 8-2. The corresponding worst-case radio configuration 1gSAR or 10gSAR values for selected technology/band/DSI are extracted from Part 1 report and are listed in the last column of Table 8-2.

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Based on equations (1a), (2a), (3a) and (4a), it is clear that Part 2 testing outcome is normalized quantity, which implies that it can be applied to any radio configuration within a selected technology/band/DSI. Thus, as long as applying the worst-case SAR obtained from the worst radio configuration in Part 1 testing to calculate time-varying SAR exposure in equations (1a), (2a), (3a) and (4a), the accuracy in compliance demonstration remains the same. Therefore, there may be some differences between the radio configuration selected for Part 2 testing and the radio configuration associated with worst-case SAR obtained in the Part 1 evaluation.

Table 8-2
Radio configurations selected for Part 2 test

Test Case #	Test Scenario	Tech	Band	Antenna	DSI	Channel	Frequency [MHz]	RB/RB Offset/Bandwidth (MHz)	Mode	SAR Exposure Scenario	Part 1 Worst Case Measured SAR at Plimit (W/kg)
1	Test Sequence 1	LTE	2	2	8	18900	1880	1/50/20 MHz BW	QPSK	bottom edge, 0mm	2.38*
	Test Sequence 2					18900	1880	1/50/20 MHz BW	QPSK		
2	Test Sequence 1		48	9	5	56207	3646.7	1/0/20 MHz BW	QPSK	right edge, 10mm	0.316
	Test Sequence 2					56207	3646.7	1/0/20 MHz BW	QPSK		
3	Test Sequence 1	UMTS	2	2	5	9400	1880	-	RMC	bottom edge, 10mm	0.962
	Test Sequence 2					9400	1880	-	RMC		
4	Test Sequence 1	CDMA	PCS	2	5	600	1880	-	EVDO	bottom edge, 10mm	0.685
	Test Sequence 2					600	1880	-			
5	Test Sequence 1	Sub6 NR	n66	3	5	349000	1745	1/1/20 MHz BW	DFT-S-OFDM, QPSK	right edge, 10mm	0.545
	Test Sequence 2					349000	1745	1/1/20 MHz BW	DFT-S-OFDM, QPSK		
6	Change in Call	LTE	48	9	5	56207	3646.7	1/0/20 MHz BW	QPSK	right edge, 10mm	0.316
7	Tech/Band Switch	LTE	48	9	5	56207	3646.7	1/0/20 MHz BW	QPSK	right edge, 10mm	0.316
		UMTS	2	2	5	9400	1880	-	RMC	bottom edge, 10mm	0.962
8	DSI Switch	LTE	2	2	5	18900	1880	1/50/20 MHz BW	QPSK	bottom edge, 10mm	0.771
				2	1	18900	1880	1/50/20 MHz BW	QPSK	bottom edge, 3mm	2*
9	Time Window/Antenna Switch	LTE	2	2	5	18900	1880	1/50/20 MHz BW	QPSK	bottom edge, 10mm	0.771
			48	9	5	56207	3646.7	1/0/20 MHz BW	QPSK	right edge, 10mm	0.316
10	SAR1 vs SAR2	LTE	2	2	5	18900	1880	1/50/20 MHz BW	QPSK	bottom edge, 10mm	0.771
		sub6 NR	n66	3	5	349000	1745	1/1/20 MHz BW	DFT-S-OFDM, QPSK	right edge, 10mm	0.545

*Indicates 10g SAR

Table 8-3
DSI and Corresponding Exposure Scenarios

Device State Index (DSI)	*PLimit* Determination Scenarios
1	The worst-case SAR exposure is determined as maximum SAR normalized to the limit among: 1. 1g Head SAR and 2. Body Worn SAR and 3. Extremity SAR measured at 1 and 3 mm spacing for back, front, bottom respectively 4. Extremity SAR measured at 0mm for left and right surfaces
5	Plimit is calculated based on 1g Hotspot SAR at 10 mm
7	Swivel mode (Main screen attaches at 90 degree)
8	Plimit is calculated based on 10g Extremity SAR at 0 mm for back, bottom, and front surfaces

Note that the DUT has a proximity sensor to manage extremity exposure, which is represented with DSI = 8; similarly, the hotspot exposure is distinguished via hotspot mode, represented as DSI = 5; DSI = 7 represents swivel mode which main screen attaches at 90 degree; DSI = 1 represents all other exposures which cannot be distinguished, thus, in this case, the maximum 1g SAR and/or 10g SAR among all remaining exposure scenarios or the minimum Plimit among all remaining exposure scenarios (i.e., head 1g SAR, body worn 1g SAR evaluation at 10 mm spacing, phablet 10gSAR extremity evaluation at 1 and 3mm spacing, phablet 10g SAR extremity evaluation at 0mm spacing for left surface) is used in Smart Transmit feature for time averaging operation

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Based on the selection criteria described in Section 4.2, the radio configurations for the Tx varying transmission test cases listed in Section 3 are:

1. Technologies and bands for time-varying Tx power transmission: The test case 1~5 listed in Table 8-2 are selected to test with the test sequences defined in Section 4.1 in both time-varying conducted power measurement and time-varying SAR measurement.
2. Technology and band for change in call test: LTE Band 48, having the lowest P_{limit} among all technologies and bands (test case 6 in Table 8-2), is selected for performing the call drop test in conducted power setup.
3. Technologies and bands for change in technology/band test: Following the guidelines in Section 4.2.3, test case 7 in Table 8-2 is selected for handover test from a technology/band within one technology group (LTE Band 48, DSI=5, antenna 9), to a technology/band in the same DSI within another technology group (UMTS B2, DSI=5, antenna 2) in conducted power setup.
4. Technologies and bands for change in DSI: Based on selection criteria in Section 4.2.5, for a given technology and band, test case 8 in Table 8-2 is selected for DSI switch test by establishing a call in LTE Band 2 in DSI=5, and then handing over to DSI = 1 exposure scenario in conducted power setup.
5. Technologies and bands for change in time-window/antenna: Based on selection criteria in Section 4.2.6, for a given DSI=5, test case 9 in Table 8-2 is selected for time window switch between 60s window (LTE Band 48, Antenna 9) and 100s window (LTE Band 2, Antenna 2) in conducted power setup.
6. Technologies and bands for switch in SAR exposure: Based on selection criteria in Section 4.2.7 Scenario 1, test case 10 in Table 8-2 is selected for SAR exposure switching test in one of the supported simultaneous WWAN transmission scenario, i.e., LTE + Sub6 NR active in the same 100s time window, in conducted power setup. Since this device supports LTE+mmW NR, test for Section 4.2.7 Scenario 2 for RF exposure switch is covered in Sections 13.1 and 13.2 between LTE (100s window) and mmW NR (4s window).
7. Technologies and bands for switch in SAR exposure (Inter-band ULCA): Inter-band ULCA operations are supported only within a single time-window. For this device, in inter-band ULCA conditions, Plimit is > Pmax for all DSI, therefore no switch in SAR Exposure test case was required.

8.2 P_{limit} and P_{max} measurement results

The measured P_{limit} for all the selected radio configurations given in Table 8-2 are listed in below Table 8-4. P_{max} was also measured for radio configurations selected for testing time-varying Tx power transmission scenarios in order to generate test sequences following the test procedures in Section 4.1.

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Table 8-4
Measured P_{limit} and P_{max} of selected radio configurations

Test Case #	Test Scenario	Tech	Band	Antenna	DSI	Channel	Frequency [MHz]	RB/RB Offset/Bandwidth (MHz)	Mode	SAR Exposure Scenario	EFS Plimit [dBm]	Tune-up Pmax [dBm]	Measured Plimit [dBm]	Measured Pmax [dBm]
1	Test Sequence 1	LTE	2	2	8	18900	1880	1/50/20 MHz BW	QPSK	Phablet	22.50	24.50	22.56	25.11
	Test Sequence 2					18900	1880	1/50/20 MHz BW	QPSK		22.50	24.50	22.56	25.11
2	Test Sequence 1		48	9	5	56207	3646.7	1/0/20 MHz BW	QPSK	Hotspot	19.50	21.00	19.54	21.38
	Test Sequence 2					56207	3646.7	1/0/20 MHz BW	QPSK		19.50	21.00	19.54	21.38
3	Test Sequence 1	UMTS	2	2	5	9400	1880	-	RMC	Hotspot	22.50	24.50	22.40	25.00
	Test Sequence 2					9400	1880	-	RMC		22.50	24.50	22.40	25.00
4	Test Sequence 1	CDMA	PCS	2	5	600	1880	-	EVDO	Hotspot	22.50	24.50	22.55	24.82
	Test Sequence 2					600	1880	-			22.50	24.50	22.55	24.82
5	Test Sequence 1	Sub6 NR	n66	3	5	349000	1745	1/1/20 MHz BW	DFT-S-OFDM, QPSK	Hotspot	22.50	24.50	22.95	25.42
	Test Sequence 2					349000	1745	1/1/20 MHz BW	DFT-S-OFDM, QPSK		22.50	24.50	22.95	25.42
6	Change in Call	LTE	48	9	5	56207	3646.7	1/0/20 MHz BW	QPSK	Hotspot	19.50	21.00	19.54	21.38
7	Tech/Band Switch	LTE	48	9	5	56207	3646.7	1/0/20 MHz BW	QPSK	Hotspot	19.50	21.00	19.54	21.38
		UMTS	2	2	5	9400	1880	-	RMC	Hotspot	22.50	24.50	22.40	25.00
8	DSI Switch	LTE	2	2	5	18900	1880	1/50/20 MHz BW	QPSK	Hotspot	22.50	24.50	22.56	25.11
				2	1	18900	1880	1/50/20 MHz BW	QPSK	Phablet	25.70	24.50	25.11	25.11
9	Time Window/Antenna Switch	LTE	2	2	5	18900	1880	1/50/20 MHz BW	QPSK	Hotspot	22.50	24.50	22.56	25.11
			48	9	5	56207	3646.7	1/0/20 MHz BW	QPSK	Hotspot	19.50	21.00	19.54	21.38
10	SAR1 vs SAR2	LTE	2	2	5	18900	1880	1/50/20 MHz BW	QPSK	Hotspot	22.50	24.50	22.56	25.11
		sub6 NR	n66	3	5	349000	1745	1/1/20 MHz BW	DFT-S-OFDM, QPSK	Hotspot	22.50	24.50	22.95	25.42

Note: The device uncertainty of P_{max} is +/- 1 dB as provided by manufacturer.

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9 CONDUCTED TX CASES (FREQ < 6 GHZ)

9.1 Time-varying Tx Power Case

The measurement setup is shown in Figure 6-1.The purpose of the time-varying Tx power measurement is to demonstrate the effectiveness of power limiting enforcement and that the time-averaged Tx power when represented in time-averaged 1gSAR or 10gSAR values does not exceed FCC limit as shown in Eq. (1a) and (1b), rewritten below:

$$1g_or_10gSAR(t) = \frac{conducted_Tx_power(t)}{conducted_Tx_power_P_{limit}} * 1g_or_10gSAR_P_{limit} \qquad (1a)$$

$$\frac{\frac{1}{T_{SAR}}\int_{t-T_{SAR}}^{t} 1g_or_10gSAR(t)dt}{FCC\ SAR\ limit} \leq 1 \qquad (1b)$$

where, $conducted_Tx_power(t)$, $conducted_Tx_power_P_{limit}$, and $1g_or_10gSAR_P_{limit}$ correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at P_{limit}, and measured *1gSAR* and *10gSAR* values at P_{limit} reported in Part 1 test (listed in Table 8-2 of this report as well).

Following the test procedure in Section 4.3, the conducted Tx power measurement for all selected configurations are reported in this section. In all the conducted Tx power plots, the dotted line represents the requested power by callbox (test sequence 1 or test sequence 2), the blue curve represents the instantaneous conducted Tx power measured using power meter, the green curve represents time-averaged power and red line represents the conducted power limit that corresponds to FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

Similarly, in all the 1g or 10gSAR plots (when converted using Eq. (1a)), the green curve represents the 100s/60s-time averaged 1gSAR or 10gSAR value calculated based on instantaneous 1gSAR or 10gSAR; and the red line limit represents the FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

Time-varying Tx power measurements were conducted on test cases #1 ~ #5 in Table 8-2, by generating test sequence 1 and test sequence 2 given in APPENDIX C: using measured P_{limit} and measured P_{max} (last two columns of Table 8-4) for each of these test cases. Measurement results for test cases #1 ~ #5 are given in Sections 9.1.1-9.1.5.

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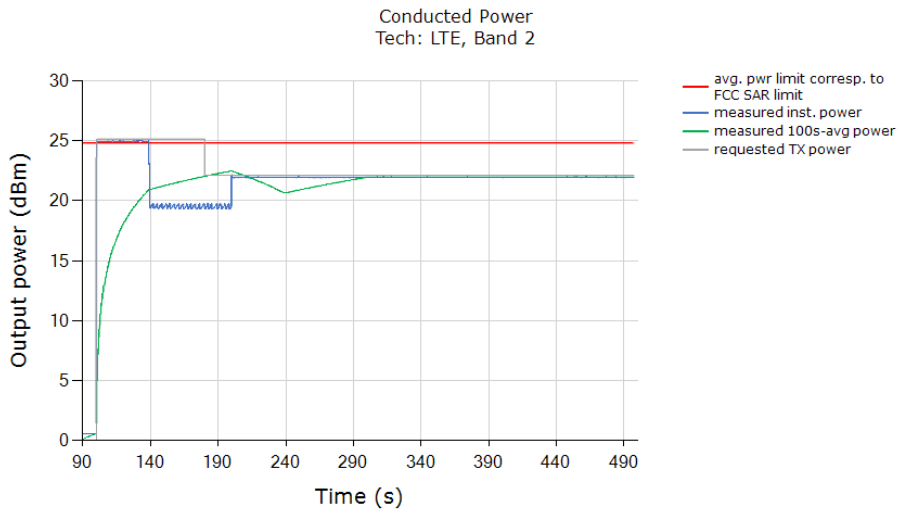
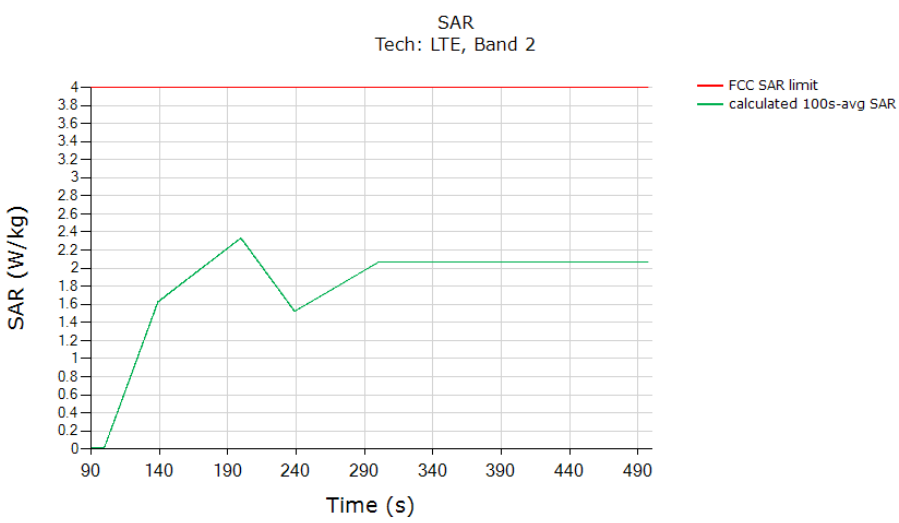
9.1.1 LTE Band 2

Test result for test sequence 1:



Above time-averaged conducted Tx power is converted/calculated into time-averaged 10gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 10gSAR versus time does not exceed the FCC limit of 4.0 W/kg for 10gSAR:



	(W/kg)
FCC 10gSAR limit	4.0
Max 100s-time averaged 10gSAR (green curve)	2.333
Validated: Max time averaged SAR (green curve) is within 1 dB device uncertainty of measured SAR at P_{limit} (last column in Table 8-2).	

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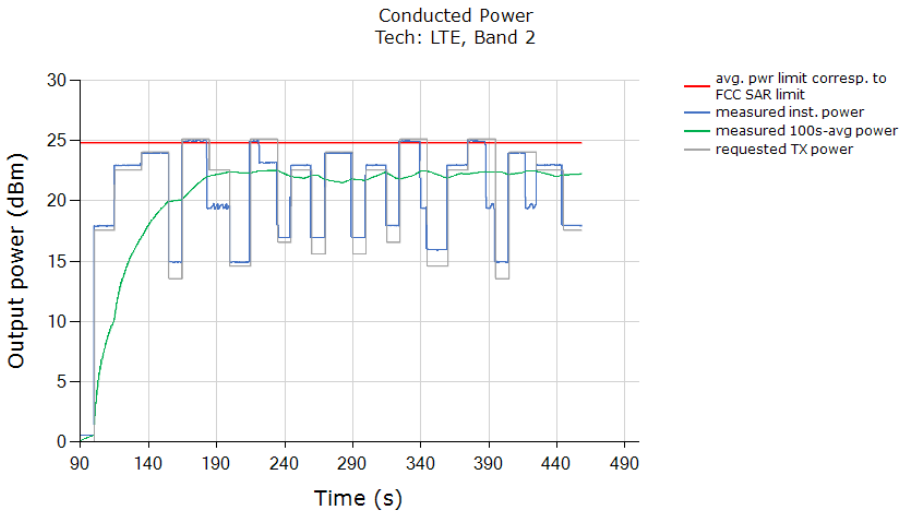
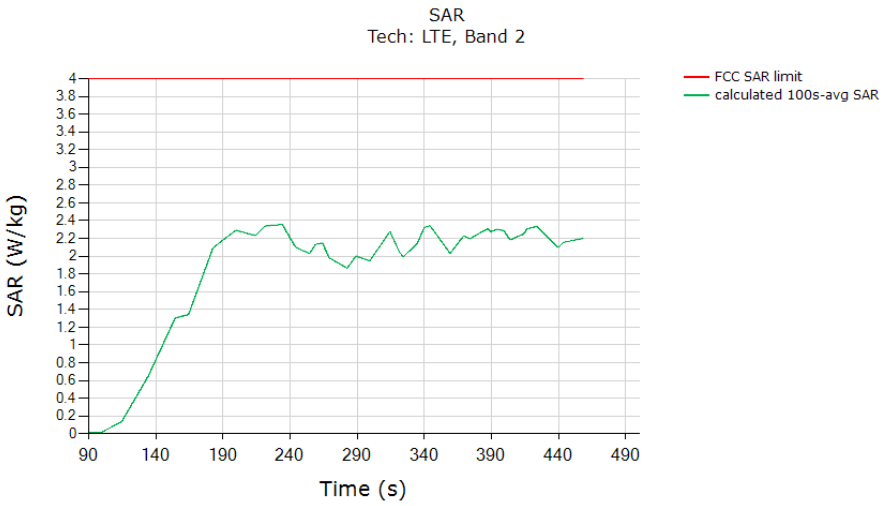
Test result for test sequence 2:



Above time-averaged conducted Tx power is converted/calculated into time-averaged 10gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 10gSAR versus time does not exceed the FCC limit of 4.0 W/kg for 10gSAR:



	(W/kg)
FCC 10gSAR limit	4.0
Max 100s-time averaged 10gSAR (green curve)	2.356
Validated: Max time averaged SAR (green curve) is within 1 dB device uncertainty of measured SAR at P_{limit} (last column in Table 8-2).	

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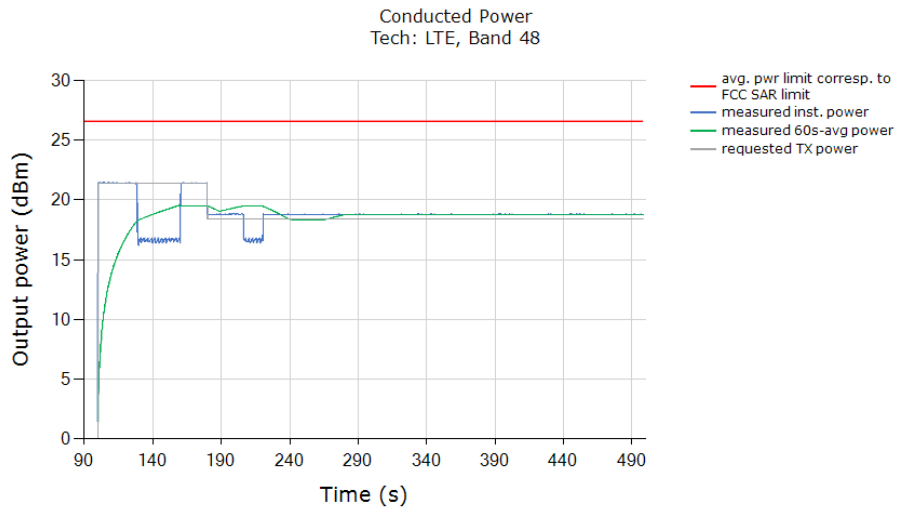
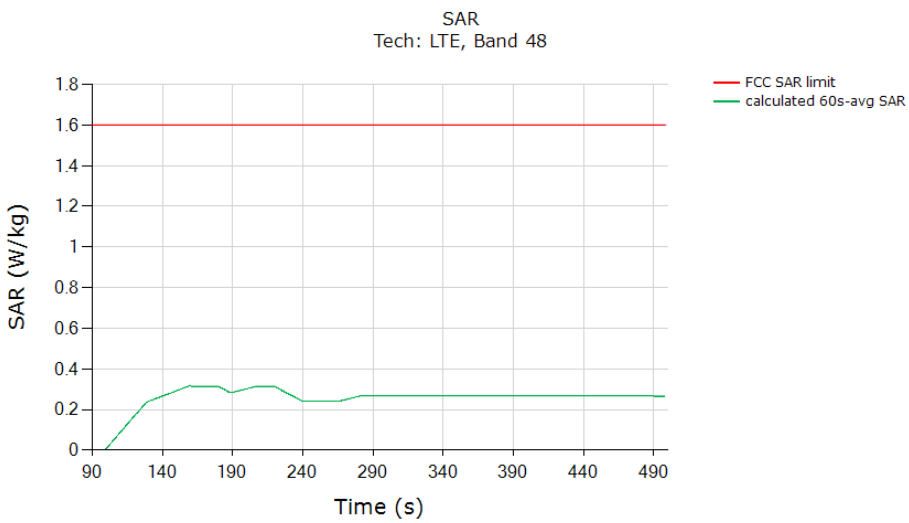
9.1.2 LTE Band 48

Test result for test sequence 1:



Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:



	(W/kg)
FCC 1gSAR limit	1.6
Max 60s-time averaged 1gSAR (green curve)	0.317
Validated: Max time averaged SAR (green curve) is within 1 dB device uncertainty of measured SAR at P_{limit} (last column in Table 8-2).	

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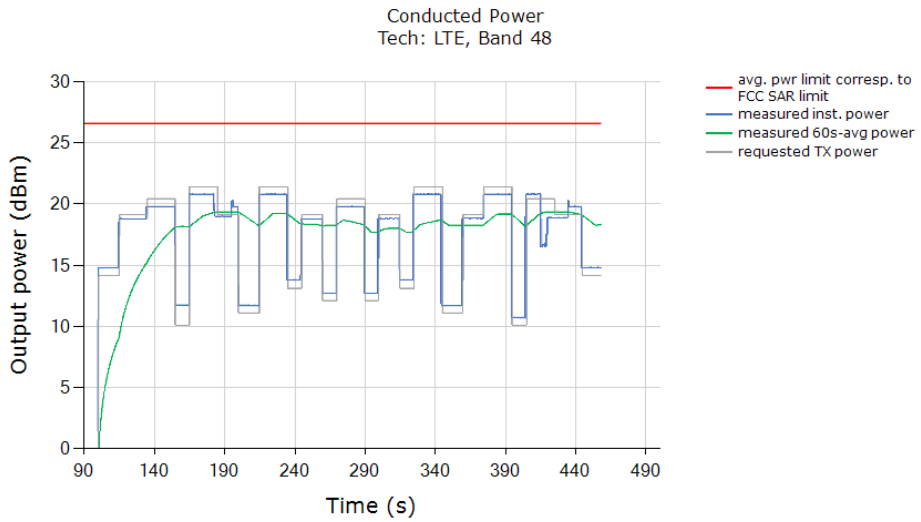
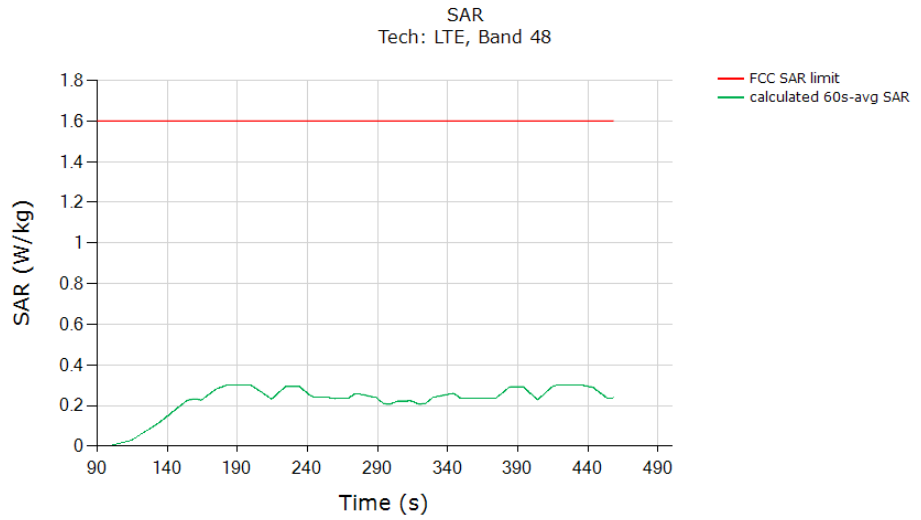
Test result for test sequence 2:



Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:



	(W/kg)
FCC 1gSAR limit	1.6
Max 60s-time averaged 1gSAR (green curve)	0.302
Validated: Max time averaged SAR (green curve) is within 1 dB device uncertainty of measured SAR at P_{limit} (last column in Table 8-2).	

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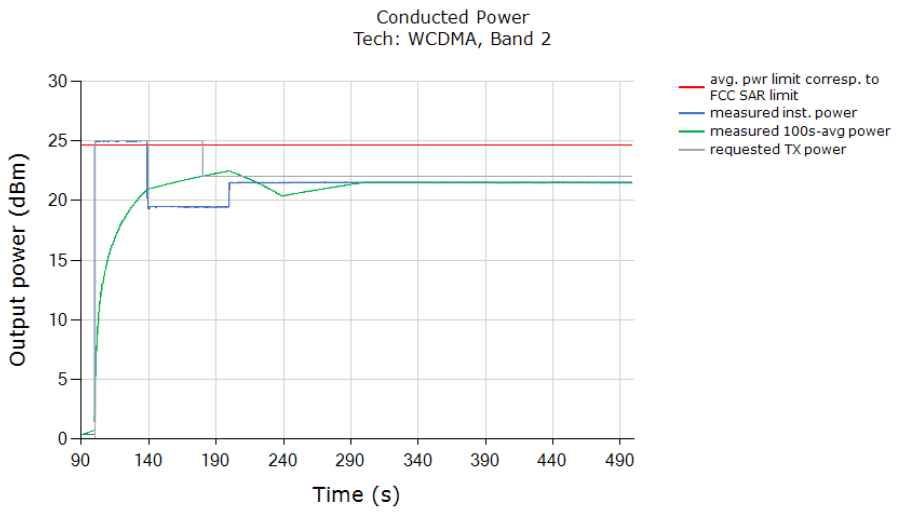
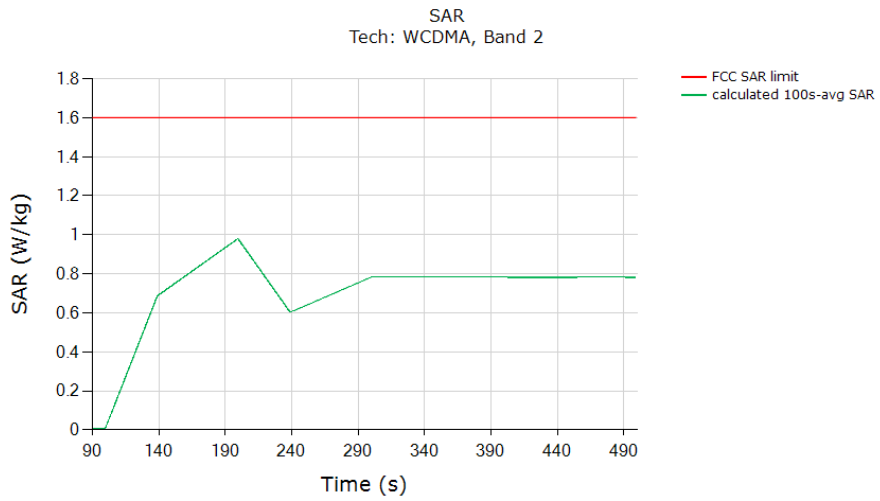
9.1.3 UMTS B2

Test result for test sequence 1:



Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:



	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	0.979
Validated: Max time averaged SAR (green curve) is within 1 dB device uncertainty of measured SAR at P_{limit} (last column in Table 8-2).	

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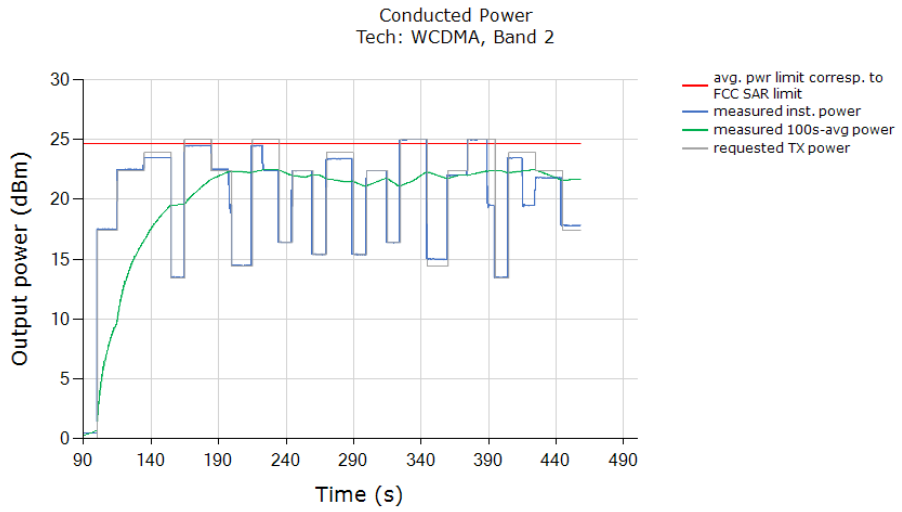
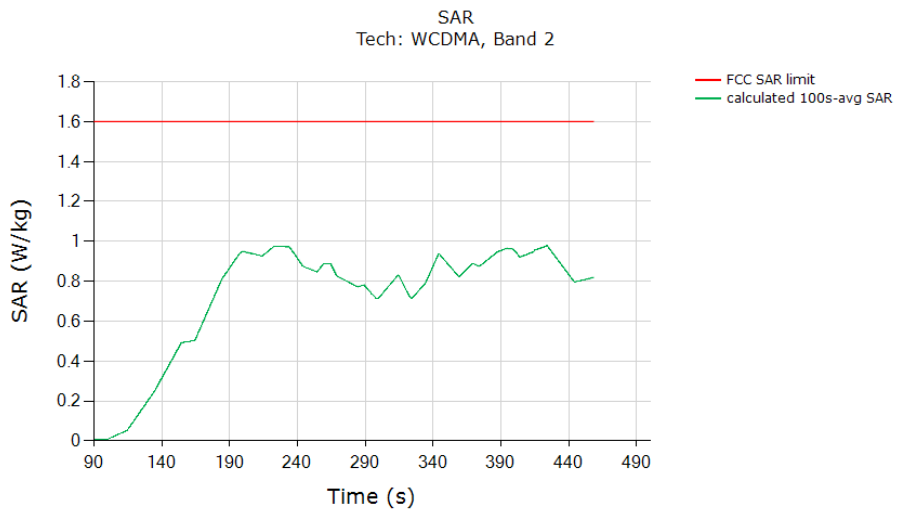
Test result for test sequence 2:



Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:



	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	0.978
Validated: Max time averaged SAR (green curve) is within 1 dB device uncertainty of measured SAR at P_{limit} (last column in Table 8-2).	

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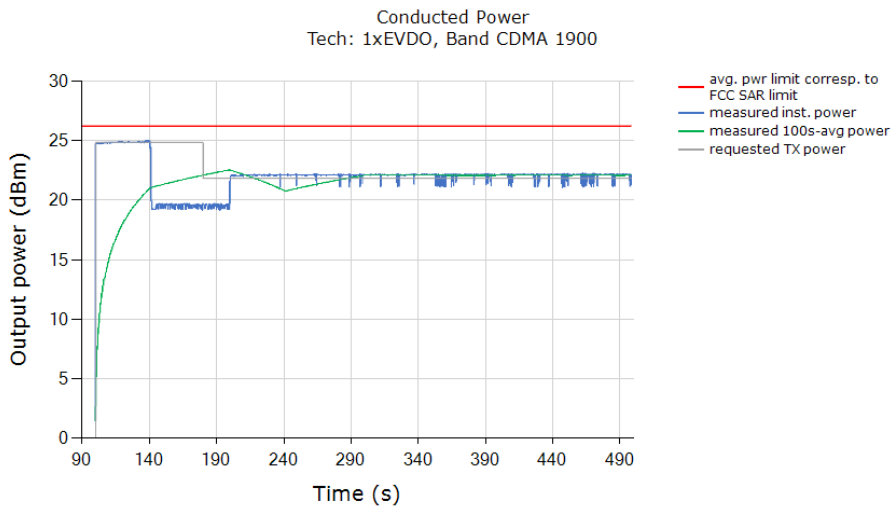
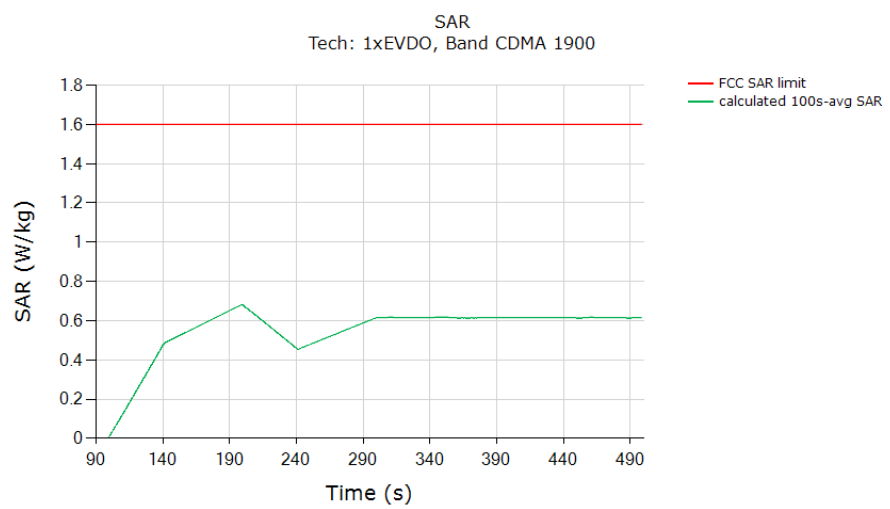
9.1.4 CDMA/EVDO BC1

Test result for test sequence 1:



Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:



	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	0.682
Validated: Max time averaged SAR (green curve) is within 1 dB device uncertainty of measured SAR at P_{limit} (last column in Table 8-2).	

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04/06/2020

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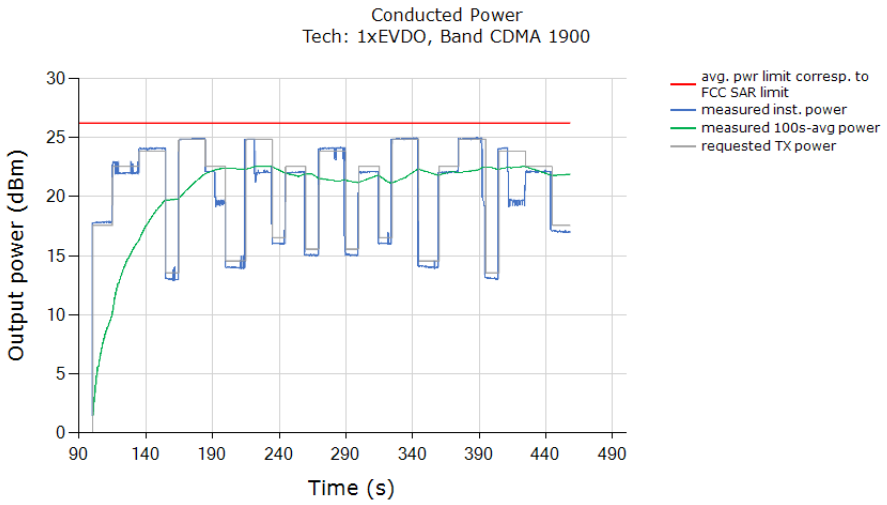
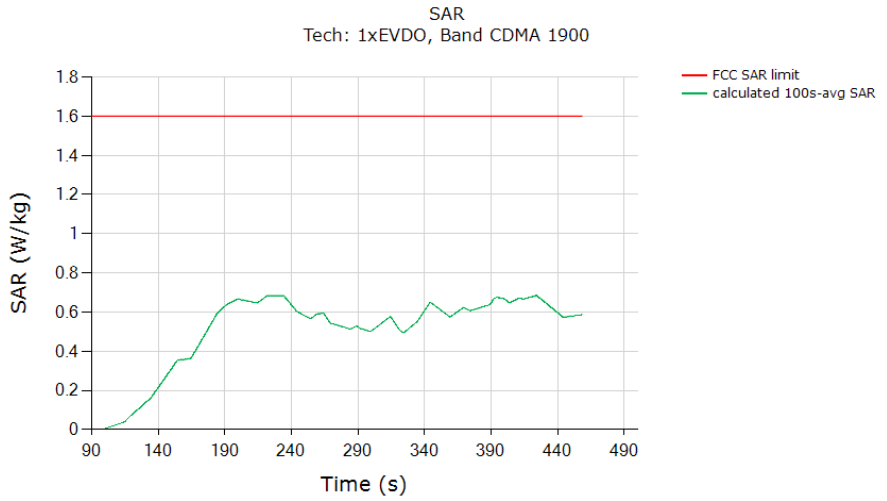
Test result for test sequence 2:



Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:



	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	0.684
Validated: Max time averaged SAR (green curve) is within 1 dB device uncertainty of measured SAR at P_{limit} (last column in Table 8-2).	

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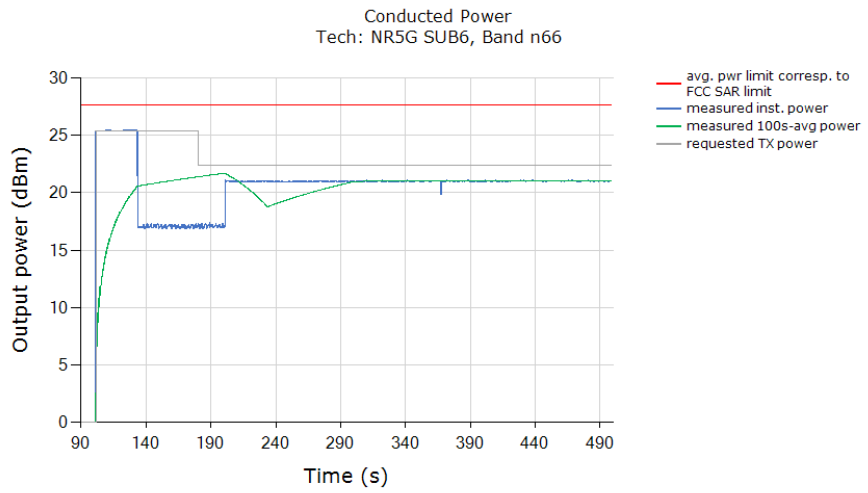
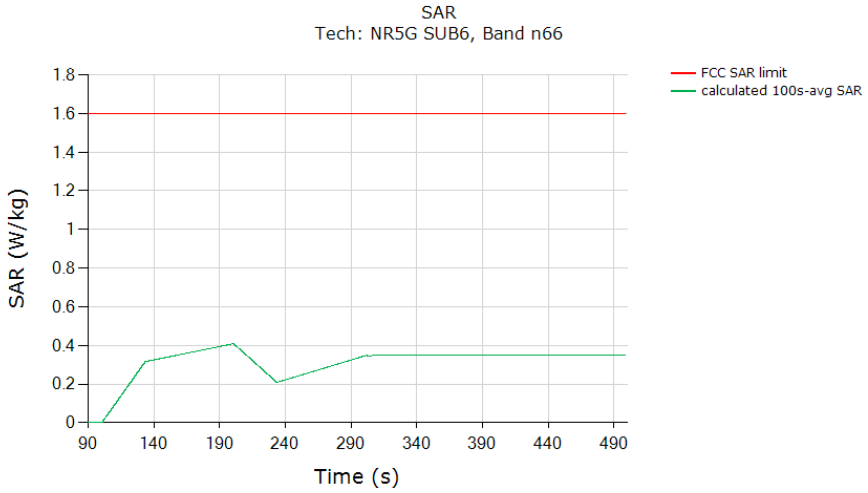
9.1.5 NR n66

Test result for test sequence 1:



Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:



	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	0.409
Validated: Max time averaged SAR (green curve) is within 1dB device uncertainty of 75% (with 3dB *Reserve_power_margin* setting) of the measured SAR at *Plimit* (last column in Table 8-2).	

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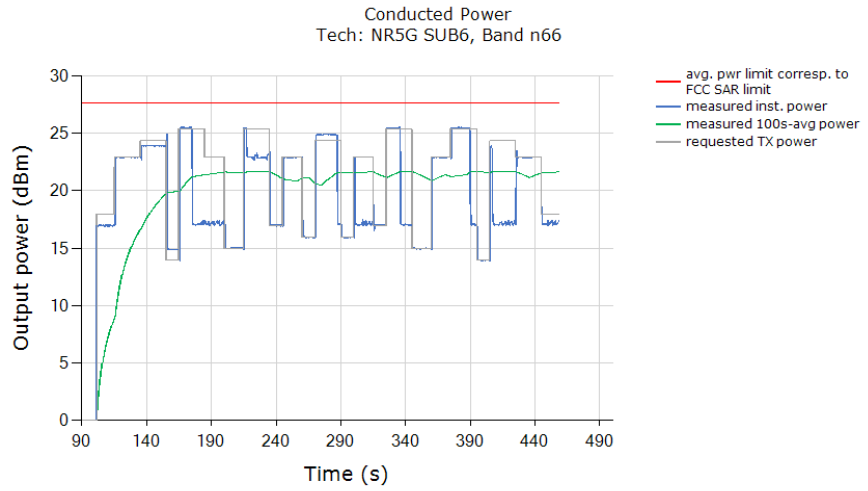
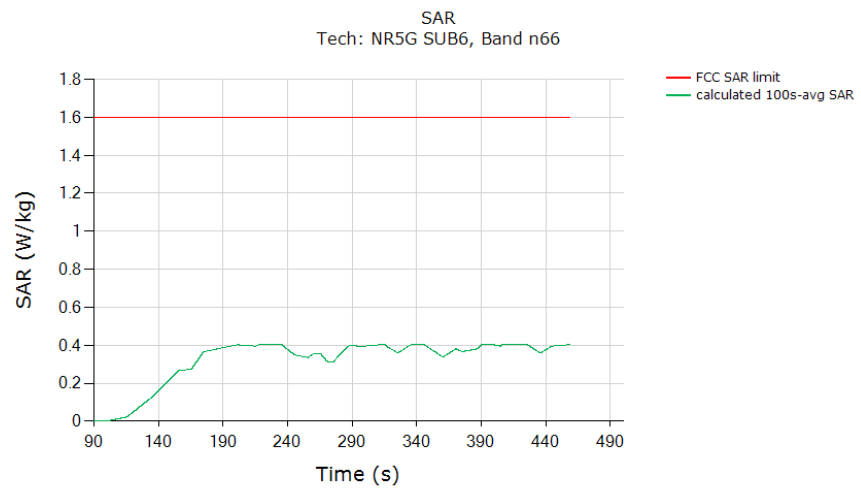
Test result for test sequence 2:



Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:



	(W/kg)
FCC 1gSAR limit	1.6
Max 100s-time averaged 1gSAR (green curve)	0.405
Validated: Max time averaged SAR (green curve) is within 1dB device uncertainty of 75% (with 3dB *Reserve_power_margin* setting) of the measured SAR at *Plimit* (last column in Table 8-2).	

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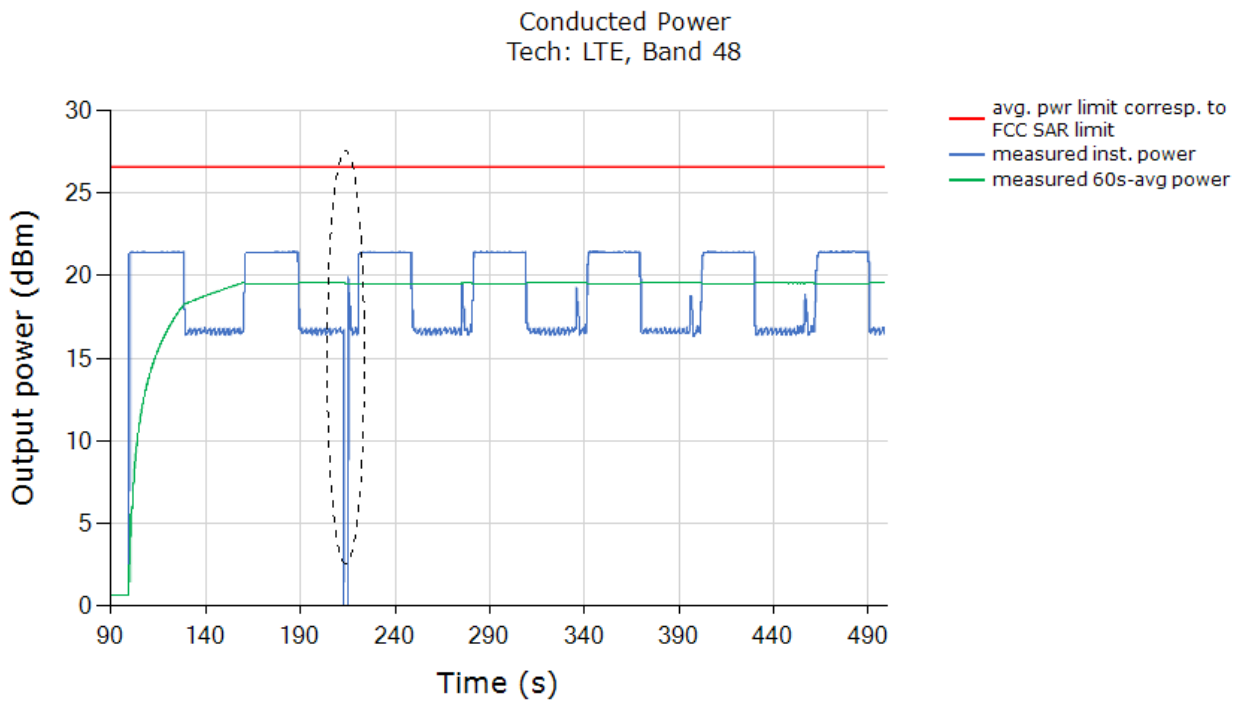
9.2 Call Drop Test Case

This test was measured LTE Band 48, Antenna 9, DSI=5, and with callbox requesting maximum power. The call drop was manually performed when the DUT is transmitting at $P_{reserve}$ level as shown in the plot below (dotted black region). The measurement setup is shown in Figure 6-1. The detailed test procedure is described in Section 4.3.2.

Call drop test result:

Plot 1: Measured Tx power (dBm) versus time shows that the transmitting power kept the same $P_{reserve}$ level of LTE Band 48 after the call was re-established:



Plot Notes: The power level after the change in call kept the same $P_{reserve}$ level of LTE Band 48. The conducted power plot shows expected Tx transition.

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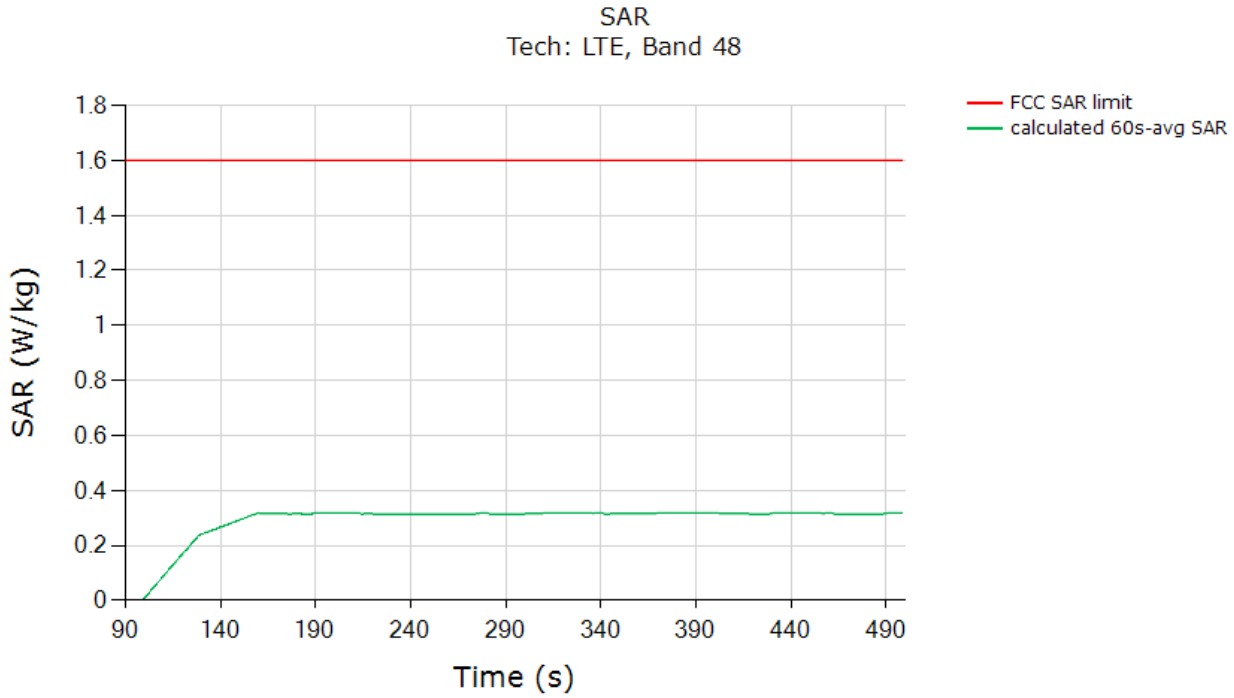
Plot 2: Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:



	(W/kg)
FCC 1gSAR limit	1.6
Max 60s-time averaged 1gSAR (green curve)	0.317
Validated	

The test result validated the continuity of power limiting in call change scenario.

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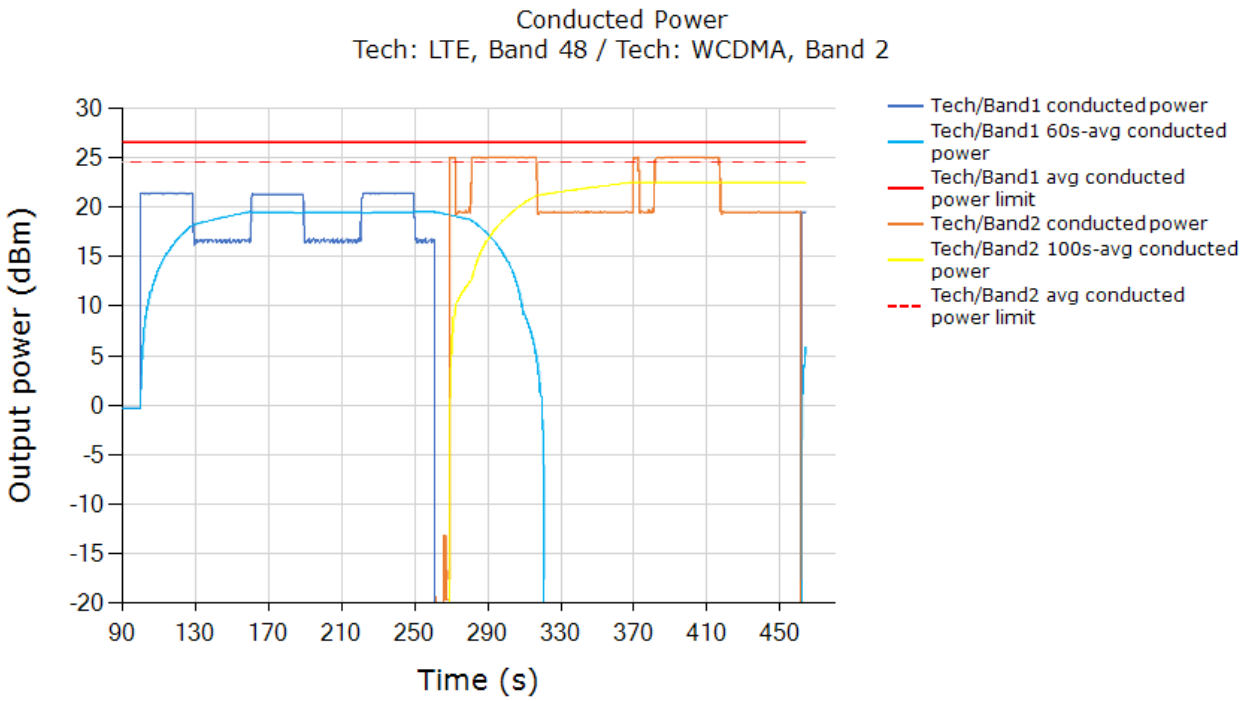
9.3 Change in Technology/Band Test Case

This test was conducted with callbox requesting maximum power, and with a technology switch from LTE Band 48, Antenna 9, DSI = 5 to UMTS B2, Antenna 2, DSI = 5. Following procedure detailed in Section 4.3.3, and using the measurement setup shown in Figure 6-1, the technology/band switch was performed when the DUT is transmitting at $P_{reserve}$ level as shown in the plot below (dotted black region).

Test result for change in technology/band:

Plot 1: Measured Tx power (dBm) versus time shows that the transmitting power changed from LTE Band 48, Antenna 9, DSI = 5 $P_{reserve}$ level to UMTS B2, Antenna 2, DSI = 5 $P_{reserve}$ level (within 1 dB device uncertainty):



Note: As per the manufacturer, *Reserve_power_margin* = 3 dB. Based on Table 8-1, EFS *Plimit* = 19.5dBm for LTE Band 48 (DSI=5), and EFS *Plimit* = 22.5dBm for UMTS B2 (DSI=5), it can be seen from above plot that the difference in *Preserve* (= *Plimit – 3dB Reserve_power_margin*) power level corresponds to the expected difference in *Plimit* levels of 3.0dB (within 1dB of sub6 radio design related uncertainty). Therefore, the conducted power plot shows expected transition in Tx power.

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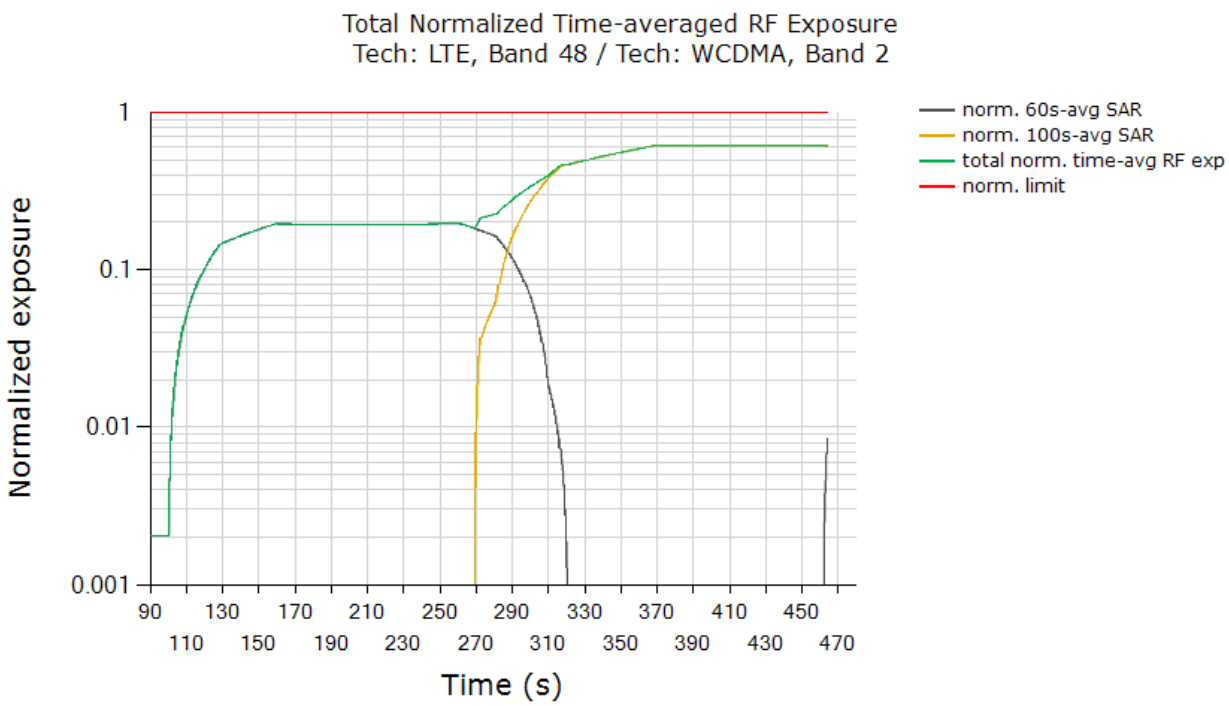
Plot 2: All the time-averaged conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (6a), (6b) and (6c), and plotted below to demonstrate that the time-averaged normalized SAR versus time does not exceed the normalized FCC limit of 1.0:



	(W/kg)
FCC normalized SAR limit	1.0
Max 100s-time averaged normalized SAR (green curve)	0.614
Validated	

The test result validated the continuity of power limiting in technology/band switch scenario.

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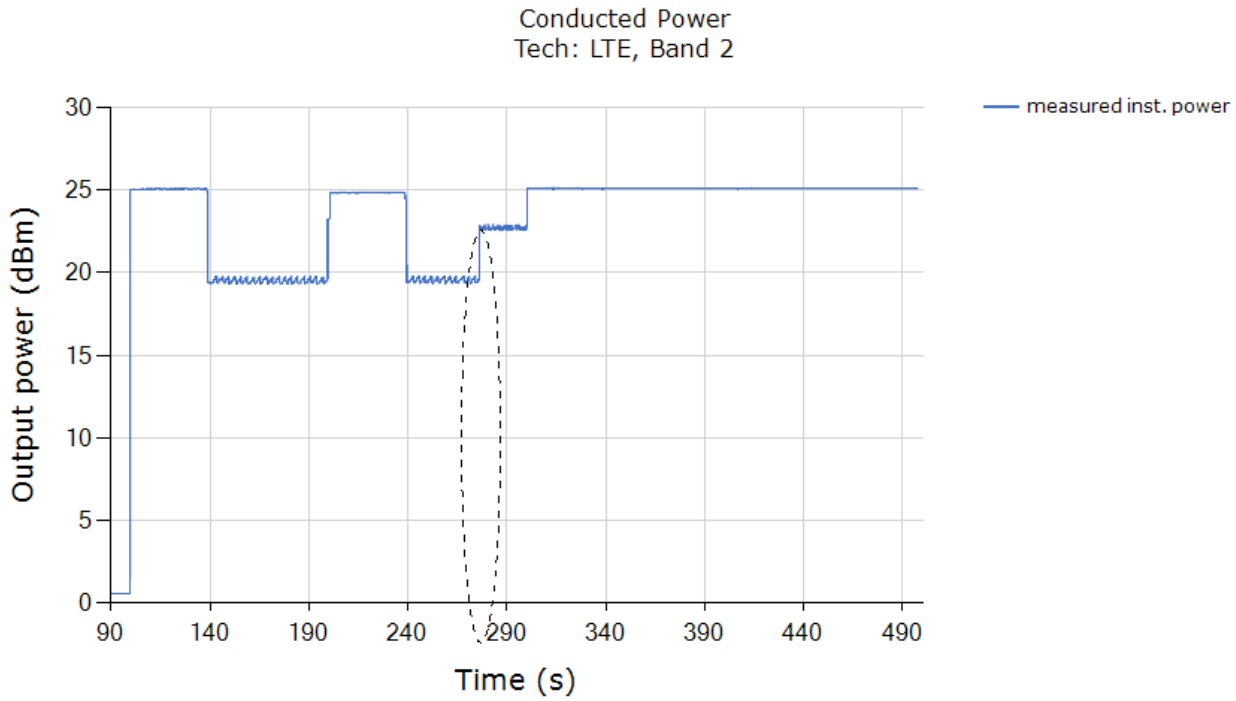
9.4 DSI Switch Test Case

This test was conducted with callbox requesting maximum power, and with DSI switch from LTE Band 2 DSI = 5 (hotspot) to DSI = 1 (Phablet). Following procedure detailed in Section 4.3.5 using the measurement setup shown in Figure 6-1, the DSI switch was performed when the DUT is transmitting at $P_{reserve}$ level as shown in the plot below (dotted black circle).

Plot 1: Measured Tx power (dBm) versus time shows that the transmitting power changed when DSI = 5 switches to DSI = 1:



Note: As per the manufacturer, *Reserve_power_margin* = 3dB. Based on Table 8-1, EFS *Plimit* = 22.5dBm for LTE Band 2 hotspot DSI = 5, and EFS *Plimit* = 25.7dBm for Phablet state DSI = 1.The difference in *Preserve* (= *Plimit – 3dB Reserve_power_margin*) level corresponds to the expected different in *Plimit* levels of 3.2 dB (within 1dB of sub6 radio design related uncertainty). Therefore, the conducted power plot shows expected transition in Tx power.

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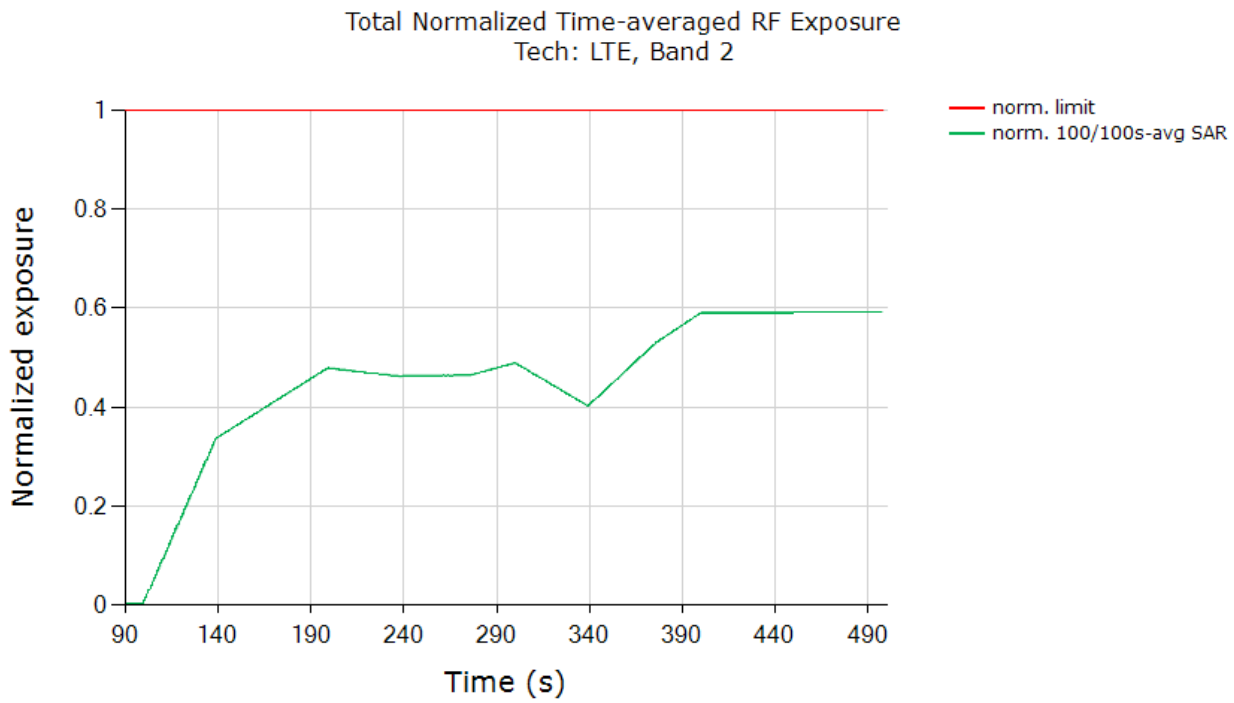
Plot 2: All the time-averaged conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (6a), (6b) and (6c), and plotted below to demonstrate that the time-averaged normalized SAR versus time does not exceed the FCC limit of 1 unit.



	(W/kg)
FCC normalized total exposure limit	1.0
Max 100s-time averaged normalized SAR (green curve)	0.591
Validated	

The test result validated the continuity of power limiting in DSI switch scenario.

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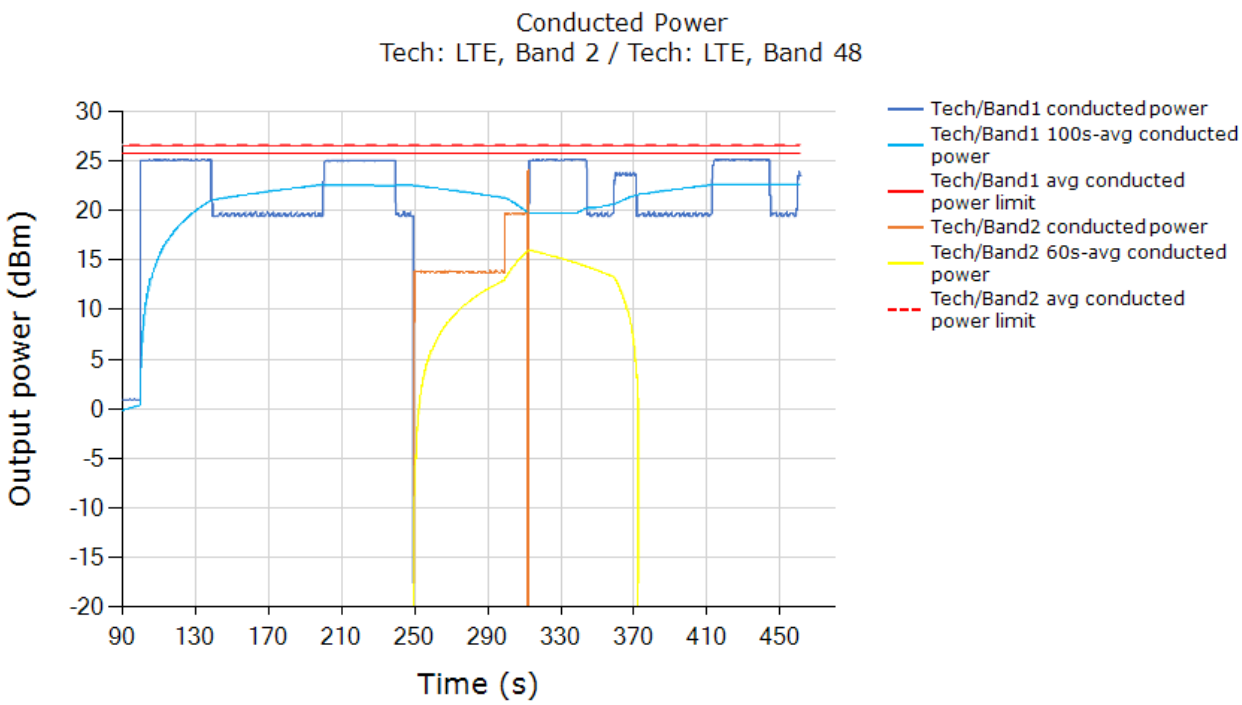
9.5 Change in Time window / antenna switch test results

This test was conducted with callbox requesting maximum power, and with time-window/antenna switch between LTE Band 2, Antenna 2, DSI = 5 (100s window) and LTE Band 48, Antenna 9, DSI = 5 (60s window). Following procedure detailed in Section 4.3.6, and using the measurement setup shown in Figure 6-1(b), the time-window switch via tech/band/antenna switch was performed when the EUT is transmitting at $P_{reserve}$ level.

9.5.1 Test case 1: transition from LTE Band 2 to LTE Band 48 (i.e., 100s to 60s), then back to LTE Band 2

Test result for change in time-window (from 100s to 60s to 100s):

Plot 1: Measured Tx power (dBm) versus time shows that the transmitting power changed when LTE Band 2 switches to LTE Band 48 (~250 seconds timestamp) and switches back to LTE Band 2 (~310s seconds timestamp):



Plot Notes: As per the manufacturer, *Reserve_power_margin* = 3dB. Based on Table 8-1, EFS *Plimit* = 22.5dBm (*Pmax* = 24.5dBm) for LTE Band 2 DSI = 5 (100s window), and EFS *Plimit* = 19.5 dBm (*Pmax* = 21.0dBm) for LTE Band 48 DSI = 5 (60s window). The conducted power plot shows expected transitions in Tx power at ~250 seconds (100s-to-60s transition) and at ~310 seconds (60s-to-100s transition) in order to maintain total time-averaged RF exposure compliance across time windows, as show in next plot.

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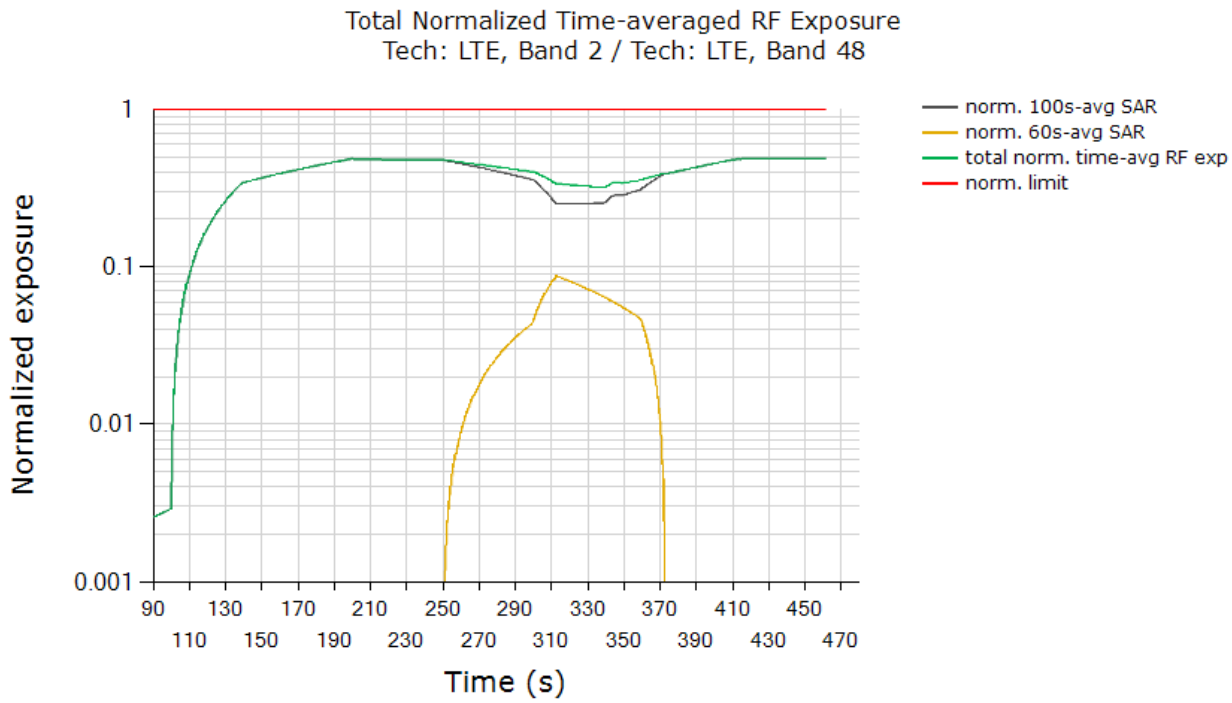
Plot 2: All the conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (7a), (7b) and (7c), and plotted below to demonstrate that the time-averaged normalized SAR versus time does not exceed the FCC limit of 1 unit. Equation (7a) is used to convert the Tx power of device to obtain 100s-averaged normalized SAR in LTE Band 2 as shown in black curve. Similarly, equation (7b) is used to obtain 60s-averaged normalized SAR in LTE Band 48 as shown in orange curve. Equation (7c) is used to obtain total time-averaged normalized SAR as shown in green curve (i.e., sum of black and orange curves).



	(W/kg)
FCC normalized total exposure limit	1.0
Max time averaged normalized SAR (green curve)	0.485
Validated	

Plot Notes: Maximum power is requested by callbox for the entire duration of the test, with tech/band switches from 100s-to-60s window at ~250s time stamp, and from 60s-to-100s window at ~310s time stamp. Smart Transmit controls the Tx power during these time-window switches to ensure total time-averaged RF exposure, i.e., sum of black and orange curves given by equation (7c), is always compliant. In time-window switch test, at all times the total time-averaged normalized RF exposure (green curve) should not exceed normalized *SAR_design_target* + 1dB device uncertainty. In this test, with a maximum normalized SAR of 0.485 being ≤ 0.79 (= 1.0/1.6 + 1dB device uncertainty), the above test result validated the continuity of power limiting in time-window switch scenario.

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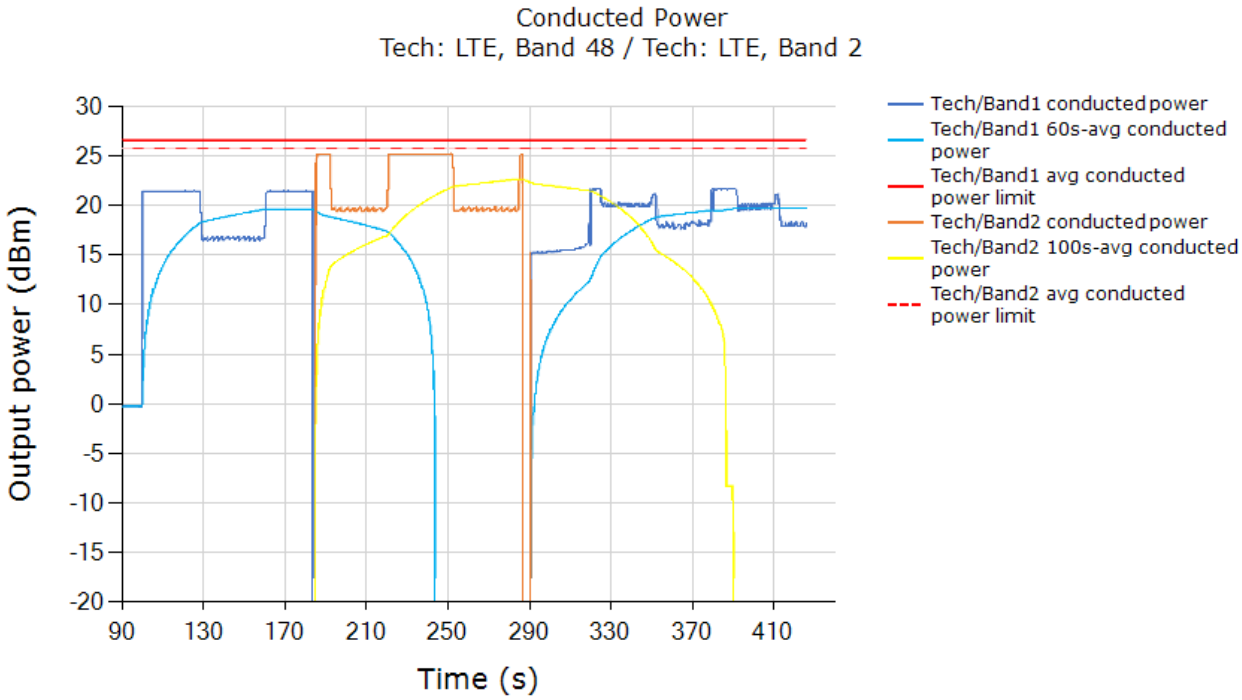
9.5.2 Test case 2: transition from LTE Band 48 to LTE Band 2 (i.e., 60s to 100s), then back to LTE Band 48

Test result for change in time-window (from 60s to 100s to 60s):

Plot 1: Measured Tx power (dBm) versus time shows that the transmitting power changed when LTE Band 48 switches to LTE Band 2 (~185 seconds timestamp) and switches back to LTE Band 48 (~290 seconds timestamp):



Note: As per the manufacturer, *Reserve_power_margin* = 3dB. Based on Table 8-1, EFS *Plimit* = 19.5dBm (*Pmax* = 21.0dBm) for LTE Band 48 DSI = 5 (60s window), and EFS *Plimit* = 22.5dBm (*Pmax* = 24.5dBm) for LTE Band 2 DSI = 5 (100s window). The conducted power plot shows expected transitions in Tx power at ~185s (60s-to-100s transition) and at ~290s (100s-to-60s transition) in order to maintain total time-averaged RF exposure compliance across time windows, as show in next plot.

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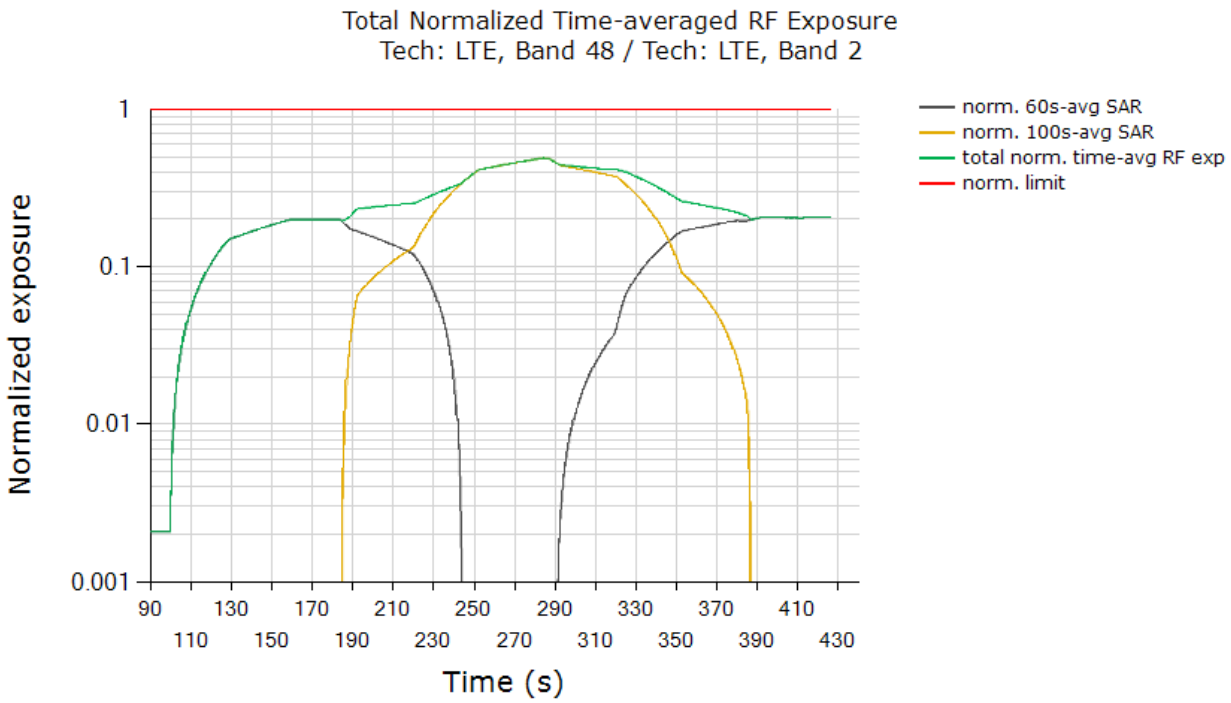
Plot 2: All the conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (7a), (7b) and (7c), and plotted below to demonstrate that the time-averaged normalized SAR versus time does not exceed the FCC limit of 1 unit. Equation (7a) is used to convert the Tx power of device to obtain 60s-averaged normalized SAR in LTE Band 48 as shown in black curve. Similarly, equation (7b) is used to obtain 100s-averaged normalized SAR in LTE Band 2 as shown in orange curve. Equation (7c) is used to obtain total time-averaged normalized SAR as shown in green curve (i.e., sum of black and orange curves).



	(W/kg)
FCC normalized total exposure limit	1.0
Max time averaged normalized SAR (green curve)	0.491
Validated	

Plot Notes: Maximum power is requested by callbox for the entire duration of the test, with tech/band switches from 60s-to-100s window at ~185s time stamp, and from 100s-to-60s window at ~290s time stamp. Smart Transmit controls the Tx power during these time-window switches to ensure total time-averaged RF exposure, i.e., sum of black and orange curves given by equation (7c), is always compliant. In time-window switch test, at all times the total time-averaged normalized RF exposure (green curve) should not exceed normalized *SAR_design_target* + 1dB device uncertainty. In this test, with a maximum normalized SAR of 0.491 being ≤ 0.79 (= 1.0/1.6 + 1dB device uncertainty), the above test result validated the continuity of power limiting in time-window switch scenario.

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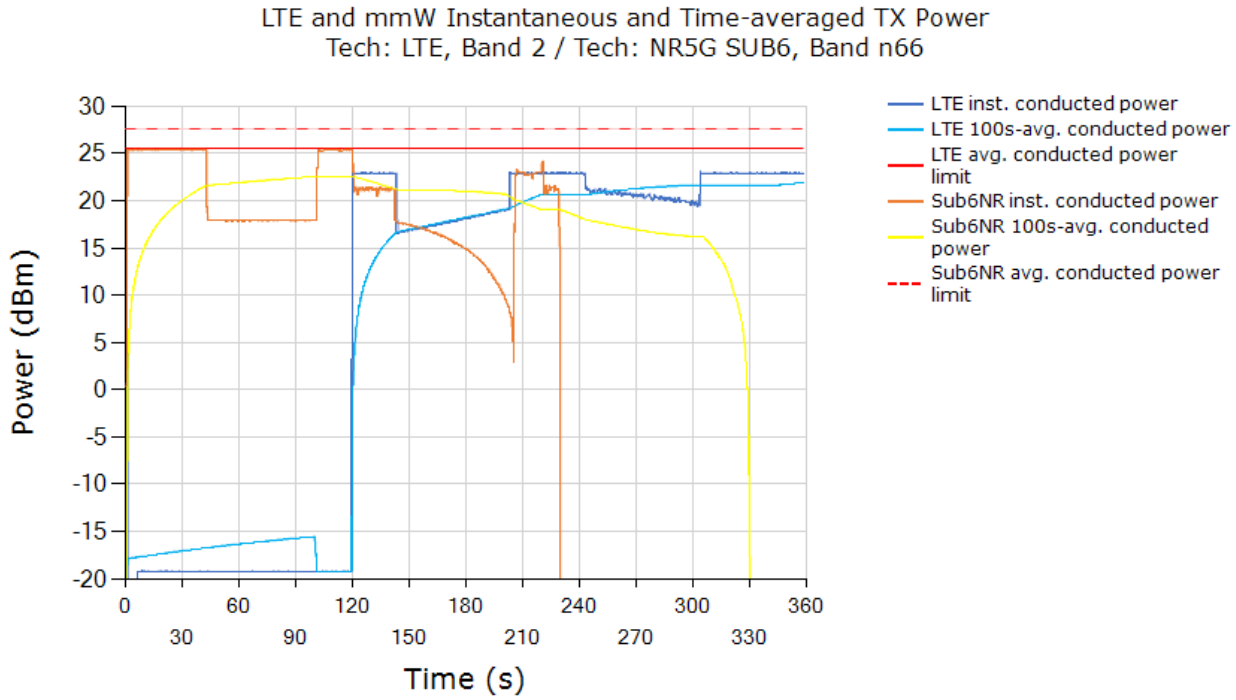
9.6 Switch in SAR exposure test results

This test was conducted with callbox requesting maximum power, and with the EUT in LTE Band 2 + Sub6 NR Band n66 call. Following procedure detailed in Section 4.3.7 and Appendix D.2, and using the measurement setup shown in Figure 6-1(c) since LTE and Sub6 NR are sharing the same antenna port, the SAR exposure switch measurement is performed with the EUT in various SAR exposure scenarios, i.e., in SAR_{sub6NR} only scenario (t =0s ~120s), SAR_{su6NR} + SAR_{LTE} scenario (t =120s ~ 230s) and SAR_{LTE} only scenario (t > 230s).



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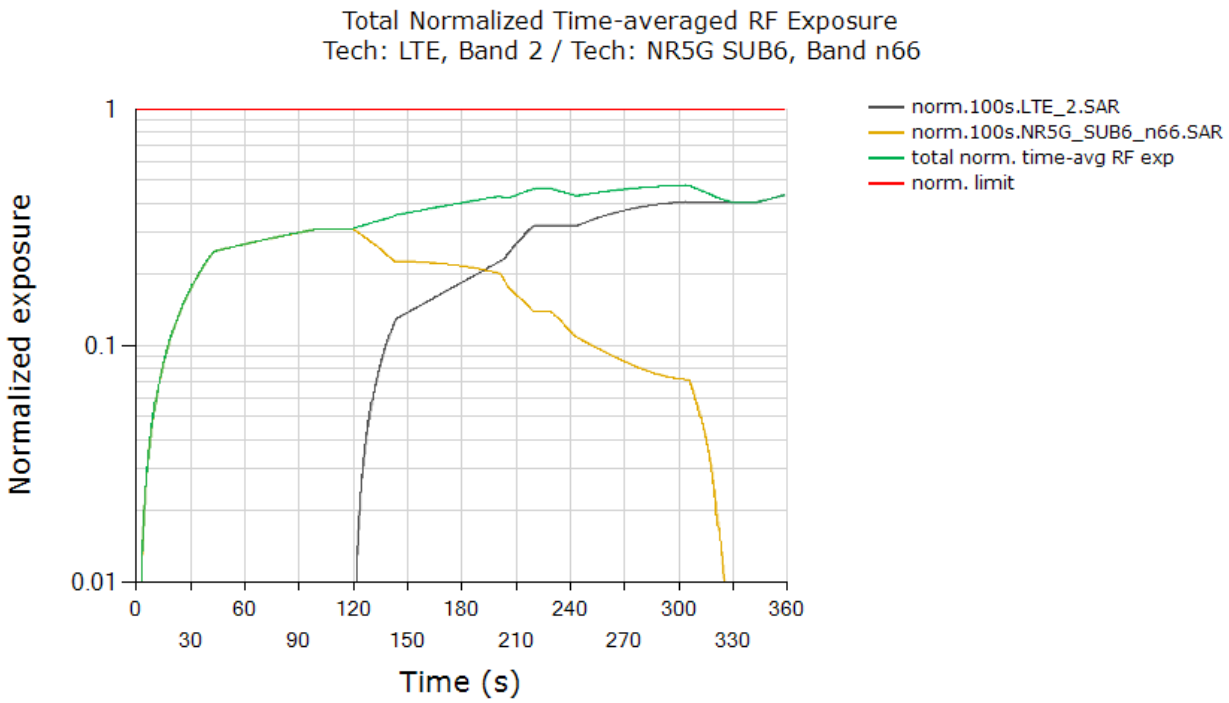
Plot 2: All the conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (7a), (7b) and (7c), and plotted below to demonstrate that the time-averaged normalized SAR versus time does not exceed the FCC limit of 1 unit. Equation (7a) is used to convert the LTE Tx power of device to obtain 100s-averaged normalized SAR in LTE Band 2 as shown in black curve. Similarly, equation (7b) is used to obtain 100s-averaged normalized SAR in Sub6 NR n66 as shown in orange curve. Equation (7c) is used to obtain total time-averaged normalized SAR as shown in green curve (i.e., sum of black and orange curves).



	(W/kg)
FCC normalized total exposure limit	1.0
Max time averaged normalized SAR (green curve)	0.476
Validated	

Plot Notes: Device starts predominantly in Sub6 NR SAR exposure scenario between 0s and 120s, and in LTE SAR + Sub6 NR SAR exposure scenario between 120s and 230s, and in predominantly in LTE SAR exposure scenario after t=230s. Here, Smart Transmit allocates a maximum of 75% of exposure margin (based on 3dB reserve margin setting) for Sub6 NR. This corresponds to a normalized 1gSAR exposure value = 75% * 0.545 W/kg measured SAR at Sub6 NR *Plimit* / 1.6W/kg limit = 0.255 ± 1dB device related uncertainty (see orange curve between 0s~120s). For predominantly LTE SAR exposure scenario, maximum normalized 1gSAR exposure should correspond to 100% exposure margin = 0.771 W/kg measured SAR at LTE *Plimit* / 1.6W/kg limit = 0.371 ± 1dB device related uncertainty (see black curve after t = 230s). Additionally, in SAR exposure switch test, at all times the total time-averaged normalized RF exposure (green curve) should not exceed normalized *SAR_design_target* + 1dB device uncertainty. In this test, with a maximum normalized SAR of 0.476 being ≤ 0.79 (= 1.0/1.6 + 1dB device uncertainty), the above test result validated the continuity of power limiting in SAR exposure switch scenario.

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10 TEST CONFIGURATIONS (FREQ > 6 GHZ)

10.1 LTE + mmW NR transmission

Based on the selection criteria described in Section 4.2, the selections for LTE and mmW NR validation test are listed in Table 12-1. The radio configurations used in this test are listed in Table 12-2.

Table 12-1
Selections for LTE + mmW NR validation measurements

Transmission Scenario	Test	Technology and Band	mmW Beam
Time-varying Tx power test	1. Cond. & Rad. Power meas. 2. PD meas.	LTE Band 2 and n261	Beam ID 20
		LTE Band 2 and n260	Beam ID 44
Switch in SAR vs. PD	1. Cond. & Rad. Power meas.	LTE Band 2 and n261	Beam ID 20
		LTE Band 2 and n260	Beam ID 44
Beam switch test	1. Cond. & Rad. Power meas.	LTE Band 2 and n261	Beam ID 20 to Beam ID 0
		LTE Band 2 and n260	Beam ID 29 to Beam ID 2

Table 12-2
Test configuration for LTE + mmW NR validation

Tech	Band	Antenna	DSI	Channel	Freq (MHz)	RB/RB Offset/Bandwidth (MHz)	Mode	UL Duty Cycle
LTE	2	2	5	18900	1880	1/0/20 MHz BW	QPSK	100%
mmW NR	n261	QTM 1	-	2071821	27559.32	66/0/100 MHz BW	CP-OFDM, QPSK	75.6%*
	n260	QTM 2	-	2254147	38498.88	66/0/100 MHz BW	CP-OFDM, QPSK	75.6%*

10.2 mmW NR radiated power test results

To demonstrate the compliance, the conducted Tx power of LTE Band 2 in DSI = 5 is converted to 1gSAR exposure by applying the corresponding worst-case 1g SAR value at P_{limit} as reported in Part 1 report and listed in Table 8-2 of this report.

Similarly, following Step 4 in Section 5.3.1, radiated Tx power of mmW Band n261 and n260 for the beams tested is converted by applying the corresponding measured worst-case 4cm^{2}PD values, and listed in below Table 12-3. Qualcomm Smart Transmit feature operates based on time-averaged Tx power reported on a per symbol basis, which is independent of modulation, channel and bandwidth (RBs), therefore the worst-case 4cm^{2}PD was conducted with the EUT in FTM mode, with CW modulation and 100% duty cycle. cDASY6 system verification for power density measurement is provided in Section 14, and the associated SPEAG certificates are attached in Appendix E.

Both the worst-case 1gSAR and 4cm^{2}PD values used in this section are listed in Table 12-3. The measured EIRP at *input.power.limit* for the beams tested in this section are also listed in Table 12-3.

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Table 12-3
Worst-case 1gSAR, 4cm^2 avg. PD and EIRP measured at *input.power.limit* for the selected configurations

Tech	Band	Antenna	Beam ID	input.power.limit (dBm)	Measured psPD at input.power.limit		Measured EIRP at input.power.limit (dBm)
					4cm^2 psPD (W/m^2)	Test Position	
mmW NR	n261	QTM 1	20	4.5	5	Back	14.27
		QTM 1	0	9.2 -> 8.0*	3.9	Back	10.21
mmW NR	n260	QTM 2	44	4.3	3.35	Back	6.95
		QTM 2	29	4.3	3.2	Back	12.29
		QTM 2	2	9.7 -> 7.0**	2.45	Back	6.42

Tech	Band	Antenna	DSI	Measured Plimit (dBm)	Measured 1g SAR at Plimit	
					1g SAR (W/kg)	Test Position
LTE	2	2	5	22.09	0.771	Bottom

*The *input.power.limit* for n261 beam 0 is 9.2 dBm. However, the maximum input power of SM7250 for n261 CP-OFDM modulation is 8.0 dBm for the test configuration used, thus, the *input.power.limit* was adjusted to 8.0 dBm in the static PD measurement via FTM for n261 beam 0 to obtain the maximum PD exposure for CP-OFDM modulation.

**The *input.power.limit* for n260 beam 2 is 9.7 dBm. However, the maximum input power of SM7250 for n260 CP-OFDM modulation is 7.0 dBm for the test configuration used, thus, the *input.power.limit* was adjusted to 7.0 dBm in the static PD measurement via FTM for n260 beam 2 to obtain the maximum PD exposure for CP-OFDM modulation.

The 4cm^2 psPD distributions for the highest PD value per band, as listed in Table 12-3, are plotted below.

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Figure 12-1
4cm² psPD distribution measured at *input.power.limit* of 4.5 dBm on the back surface for n261 beam 20

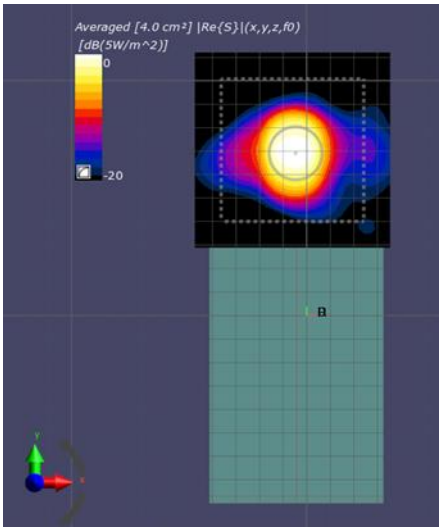
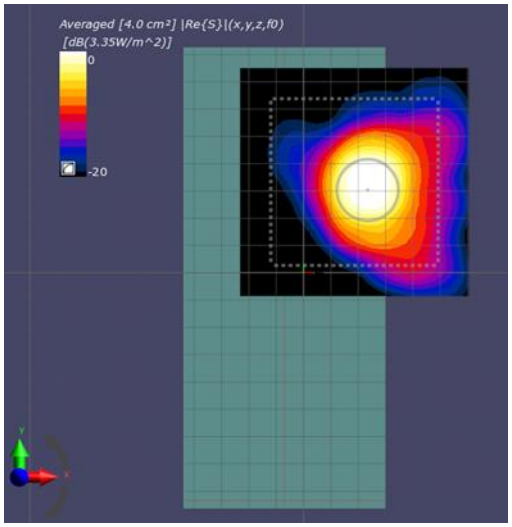


Figure 12-2
4cm² psPD distribution measured at *input.power.limit* of 4.3 dBm on the back surface for n260 beam 44



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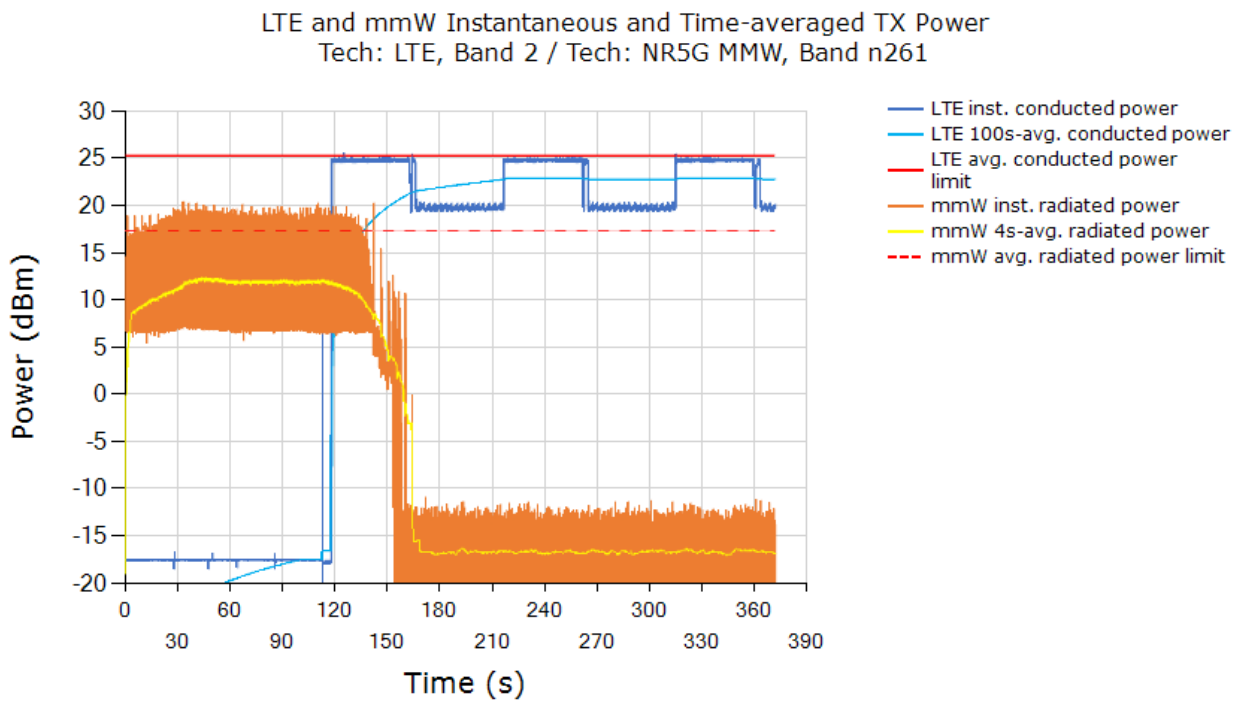
11 RADIATED POWER TX CASES (FREQ > 6 GHZ)

11.1 Maximum Tx power test results for n261

This test was measured with LTE Band 2 and mmW Band n261 Beam ID 20, by following the detailed test procedure described in Section 5.3.1.

Instantaneous and 100s-averaged conducted LTE Tx power versus time, instantaneous and 4s-averaged radiated mmW Tx power versus time, time-averaged conducted LTE Tx power limit and time-averaged radiated mmW Tx power limit:



Above time-averaged conducted Tx power for LTE Band 2 and radiated Tx power for mmW NR n261 beam 20 are converted into time-averaged 1gSAR and time-averaged 4cm^{2}PD using Equation (2a) and (2b), which are divided by FCC 1gSAR limit of 1.6 W/kg and 4cm^{2}PD limit of 10 W/m^2, respectively, to obtain normalized exposures versus time. Below plot shows (a) normalized time-averaged 1gSAR versus time, (b) normalized time-averaged 4cm2-avg.PD versus time, (c) sum of normalized time-averaged 1gSAR and normalized time-averaged 4cm^2-avg.PD:

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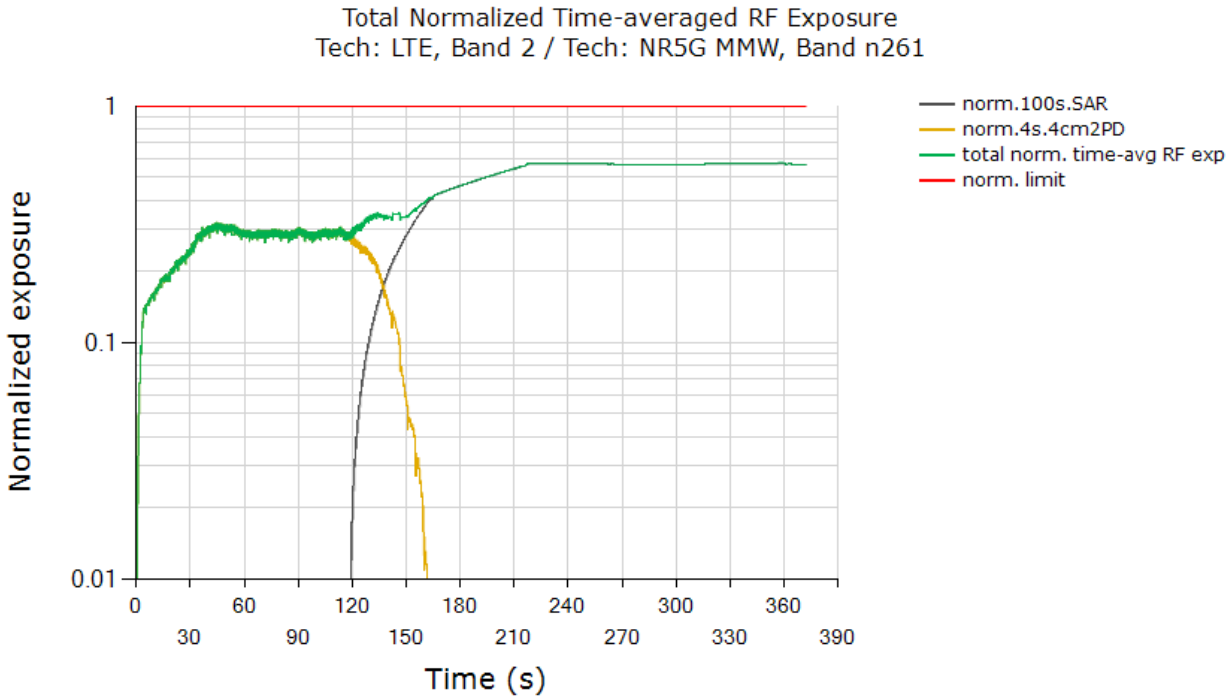

FCC requirement for total RF exposure (normalized)	1.0
Max total normalized time-averaged RF exposure (green curve)	0.574
Validated	

Plot notes: As soon as 5G mmW NR call was established, LTE was placed in all-down bits immediately. Between 0s~120s, mmW exposure is the dominant contributor. Here, Smart Transmit feature allocates a maximum of 75% for mmW (based on the 3dB reserve setting in Part 1 report). From Table 12-3, this corresponds to a normalized 4cm^{2}PD exposure value for Beam ID 20 of (75% * 5.0 W/m^2)/(10 W/m^2) = 37.5% ± 2.1dB device related uncertainty (see green/orange curve between 0s~120s). At ~120s time mark, LTE is set to all-up bits, taking away margin from mmW exposure gradually. Towards the end of test, LTE is the dominant contributor towards RF exposure, i.e., corresponding normalized 1g SAR exposure value of (100% * 0.771 W/kg)/(1.6 W/kg) = 48.2% ± 1dB design related uncertainty (see black curve approaching this level towards end of the test).

As can be seen, the power limiting enforcement is effective and the total normalized time-averaged RF exposure does not exceed 1.0. Therefore, Qualcomm® Smart Transmit time averaging feature is validated.

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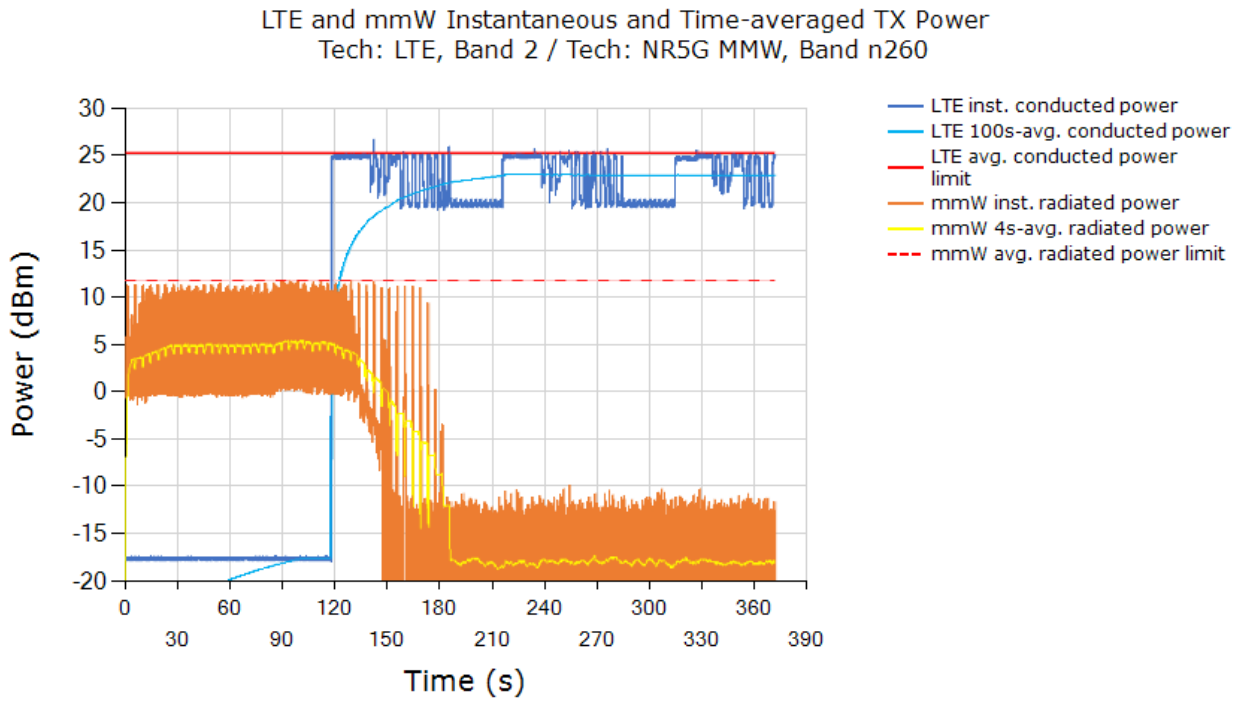
11.2 Maximum Tx power test results for n260

This test was measured with LTE Band 2 and mmW Band n260 Beam ID 44, by following the detailed test procedure described in Section 5.3.1.

Instantaneous and 100s-averaged conducted LTE Tx power versus time, instantaneous and 4s-averaged radiated mmW Tx power versus time, time-averaged conducted LTE Tx power limit and time-averaged radiated mmW Tx power limit:



Above time-averaged conducted Tx power for LTE Band 2 and radiated Tx power for mmW NR n260 beam 44 are converted into time-averaged 1gSAR and time-averaged 4cm^{2}PD using Equation (2a) and (2b), which are divided by FCC 1gSAR limit of 1.6 W/kg and 4cm^{2}PD limit of 10 W/m^2, respectively, to obtain normalized exposures versus time. Below plot shows (a) normalized time-averaged 1gSAR versus time, (b) normalized time-averaged 4cm2-avg.PD versus time, (c) sum of normalized time-averaged 1gSAR and normalized time-averaged 4cm^2-avg.PD:

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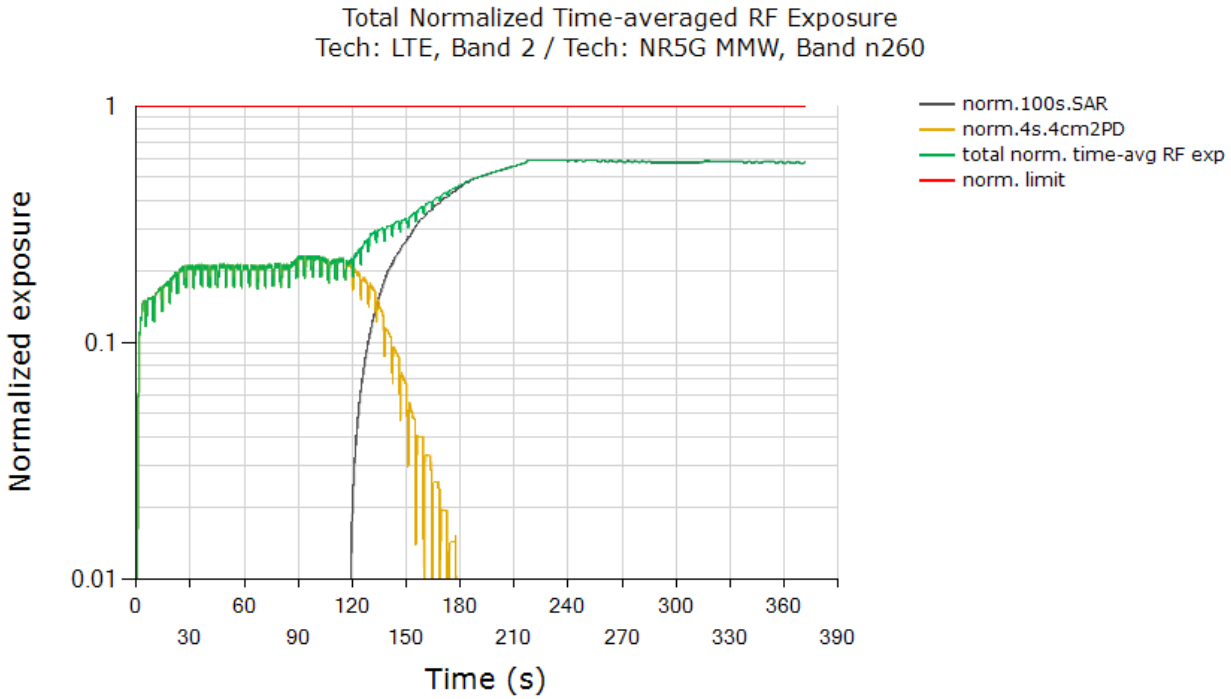

FCC requirement for total RF exposure (normalized)	1.0
Max total normalized time-averaged RF exposure (green curve)	0.594
Validated	

Plot notes: As soon as 5G mmW NR call was established, LTE was placed in all-down bits immediately. Between 0s~120s, mmW exposure is the dominant contributor. Here, Smart Transmit feature allocates a maximum of 75% for mmW (based on the 3dB reserve setting in Part 1 report). From Table 12-3, this corresponds to a normalized 4cm^{2}PD exposure value for Beam ID 44 of (75% * 3.35 W/m^2)/(10 W/m^2) = 25.1% ± 2.1dB device related uncertainty (see green/orange curve between 0s~120s). At ~120s time mark, LTE is set to all-up bits, taking away margin from mmW exposure gradually. Towards the end of test, LTE is the dominant contributor towards RF exposure, i.e., corresponding normalized 1gSAR exposure value of (100% * 0.771 W/kg)/(1.6 W/kg) = 48.2% ± 1dB design related uncertainty (see black curve approaching this level towards end of the test).

As can be seen, the power limiting enforcement is effective and the total normalized time-averaged RF exposure does not exceed 1.0. Therefore, Qualcomm® Smart Transmit time averaging feature is validated.

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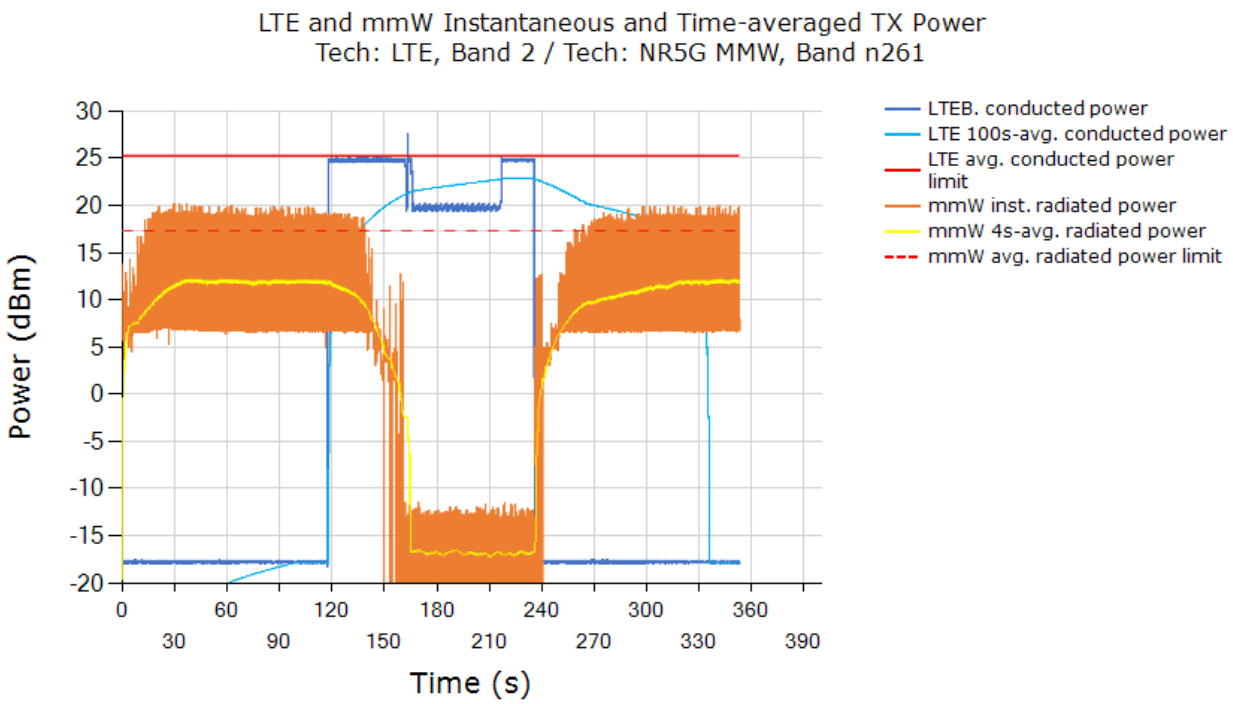
11.3 Switch in SAR vs. PD exposure test results for n261

This test was measured with LTE Band 2 (DSI = 5) and mmW Band n261 Beam ID 20, by following the detailed test procedure is described in Section 5.3.2.

Instantaneous and 100s-averaged conducted LTE Tx power versus time, instantaneous and 4s-averaged radiated mmW Tx power versus time, time-averaged conducted LTE Tx power limit and time-averaged radiated mmW Tx power limit:



From the above plot, it is predominantly instantaneous PD exposure between 0s ~ 120s, it is instantaneous SAR+PD exposure between 120s ~ 140s, it is predominantly instantaneous SAR exposure between 140s ~ 240s, and above 240s, it is predominantly instantaneous PD exposure.

Normalized time-averaged exposures for LTE (1gSAR) and mmW (4cm^{2}PD), as well as total normalized time-averaged exposure versus time:

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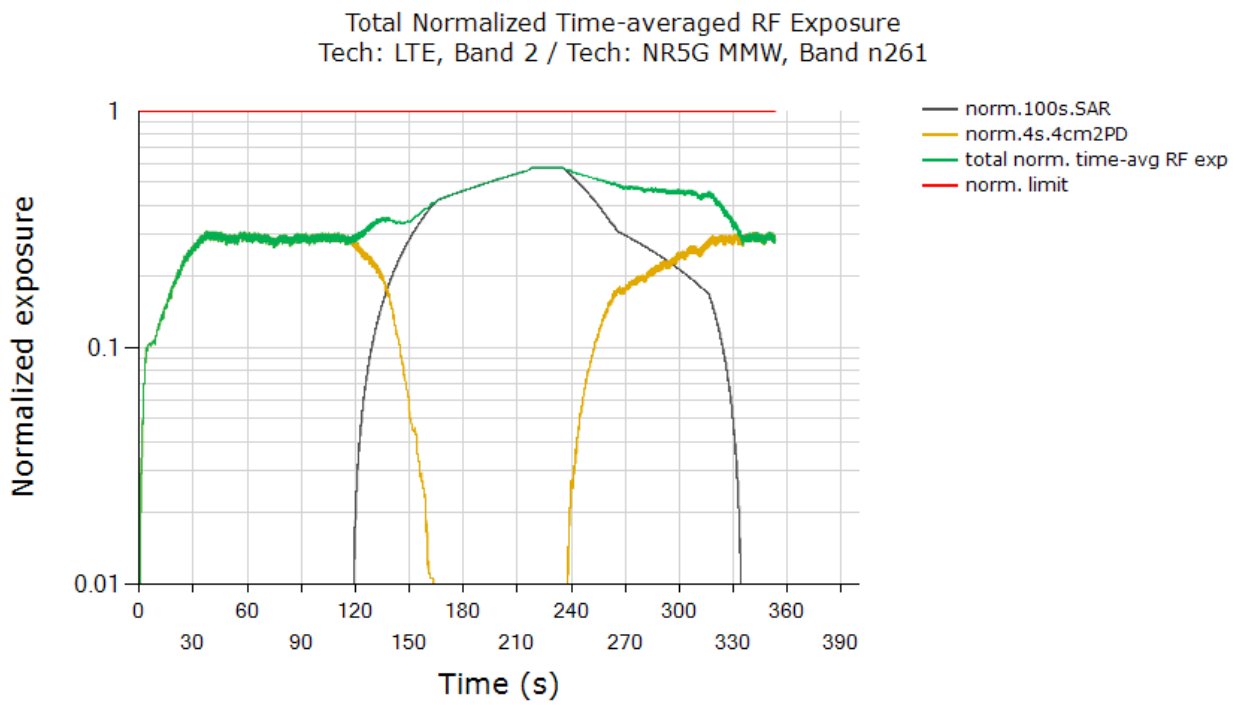

FCC requirement for total RF exposure (normalized)	1.0
Max total normalized time-averaged RF exposure (green curve)	0.575
Validated	

Plot notes: As soon as 5G mmW NR call was established, LTE was placed in all-down bits immediately. Between 0s~120s, mmW exposure is the dominant contributor. Here, Smart Transmit feature allocates a maximum of 75% for mmW (based on 3dB reserve setting in Part 1 report). From Table 12-3, this corresponds to a normalized 4cm^{2}PD exposure value for Beam ID 20 of (75% * 5.00 W/m^2)/(10 W/m^2) = 37.5% ± 2.1dB device related uncertainty (see orange/green curve between 0s~120s). At ~120s time mark, LTE is set to all-up bits, taking away margin from mmW exposure gradually (orange curve for mmW exposure goes down while black curve for LTE exposure goes up). At ~240s time mark, LTE is set to all-down bits, which results in mmW getting back RF margin slowly as seen by gradual increase in mmW exposure (orange curve for mmW exposure goes up while black curve for LTE exposure goes down). The calculated maximum RF exposure from LTE corresponds to normalized 1gSAR exposure value of (100% * 0.771 W/kg)/(1.6 W/kg) = 48.2% ± 1dB design related uncertainty (note that this level will be achieved by green and black curves if LTE remains in all-up bits for longer time duration which was already demonstrated in maximum Tx power test in Section 13.1). Total normalized time-averaged exposure (green curve) for this test should be within the calculated range between 37.5% ± 2.1dB device related uncertainty (only PD exposure) and 48.2% ± 1dB design related uncertainty (only SAR exposure).

As can be seen, the power limiting enforcement is effective during transmission when SAR and PD exposures are switched, and the total normalized time-averaged RF exposure does not exceed 1.0. Therefore, Qualcomm® Smart Transmit time averaging feature is validated.

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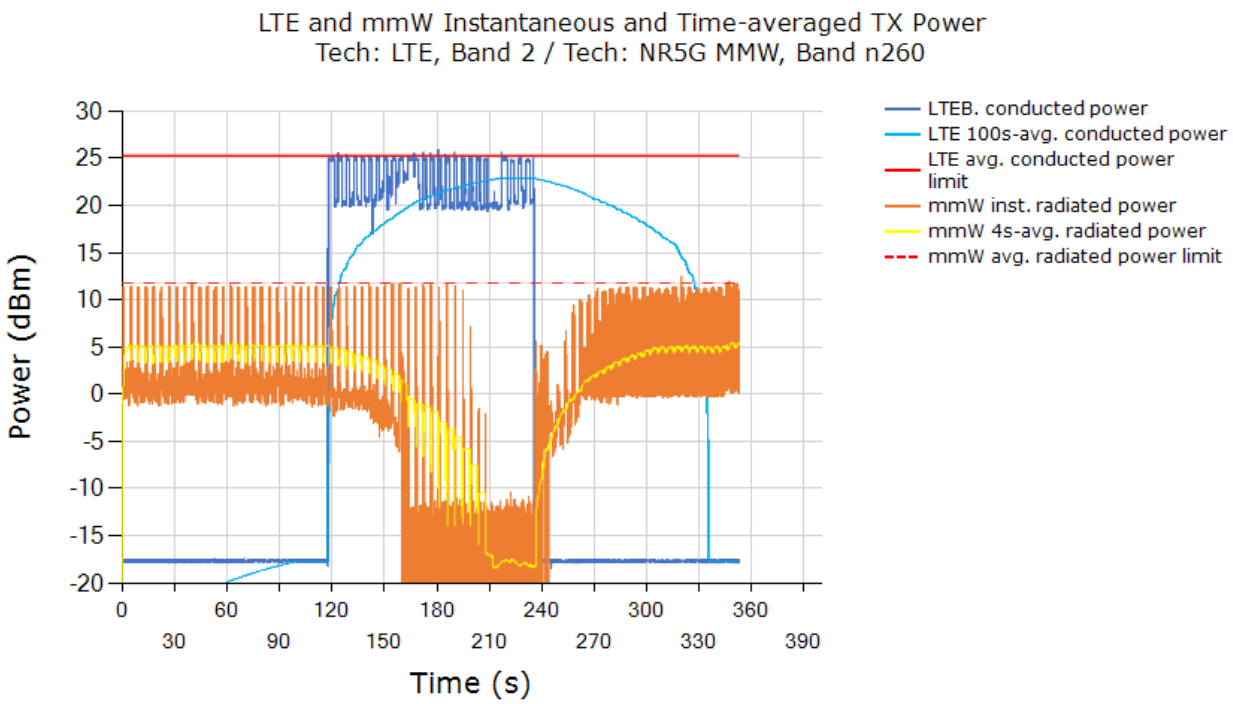
11.4 Switch in SAR vs. PD exposure test results for n260

This test was measured with LTE Band 2 (DSI = 5) and mmW Band n260 Beam ID 44, by following the detailed test procedure is described in Section 5.3.2.

Instantaneous and 100s-averaged conducted LTE Tx power versus time, instantaneous and 4s-averaged radiated mmW Tx power versus time, time-averaged conducted LTE Tx power limit and time-averaged radiated mmW Tx power limit:



From the above plot, it is predominantly instantaneous PD exposure between 0s ~ 120s, it is instantaneous SAR+PD exposure between 120s ~ 140s, it is predominantly instantaneous SAR exposure between 140s ~ 240s, and above 240s, it is predominantly instantaneous PD exposure

Normalized time-averaged exposures for LTE (1gSAR) and mmW (4cm^{2}PD), as well as total normalized time-averaged exposure versus time:

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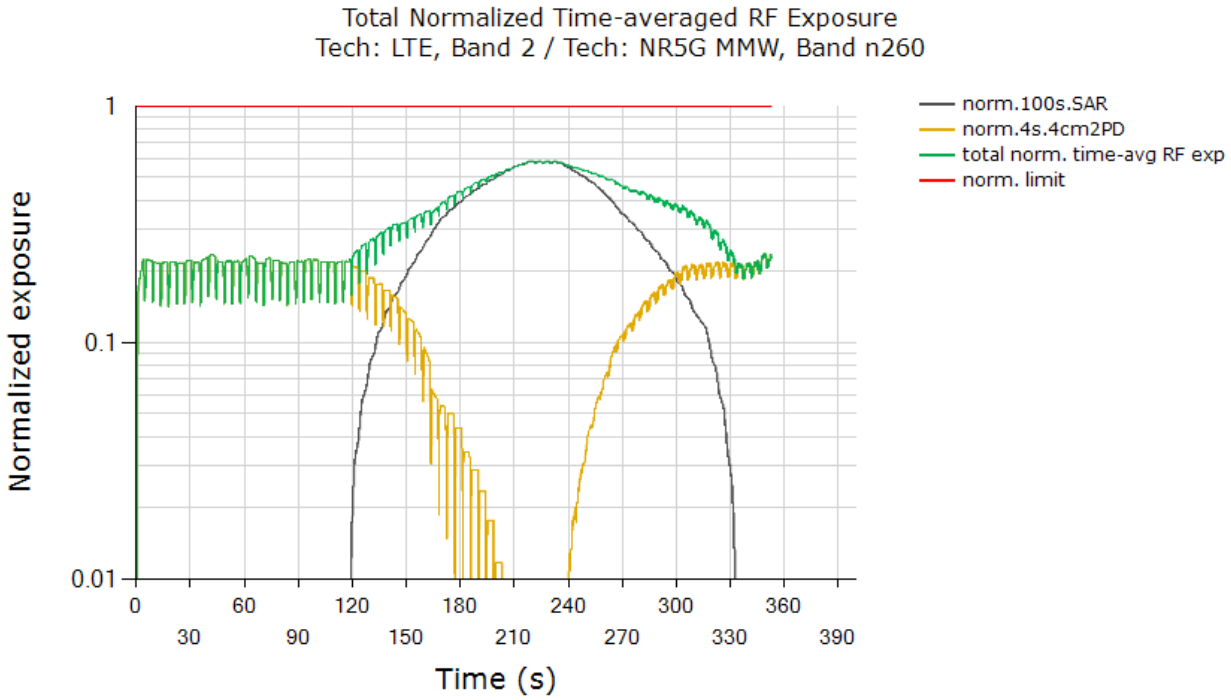

FCC requirement for total RF exposure (normalized)	1.0
Max total normalized time-averaged RF exposure (green curve)	0.586
Validated	

Plot notes: As soon as 5G mmW NR call was established, LTE was placed in all-down bits immediately. Between 0s~120s, mmW exposure is the dominant contributor. Here, Smart Transmit feature allocates a maximum of 75% for mmW (based on 3dB reserve setting in Part 1 report). From Table 12-3, this corresponds to a normalized 4cm^{2}PD exposure value for Beam ID 44 of (75% * 3.35 W/m^2)/(10 W/m^2) = 25.1% ± 2.1dB device related uncertainty (see orange/green curve between 0s~120s). At ~120s time mark, LTE is set to all-up bits, taking away margin from mmW exposure gradually (orange curve for mmW exposure goes down while black curve for LTE exposure goes up). At ~240s time mark, LTE is set to all-down bits, which results in mmW getting back RF margin slowly as seen by gradual increase in mmW exposure (orange curve for mmW exposure goes up while black curve for LTE exposure goes down). The calculated maximum RF exposure from LTE corresponds to normalized 1gSAR exposure value of (100% * 0.771 W/kg)/(1.6 W/kg) = 48.2% ± 1dB design related uncertainty (note that this level will be achieved by green and black curves if LTE remains in all-up bits for longer time duration which was already demonstrated in maximum Tx power test in Section 13.1). Total normalized time-averaged exposure (green curve) for this test should be within the calculated range between 25.1% ± 2.1dB device related uncertainty (only PD exposure) and 48.2% ± 1dB design related uncertainty (only SAR exposure).

As can be seen, the power limiting enforcement is effective during transmission when SAR and PD exposures are switched, and the total normalized time-averaged RF exposure does not exceed 1.0. Therefore, Qualcomm® Smart Transmit time averaging feature is validated.

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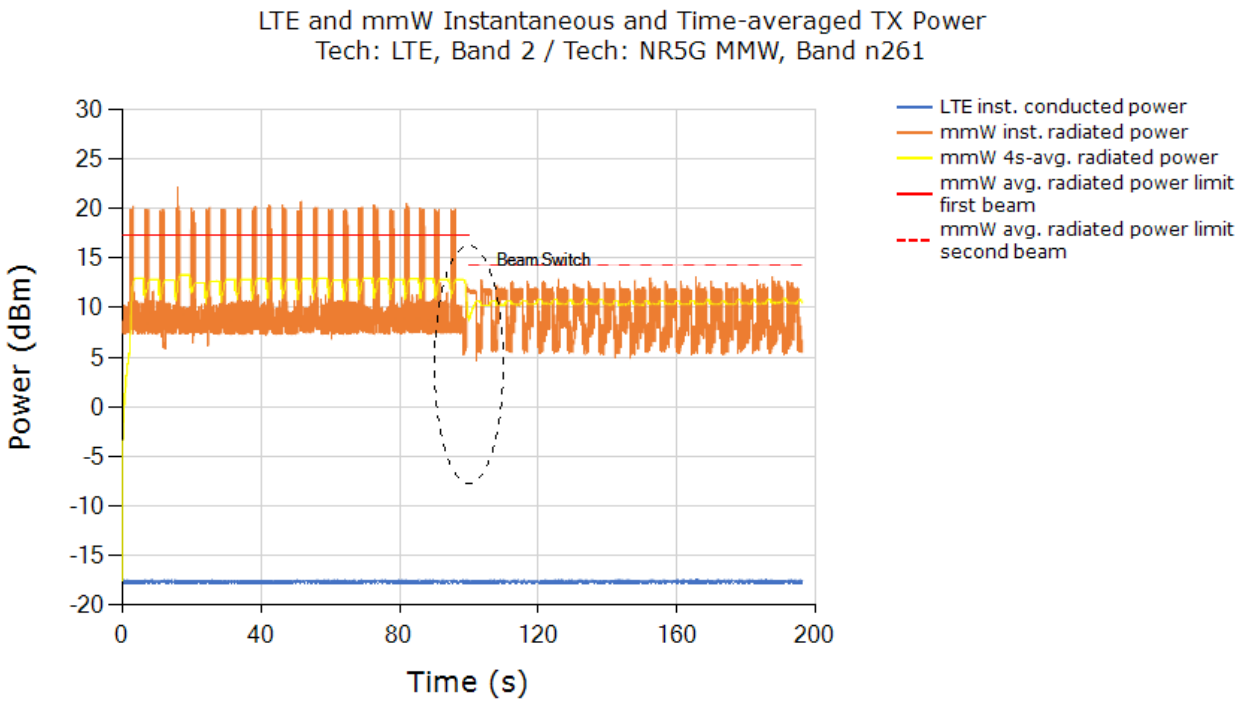
11.5 Change in Beam test results for n261

This test was measured with LTE Band 2 (DSI = 5) and mmW Band n261, with beam switch from Beam ID 20 to Beam ID 0, by following the test procedure is described in Section 5.3.3.

Instantaneous conducted LTE Tx power versus time, instantaneous and 4s-averaged radiated mmW Tx power versus time, time-averaged radiated mmW Tx power limits for beam 20 and beam 0:



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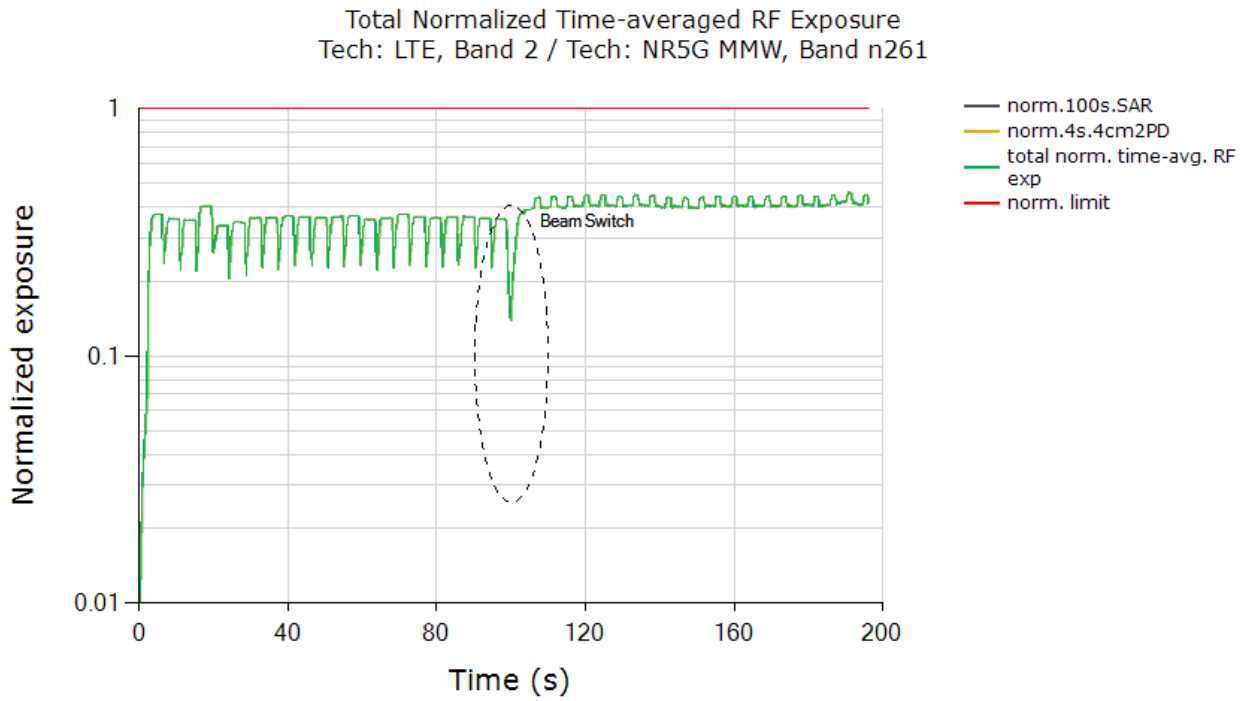
Normalized time-averaged exposures for LTE and mmW (4cm^{2}PD), as well as total normalized time-averaged exposure versus time:



FCC requirement for total RF exposure (normalized)	1.0
Max total normalized time-averaged RF exposure (green curve)	0.456
Validated	

Plot notes: 5G mmW NR call was established at ~1s time mark and LTE was placed in all-down bits immediately after 5G mmW NR call was established. For the rest of this test, mmW exposure is the dominant contributor as LTE is left in all-down bits. Here, Smart Transmit feature allocates a maximum of 75% for mmW (based on 3dB reserve setting in Part 1 report). From Table 12-3, exposure between 1s ~100s corresponds to a normalized 4cm^{2}PD exposure value for Beam ID 20 of (75% * 5.00 W/m^2)/(10 W/m^2) = 37.5% ± 2.1dB device related uncertainty. At ~100s time mark (shown in black dotted ellipse), beam was switched to Beam ID 0. Note that the *input.power.limit* for Beam ID 0 is 9.2 dBm, however the maximum input power for n261 CP-OFDM modulation is capped at 8.0 dBm, therefore, there is no power limiting required when in n261 Beam ID 0, resulting in flat line in power plot for instantaneous radiated power after switch. Note that at 8.0 dBm max power, it is 1.2 dB (76.0% in linear units) lower than *input.power.limit*. Since the callbox is configured to transmit at 75.6% duty cycle, the maximum average power consumes 76.0 % x 75.6% = 57.5% of RF exposure margin utilized by Beam ID 0 (less than 75% allocated margin for mmW by Smart Transmit). Therefore, Smart Transmit allows Beam ID 0 to transmit at maximum power continuously at 75.6% duty cycle. Therefore, the normalized 4cm^{2}PD exposure value for n261 Beam ID 0 = (100% * 75.6% callbox duty cycle * 3.90 W/m^2)/(10 W/m^2) = 29.5% ± 2.1dB device related uncertainty. Additionally, during the switch, the ratio between the averaged radiated powers of the two beams (yellow curve) should correspond to the difference in EIRPs measured at each corresponding *input.power.limit* for these beams listed in Table 12-3, i.e., 4.06 dB ± 2.1dB device uncertainty.

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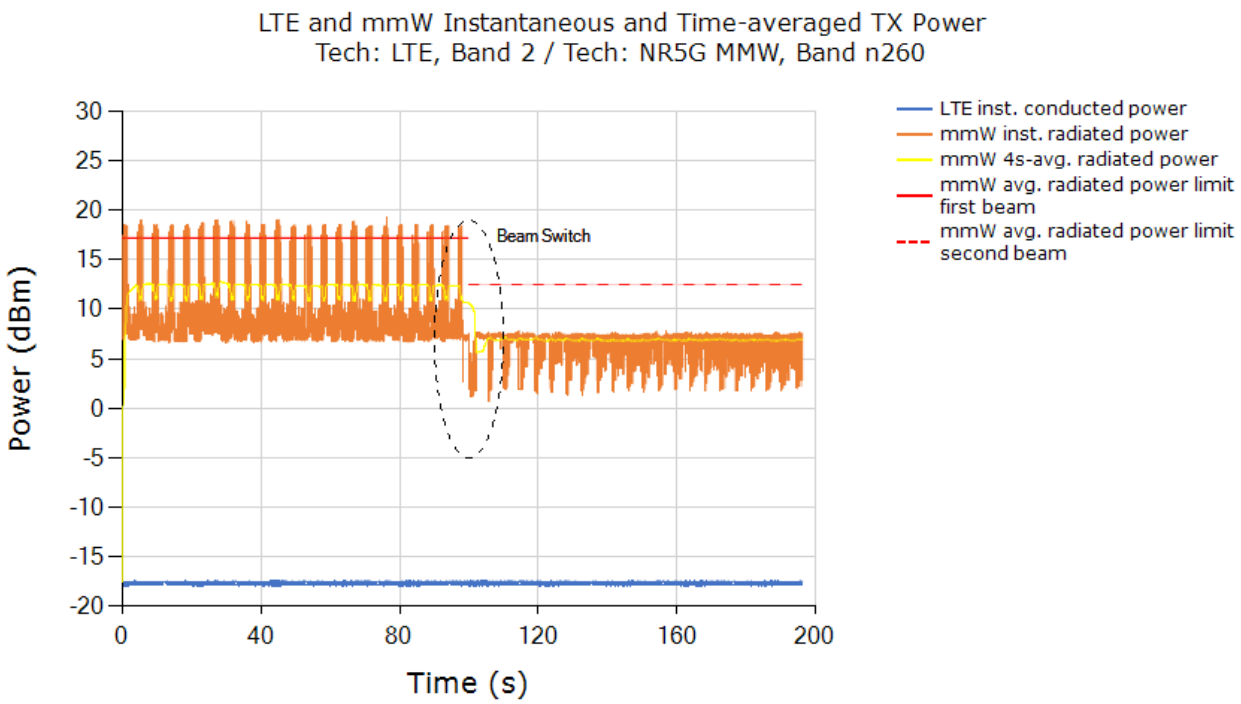
11.6 Change in Beam test results for n260

This test was measured with LTE Band 2 (DSI = 5) and mmW Band n260, with beam switch from Beam ID 29 to Beam ID 2, by following the test procedure is described in Section 5.3.3.

Instantaneous conducted LTE Tx power versus time, instantaneous and 4s-averaged radiated mmW Tx power versus time, time-averaged radiated mmW Tx power limits for beam 29 and beam 2:



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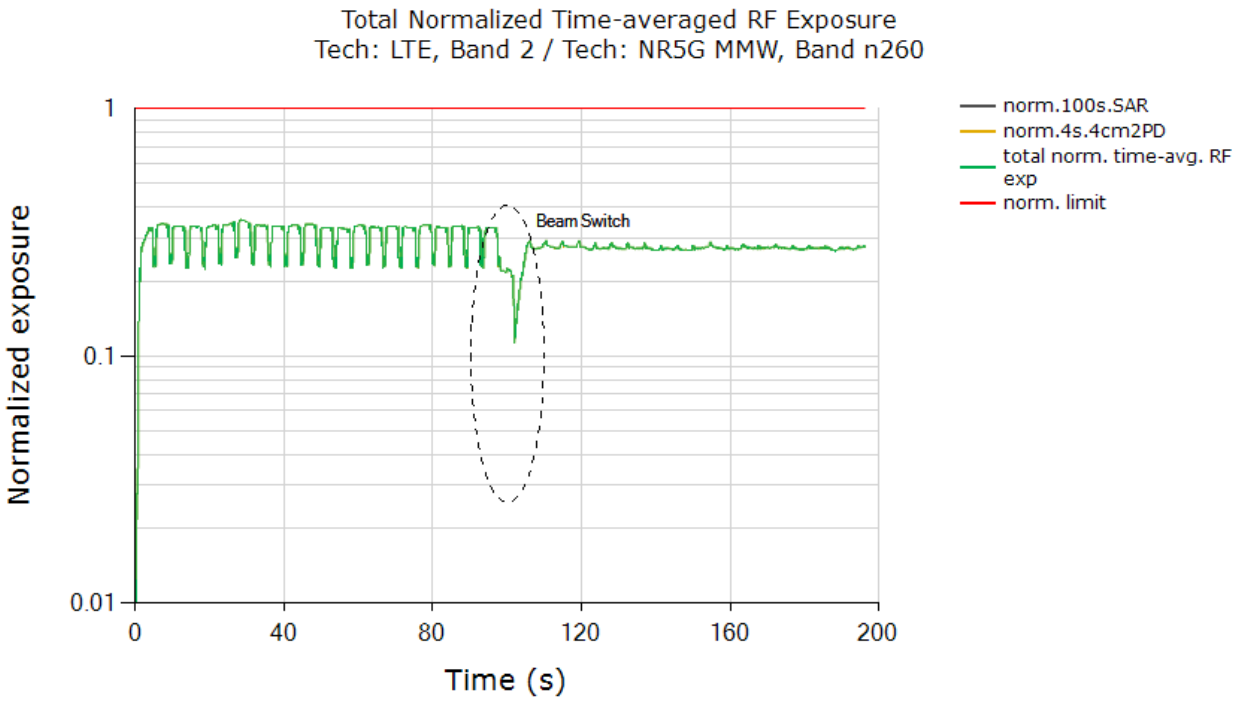
Normalized time-averaged exposures for LTE and mmW (4cm^{2}PD), as well as total normalized time-averaged exposure versus time:



FCC requirement for total RF exposure (normalized)	1.0
Max total normalized time-averaged RF exposure (green curve)	0.354
Validated	

Plot notes: 5G mmW NR call was established at ~1s time mark and LTE was placed in all-down bits immediately after 5G mmW NR call was established. For the rest of this test, mmW exposure is the dominant contributor as LTE is left in all-down bits. Here, Smart Transmit feature allocates a maximum of 75% for mmW (based on 3dB reserve setting in Part 1 report). From Table 12-3, exposure between 1s ~100s corresponds to a normalized 4cm^{2}PD exposure value for Beam ID 29 of (75% * 3.20 W/m^2)/(10 W/m^2) = 24.0% ± 2.1dB device related uncertainty. At ~100s time mark (shown in black dotted ellipse), beam was switched to Beam ID 2. Note that the *input.power.limit* for Beam ID 2 is 9.7 dBm, however the maximum input power for n260 CP-OFDM modulation is capped at 7.0 dBm, therefore, there is no power limiting required when in n260 Beam ID 2, resulting in flat line in power plot for instantaneous radiated power after switch. Note that at 7.0 dBm max power, it is 2.7dB (53.5% in linear units) lower than *input.power.limit*. Since the callbox is configured to transmit at 75.6% duty cycle, the maximum average power consumes 53.5% x 75.6% = 40.4% of RF exposure margin utilized by Beam ID 2 (less than 75% allocated margin for mmW by Smart Transmit). Therefore, Smart Transmit allows Beam ID 2 to transmit at maximum power continuously at 75.6% duty cycle. Therefore, the normalized 4cm^{2}PD exposure value for n260 Beam ID 2 = (100% * 75.6% callbox duty cycle * 2.45 W/m^2)/(10 W/m^2) = 18.5% ± 2.1dB device related uncertainty. Additionally, during the switch, the ratio between the averaged radiated powers of the two beams (yellow curve) should correspond to the difference in EIRPs measured at each corresponding *input.power.limit* for these beams listed in Table 12-3, i.e., 5.87 ± 2.1dB device uncertainty.

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12 SYSTEM VERIFICATION (FREQ > 6 GHZ)

The system was verified to be within ±0.66 dB of the power density targets on the calibration certificate according to the test system specification in the user's manual and calibration facility recommendation. The 0.66 dB deviation threshold represents the expanded uncertainty for system performance checks using SPEAG's mmWave verification sources. The same spatial resolution and measurement region used in the source calibration was applied during the system check.

The measured power density distribution of verification source was also confirmed through visual inspection to have no noticeable differences, both spatially (shape) and numerically (level) from the distribution provided by the manufacturer, per November 2017 TCBC Workshop Notes.

Table 14-1
System Verification Results

System Verification										
Syst.	Freq. (GHz)	Date	Source SN	Probe SN	Normal psPD (W/m^2 over 4 cm^2)		Deviation (dB)	Total psPD (W/m^2 over 4 cm^2)		Deviation (dB)
					measured	target		measured	target	
Q	30	09/03/2020	1035	9415	28.00	32.10	-0.59	28.40	32.50	-0.59
Q	30	09/08/2020	1035	9415	28.00	32.10	-0.59	28.40	32.50	-0.59

Note: A **10 mm distance spacing** was used from the reference horn antenna aperture to the probe element. This includes 4.45 mm from the reference antenna horn aperture to the surface of the verification source plus 5.55 mm from the surface to the probe. The SPEAG software requires a setting of "5.55 mm" for the correct set up.

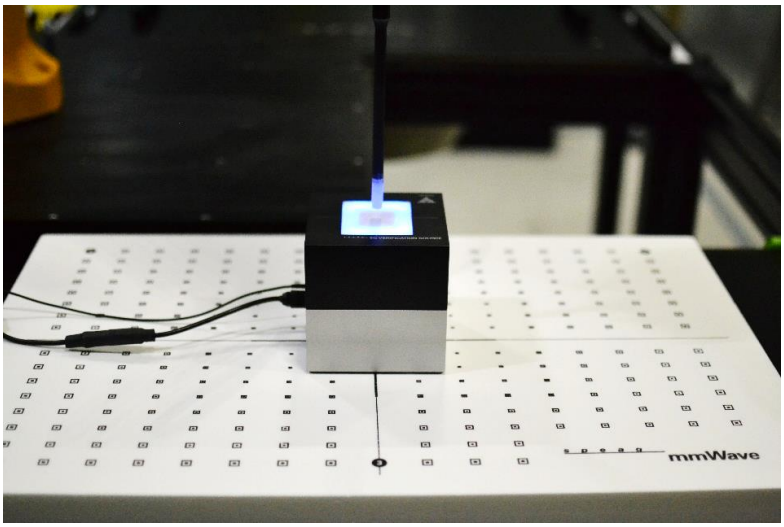

Figure 14-1
System Verification Setup Photo

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13 POWER DENSITY TEST RESULTS (FREQ > 6 GHZ)

13.1 PD measurement results for maximum power transmission scenario

The following configurations were measured by following the detailed test procedure is described in Section 5.4:

1. LTE Band 2 (DSI = 5) and mmW Band n261 Beam ID 20
2. LTE Band 2 (DSI = 5) and mmW Band n260 Beam ID 44

The measured conducted Tx power of LTE and ratio of $\frac{[pointE(t)]^2}{[pointE_input.power.limit]^2}$ of mmW is converted into 1gSAR and 4cm^{2}PD value, respectively, using Eq. (4a) and (4b), rewritten below:

$$1g_or_10gSAR(t) = \frac{conducted_Tx_power(t)}{conducted_Tx_power_P_{limit}} * 1g_or_10gSAR_P_{limit} \qquad (4a)$$

$$4cm^2PD(t) = \frac{[pointE(t)]^2}{[pointE_input.power.limit]^2} * 4cm^2PD_input.power.limit \qquad (4b)$$

$$\frac{\frac{1}{T_{SAR}}\int_{t-T_{SAR}}^{t} 1g_or_10gSAR(t)dt}{FCC\ SAR\ limit} + \frac{\frac{1}{T_{PD}}\int_{t-T_{PD}}^{t} 4cm^2PD(t)dt}{FCC\ 4cm^2PD\ limit} \leq 1 \qquad (4c)$$

where, $conducted_Tx_power(t)$, $conducted_Tx_power_P_{limit}$, and $1g_or_10gSAR_P_{limit}$ correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at P_{limit}, and measured 1gSAR or 10gSAR values at P_{limit} corresponding to LTE transmission. Similarly, $pointE(t)$, $pointE_input.power.limit$, and $4cm^2PD@input.power.limit$ correspond to the measured instantaneous E-field, E-field at *input.power.limit*, and 4cm^{2}PD value at *input.power.limit*. corresponding to mmW transmission.

NOTE: cDASY6 system measures relative E-field, and provides ratio of $\frac{[pointE(t)]^2}{[pointE_input.power.limit]^2}$ versus time.

The radio configurations tested are described in Table 12-1 and Table 12-2. The 1gSAR at P_{limit} for LTE 2 DSI = 5, the measured 4cm^{2}PD at *input.power.limit* of mmW n261 beam 20 and n260 beam 44, are all listed in Table 12-3.

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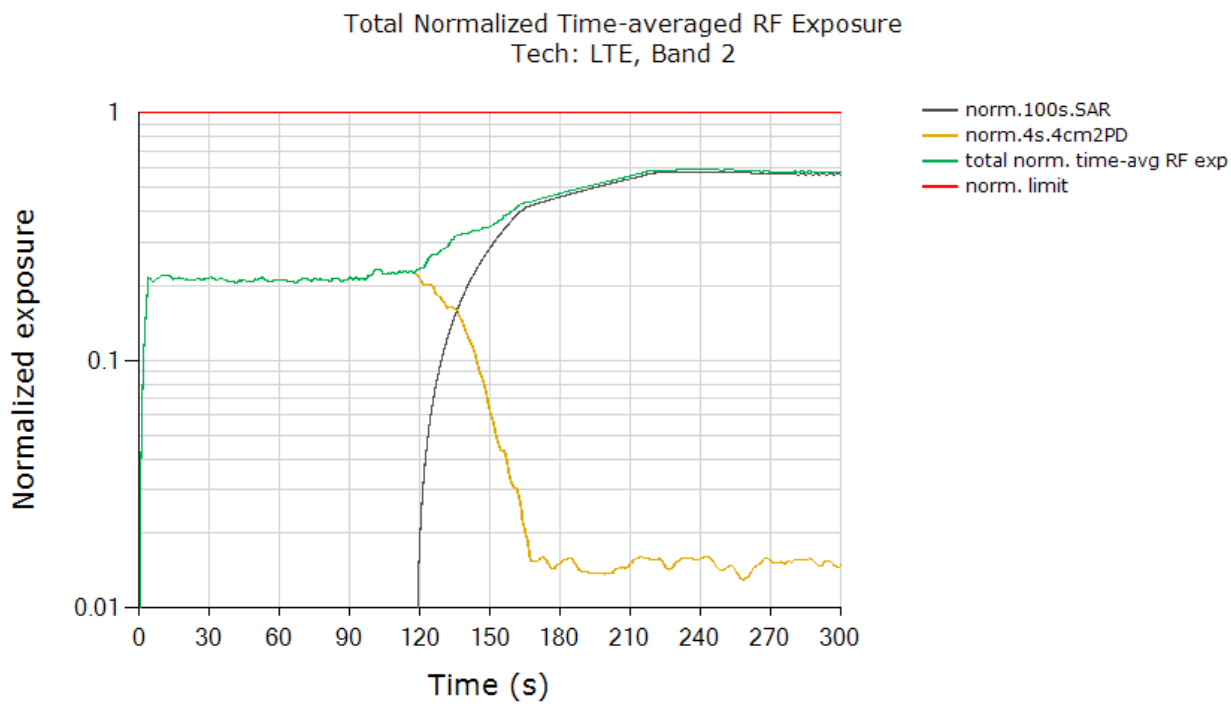
13.1.1 PD test results for n261

Step 2.e plot (in Section 5.4) for normalized instantaneous and time-averaged exposures for LTE and mmW n261 beam 20:



FCC limit for total RF exposure (normalized)	1.0
Max total normalized time-averaged RF exposure (green curve)	0.587
Validated	

Plot notes: LTE was placed in all-down bits immediately after 5G mmW NR call was established. Between 0s~120s, mmW exposure is the dominant contributor. Here, Smart Transmit feature allocates a maximum of 75% for mmW (based on the 3dB reserve setting in Part 1 report). From Table 12-3, this corresponds to a normalized 4cm^{2}PD exposure value for Beam ID 20 of (75% * 5.0 W/m^2)/(10 W/m^2) = 37.5% ± 2.1dB device related uncertainty (see orange/green curve between 0s~120s). Around 120s time mark, LTE is set to all-up bits, taking away margin from mmW exposure gradually. Towards the end of the test, LTE is the dominant contributor towards RF exposure, i.e., corresponding normalized 1gSAR exposure value of (100% * 0.771 W/kg)/(1.6 W/kg) = 48.2% ± 1dB design related uncertainty (see black curves approaching this level towards end of the test).

As can be seen, the power limiting enforcement is effective and the total normalized time-averaged RF exposure does not exceed 1.0. Therefore, Qualcomm® Smart Transmit time averaging feature is validated.

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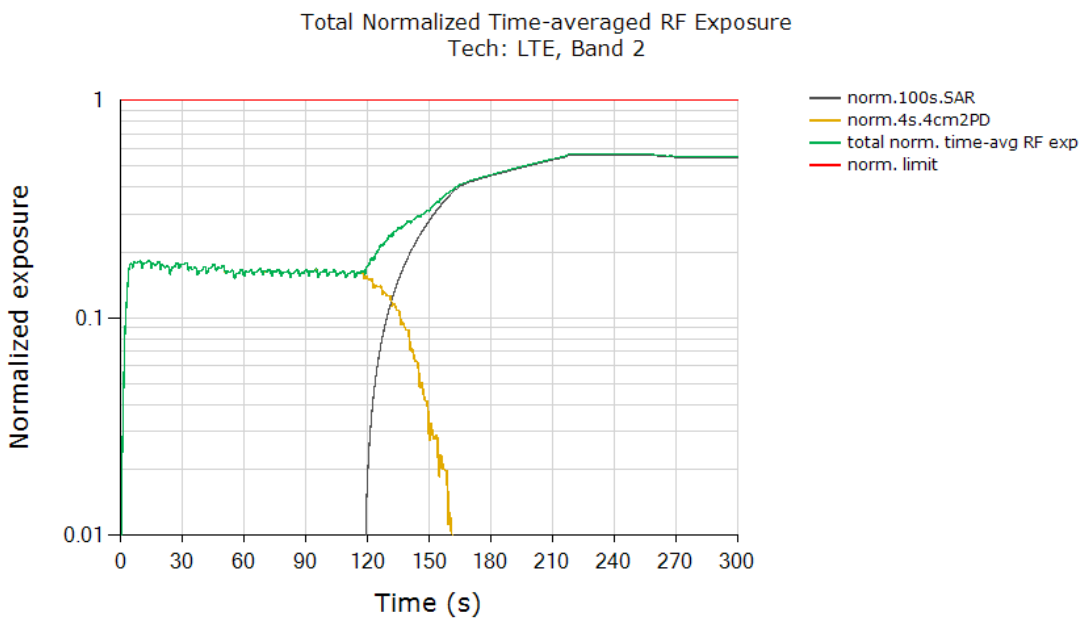
13.1.2 PD test results for n260

Step 2.e plot (in Section 5.4) for normalized instantaneous and time-averaged exposures for LTE and mmW n260 beam 44



FCC limit for total RF exposure	1.0
Max total normalized time-averaged RF exposure (green curve)	0.564
Validated	

Plot notes: LTE was placed in all-down bits immediately after 5G mmW NR call was established. Between 0s~120s, mmW exposure is the dominant contributor. Here, Smart Transmit feature allocates a maximum of 75% for mmW (based on the 3dB reserve setting in Part 1 report). From Table 12-3, this corresponds to a normalized 4cm^{2}PD exposure value for Beam ID 44 of (75% * 3.35 W/m^2)/(10 W/m^2) = 25.1% ± 2.1dB device related uncertainty (see orange/green curve between 0s~120s). Around 120s time mark, LTE is set to all-up bits, taking away margin from mmW exposure gradually. Towards the end of the test, LTE is the dominant contributor towards RF exposure, i.e., corresponding normalized 1gSAR exposure value of (100% * 0.771 W/kg)/(1.6 W/kg) = 48.2% ± 1dB design related uncertainty (see black curves approaching this level towards end of the test).

As can be seen, the power limiting enforcement is effective and the total normalized time-averaged RF exposure does not exceed 1.0. Therefore, Qualcomm® Smart Transmit time averaging feature is validated.

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14 EQUIPMENT LIST

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
Agilent	8594A	(9kHz-2.9GHz) Spectrum Analyzer	N/A	N/A	N/A	3051A00187
Agilent	E4438C	ESG Vector Signal Generator	3/8/2019	Biennial	3/8/2021	MY42082385
Agilent	N9020A	MXA Signal Analyzer	12/19/2019	Annual	12/19/2020	MY48010233
Agilent	N5182A	MXG Vector Signal Generator	8/19/2019	Annual	8/19/2020	MY47420837
Agilent	8753ES	S-Parameter Network Analyzer	12/31/2019	Annual	12/31/2020	US39170122
Agilent	N5182A	MXG Vector Signal Generator	5/13/2020	Annual	5/13/2021	MY47420603
Agilent	E4438C	ESG Vector Signal Generator	3/8/2019	Biennial	3/8/2021	MY42082385
Agilent	E4438C	ESG Vector Signal Generator	3/11/2019	Biennial	3/11/2021	MY45090700
Agilent	8753ES	S-Parameter Network Analyzer	1/16/2020	Annual	1/16/2021	US39170118
Agilent	8753ES	S-Parameter Network Analyzer	8/26/2019	Annual	8/26/2020	MY40000670
Agilent	8753ES	S-Parameter Vector Network Analyzer	9/19/2019	Annual	9/19/2020	MY40003841
Amplifier Research	15S1G6	Amplifier	CBT	N/A	CBT	433972
Amplifier Research	15S1G6	Amplifier	CBT	N/A	CBT	433974
Anritsu	ML2495A	Power Meter	12/17/2019	Annual	12/17/2020	941001
Anritsu	MA24106A	USB Power Sensor	2/27/2020	Annual	2/27/2021	1520501
Anritsu	MA24106A	USB Power Sensor	2/27/2020	Annual	2/27/2021	1520503
Anritsu	ML2496A	Power Meter	12/17/2019	Annual	12/17/2020	1138001
Anritsu	MA2411B	Pulse Power Sensor	12/4/2019	Annual	12/4/2020	0846215
Anritsu	MA2411B	Pulse Power Sensor	12/4/2019	Annual	12/4/2020	1126066
COMTECH	AR85729-5/5759B	Solid State Amplifier	CBT	N/A	CBT	M3W1A00-1002
COMTech	AR85729-5	Solid State Amplifier	CBT	N/A	CBT	M1S5A00-009
Control Company	4352	Ultra Long Stem Thermometer	8/2/2018	Biennial	8/2/2020	181292061
Control Company	4040	Therm./ Clock/ Humidity Monitor	10/9/2018	Biennial	10/9/2020	181647811
Control Company	4352	Long Stem Thermometer	6/26/2019	Biennial	6/26/2021	192282753
K & L	11SH10-1300/U4000	High Pass Filter	N/A	N/A	N/A	11SH10-1300/U4000 - 2
Keysight Technologies	772D	Dual Directional Coupler	CBT	N/A	CBT	MY52180215
Keysight Technologies	E7515B	UXM 5G Wireless Test Platform	6/11/2019	Annual	12/11/2020	MY59150289
Keysight Technologies	M1740A	mmWave Transceiver	5/7/2019	Annual	11/7/2020	MY58481076
Keysight Technologies	M1740A	mmWave Transceiver	5/7/2019	Annual	11/7/2020	MY58481133
Keysight Technologies	E7770A	Common Interface Unit	4/29/2019	Annual	10/29/2020	MY58290483
Krytar	110067006	Directional Coupler, 10 - 67 GHz	N/A	N/A	N/A	200391
MCL	BW-N6W5+	6dB Attenuator	CBT	N/A	CBT	1139
Mini Circuits	ZA2PD2-63-S+	Power Splitter	CBT	N/A	CBT	SUU64901930
Mini Circuits	ZAPD-2-272-S+	Power Splitter	CBT	N/A	CBT	SF702001405
MIniCircuits	NLP-1200+	Low Pass Filter	N/A	N/A	N/A	VUU78201318
MiniCircuits	SLP-2400+	Low Pass Filter	CBT	N/A	CBT	R8979500903
MiniCircuits	VLF-6000+	Low Pass Filter	CBT	N/A	CBT	N/A
Mini-Circuits	BW-N20W5+	DC to 18 GHz Precision Fixed 20 dB Attenuator	CBT	N/A	CBT	N/A
Mini-Circuits	NLP-2950+	Low Pass Filter DC to 2700 MHz	CBT	N/A	CBT	N/A
Mini-Circuits	NLP-1200+	Low Pass Filter DC to 1000 MHz	CBT	N/A	CBT	N/A
Mini-Circuits	BW-N20W5	Power Attenuator	CBT	N/A	CBT	1226
Narda	4216-10	Directional Coupler, 0.5 to 8.0 GHz, 10 dB	5/16/2019	Annual	11/16/2020	01492
Narda	4216-10	Directional Coupler, 0.5 to 8.0 GHz, 10 dB	5/16/2019	Annual	11/16/2020	01493
Narda	4772-3	Attenuator	CBT	N/A	CBT	9406
Narda	BW-S3W2	Attenuator	CBT	N/A	CBT	120
Narda	BW-S10W2+	Attenuator	CBT	N/A	CBT	831
Narda	4014C-6	4 - 8 GHz SMA 6 dB Directional Coupler	CBT	N/A	CBT	N/A
Newmark System	NSC-G2	Motion Controller	CBT	N/A	CBT	1007-D
Pasternack	PE2208-6	Bidirectional Coupler	CBT	N/A	CBT	N/A
Pasternack	PE2209-10	Bidirectional Coupler	CBT	N/A	CBT	N/A
Ramsey Electronics, LLC	STE6300	Shielded Test Enclosure	N/A	N/A	N/A	1310
Rohde & Schwarz	CMW500	Radio Communication Tester	8/26/2019	Annual	8/26/2020	100976
Rohde & Schwarz	NRP8S	3-Path Dipole Power Sensor	6/1/2019	Annual	12/1/2020	108168
Rohde & Schwarz	NRP8S	3-Path Dipole Power Sensor	6/1/2019	Annual	12/1/2020	108523
Rohde & Schwarz	NRP8S	3-Path Dipole Power Sensor	6/10/2020	Annual	6/10/2021	109322
Rohde & Schwarz	NRP50S	3-Path Dipole Power Sensor	6/1/2019	Annual	12/1/2020	101164
SPEAG	5G Verification Source 30GHz	30GHz System Verification Antenna	2/12/2020	Annual	2/12/2021	1035
SPEAG	EUmmWV3	E-field Probe	2/14/2020	Annual	2/14/2021	9415
SPEAG	DAE4	Dasy Data Acquisition Electronics	3/12/2020	Annual	3/12/2021	1415

Notes:

1. CBT (Calibrated Before Testing). Prior to testing, the measurement paths containing a cable, amplifier, attenuator, coupler or filter were connected to a calibrated source (i.e. a signal generator) to determine the losses of the measurement path. The power meter offset was then adjusted to compensate for the measurement system losses. This level offset is stored within the power meter before measurements are made. This calibration verification procedure applies to the system verification and output power measurements. The calibrated reading is then taken directly from the power meter after compensation of the losses for all final power measurements.
2. Each equipment item is used solely within its respective calibration period.
3. Due to the worldwide pandemic caused by the novel SAR-CoV-2 virus (COVID-19), special calibration extensions have been permitted by A2LA. Some equipment had its calibration period extended accordingly and will be calibrated when possible.

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15 MEASUREMENT UNCERTAINTIES

For PD Measurements

a	b	c	d	e	f = b x e/d	g
Uncertainty Component	Unc. (± dB)	Prob. Dist.	Div.	ci	ui (± dB)	vi
Calibration	0.49	N	1	1.0	0.49	∞
Probe correction	0	R	1.73	1.0	0.00	∞
Frequency Response (BW ≤ 1 GHz)	0.20	R	1.73	1.0	0.12	∞
Sensor cross coupling	0	R	1.73	1.0	0.00	∞
Isotropy	0.50	R	1.73	1.0	0.29	∞
Linearity	0.20	R	1.73	1.0	0.12	∞
Probe Scattering	0	R	1.73	1.0	0	∞
Probe Positioning Offset	0.30	R	1.73	1.0	0.17	∞
Probe Positioning Repeatability	0.04	R	1.73	1.0	0.02	∞
Sensor Mechanical Offset	0	R	1.73	1.0	0	∞
Probe Spatial Resolution	0	R	1.73	1.0	0	∞
Field Impedance Dependence	0	R	1.73	1.0	0	∞
Amplitude and phase drift	0	R	1.73	1.0	0	∞
Amplitude and phase noise	0.04	R	1.73	1.0	0.02	∞
Measurement area truncation	0	R	1.73	1.0	0	∞
Data acquisition	0.03	N	1	1.0	0.03	∞
Sampling	0	R	1.73	1.0	0	∞
Field Reconstruction	0.60	R	1.73	1.0	0.35	∞
Forward Transformation	0	R	1.73	1.0	0	∞
Power Density Scaling	-	R	1.73	1.0	-	∞
Spatial Averaging	0.10	R	1.73	1.0	0.06	∞
System Detection Limit	0.04	R	1.73	1.0	0.02	∞
Test Sample and Environmental Factors						
Probe Coupling with DUT	0	R	1.73	1.0	0	∞
Modulation Response	0.40	R	1.73	1.0	0.23	∞
Integration Time	0	R	1.73	1.0	0	∞
Response Time	0	R	1.73	1.0	0	∞
Device Holder Influence	0.10	R	1.73	1.0	0.06	∞
DUT Alignment	0	R	1.73	1.0	0	∞
RF Ambient Conditions	0.04	R	1.73	1.0	0.02	∞
Ambient Reflections	0.04	R	1.73	1.0	0.02	∞
Immunity / Secondary Reception	0	R	1.73	1.0	0	∞
Drift of the DUT	0.22	R	1.73	1.0	0.13	∞
Combined Standard Uncertainty (k=1)		RSS			0.76	∞
(95% CONFIDENCE LEVEL)		**k=2**			**1.53**	

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16 CONCLUSION

16.1 Measurement Conclusion

The SAR evaluation indicates that the DUT complies with the RF radiation exposure limits of the FCC and Innovation, Science, and Economic Development Canada, with respect to all parameters subject to this test. These measurements were taken to simulate the RF effects of RF exposure under worst-case conditions. Precise laboratory measures were taken to assure repeatability of the tests. The results and statements relate only to the item(s) tested.

Please note that the absorption and distribution of electromagnetic energy in the body are very complex phenomena that depend on the mass, shape, and size of the body, the orientation of the body with respect to the field vectors, and the electrical properties of both the body and the environment. Other variables that may play a substantial role in possible biological effects are those that characterize the environment (e.g. ambient temperature, air velocity, relative humidity, and body insulation) and those that characterize the individual (e.g. age, gender, activity level, debilitation, or disease). Because various factors may interact with one another to vary the specific biological outcome of an exposure to electromagnetic fields, any protection guide should consider maximal amplification of biological effects as a result of field-body interactions, environmental conditions, and physiological variables. [3]

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APPENDIX A: VERIFICATION PLOTS

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Date: 09/03/2020

30 GHz System Verification

Device Under Test Properties

DUT	Serial Number
30 GHz Verification Source	1035

Exposure Conditions

Phantom Section	Position	Test Distance [mm]	Band	Frequency [MHz]
5G	FRONT	5.55	Validation band	30000.0

Hardware Setup

Probe, Calibration Date	DAE, Calibration Date
EUmmWV3 - SN9415, 02/14/2020	DAE4 SN1415, 03/12/2020

Software Setup

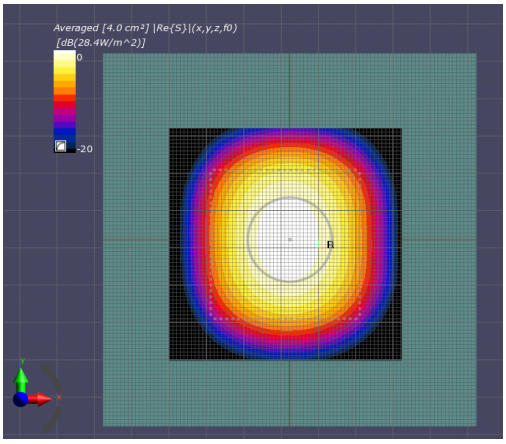
Software	Software Version
cDASY6 Module mmWave	2.0.2.34

Scans Setup

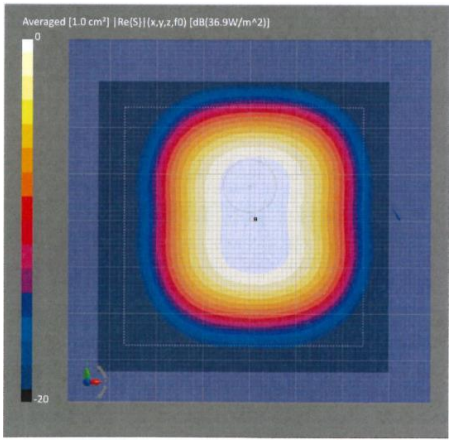
Scan Type	5G Scan
Grid Extents [mm]	60.0 x 60.0
Grid Steps [lambda]	0.25 x 0.25
Sensor Surface [mm]	5.55

Measurement Results

Scan Type	5G Scan
Avg. Area [cm²]	4.00
pS_{tot} avg [W/m²]	28.4
pS_n avg [W/m²]	28.0
E_{peak} [V/m]	123
Deviation (dB)	-0.59



30GHz System Verification



Calibration Certificate

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Date: 09/08/2020

30 GHz System Verification

Device Under Test Properties

DUT	Serial Number
30 GHz Verification Source	1035

Exposure Conditions

Phantom Section	Position	Test Distance [mm]	Band	Frequency [MHz]
5G	FRONT	5.55	Validation band	30000.0

Hardware Setup

Probe, Calibration Date	DAE, Calibration Date
EUmmWV3 - SN9415, 02/14/2020	DAE4 SN1415, 03/12/2020

Software Setup

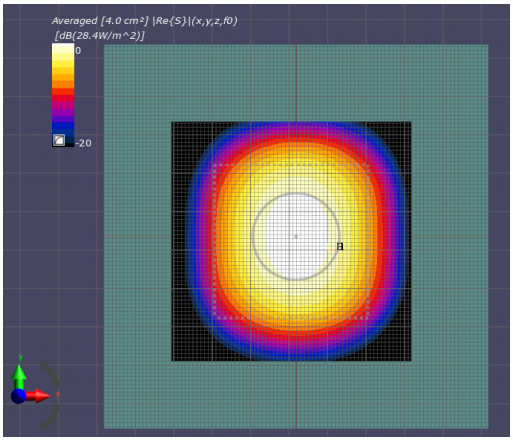
Software	Software Version
cDASY6 Module mmWave	2.0.2.34

Scans Setup

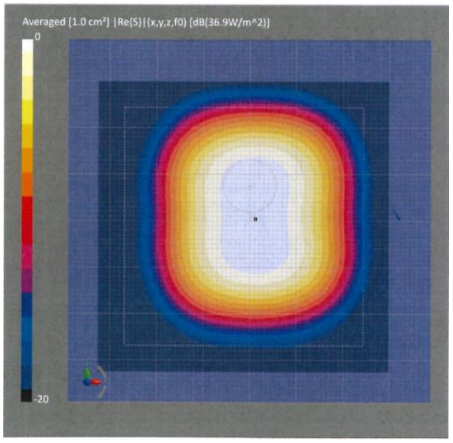
Scan Type	5G Scan
Grid Extents [mm]	60.0 x 60.0
Grid Steps [lambda]	0.25 x 0.25
Sensor Surface [mm]	5.55

Measurement Results

Scan Type	5G Scan
Avg. Area [cm²]	4.00
pS_{tot} avg [W/m²]	28.4
pS_n avg [W/m²]	28.0
E_{peak} [V/m]	123
Deviation (dB)	-0.59



30GHz System Verification



Calibration Certificate

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APPENDIX C: TEST SEQUENCES

1. Test sequence is generated based on below parameters of the DUT:
   a. Measured maximum power (P_{max})
   b. Measured Tx_power_at_SAR_design_target (P_{limit})
   c. Reserve_power_margin (dB)
      - $P_{reserve}$ (dBm) = measured P_{limit} (dBm) – Reserve_power_margin (dB)
   d. *SAR_time_window* (100s for FCC)
2. Test Sequence 1 Waveform:

   Based on the parameters above, the Test Sequence 1 is generated with one transition between high and low Tx powers. Here, high power = P_{max}; low power = $P_{max}/2$, and the transition occurs after 80 seconds at high power P_{max}. As long as the power enforcement is taking into effective during one 100s/60s time window, the validation test with this defined test sequence 1 is valid, otherwise, select other radio configuration (band/DSI within the same technology group) having lower P_{limit} for this test. The Test sequence 1 waveform is shown below:

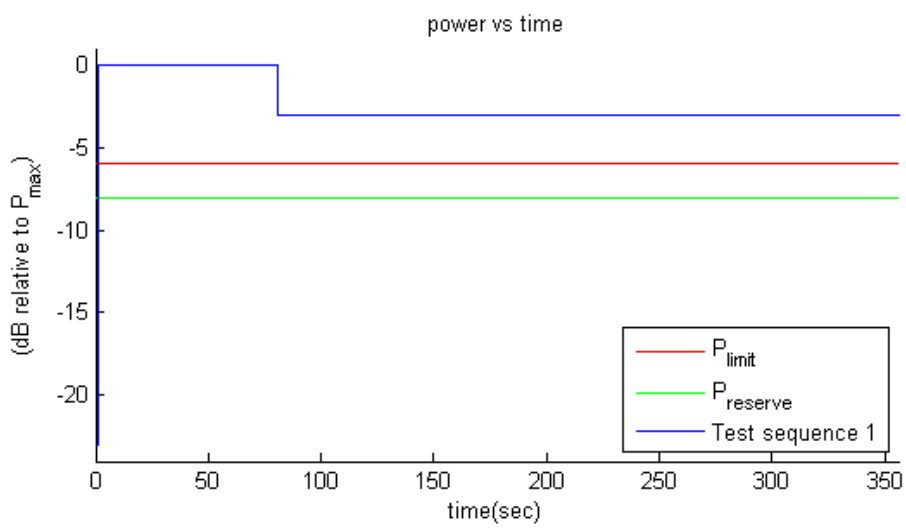

Figure C-1
Test sequence 1 waveform

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3. Test Sequence 2 Waveform:

Based on the parameters described above, the Test Sequence 2 is generated as described in Table 10-1, which contains two 170 second-long sequences (yellow and green highlighted rows) that are mirrored around the center row of 20s, resulting in a total duration of 360 seconds:

Table C-1
Test Sequence 2

Time duration (seconds)	dB relative to P_{limit} or $P_{reserve}$
15	$P_{reserve} - 2$
20	P_{limit}
20	$(P_{limit} + P_{max})/2$ averaged in mW and rounded to nearest 0.1 dB step
10	$P_{reserve} - 6$
20	P_{max}
15	P_{limit}
15	$P_{reserve} - 5$
20	P_{max}
10	$P_{reserve} - 3$
15	P_{limit}
10	$P_{reserve} - 4$
20	$(P_{limit} + P_{max})/2$ averaged in mW and rounded to nearest 0.1 dB step
10	$P_{reserve} - 4$
15	P_{limit}
10	$P_{reserve} - 3$
20	P_{max}
15	$P_{reserve} - 5$
15	P_{limit}
20	P_{max}
10	$P_{reserve} - 6$
20	$(P_{limit} + P_{max})/2$ averaged in mW and rounded to nearest 0.1 dB step
20	P_{limit}
15	$P_{reserve} - 2$

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The Test Sequence 2 waveform is shown in Figure C-2.

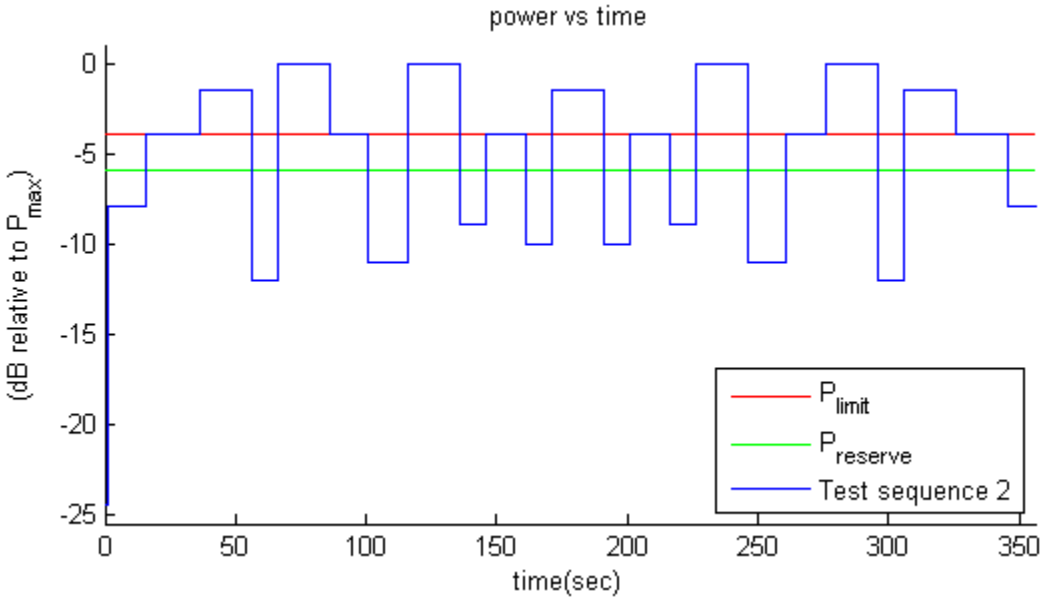

Figure C-2
Test sequence 2 waveform

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APPENDIX D: TEST PROCEDURES FOR SUB6 NR + NR RADIO

Appendix D provides the test procedures for validating Qualcomm Smart Transmit feature for LTE + Sub6 NR non-standalone (NSA) mode transmission scenario, where sub-6GHz LTE link acts as an anchor.

D.1 Time-varying Tx power test for sub6 NR in NSA mode

Follows Section 4.2.1 to select test configurations for time-varying test. This test is performed with two pre-defined test sequences (described in Section 4.1) applied to Sub6 NR (with LTE on all-down bits or low power for the entire test after establishing the LTE+Sub6 NR call with the callbox). Follow the test procedures described in Section 4.3.1 to demonstrate the effectiveness of power limiting enforcement and that the time averaged Tx power of Sub6 NR when converted into 1gSAR values does not exceed the regulatory limit at all times (see Eq. (1a) and (1b)). Sub6 NR response to test sequence1 and test sequence2 will be similar to other technologies (say, LTE), and are shown in Section 9.1.5.

D.2 Switch in SAR exposure between LTE vs. Sub6 NR during transmission

This test is to demonstrate that Smart Transmit feature accurately accounts for switching in exposures among SAR for LTE radio only, SAR from both LTE radio and sub6 NR, and SAR from sub6 NR only scenarios, and ensures total time-averaged RF exposure compliance with FCC limit.

Test procedure:

1. Measure conducted Tx power corresponding to P_{limit} for LTE and sub6 NR in selected band. Test condition to measure conducted P_{limit} is:
    a. Establish device in call with the callbox for LTE in desired band. Measure conducted Tx power corresponding to LTE P_{limit} with Smart Transmit <u>enabled</u> and *Reserve_power_margin* set to 0 dB, callbox set to request maximum power.
    b. Repeat above step to measure conducted Tx power corresponding to Sub6 NR $\underline{P_{limit}}$. If testing LTE+Sub6 NR in non-standalone mode, then establish LTE+Sub6 NR call with callbox and request all down bits for radio1 LTE. In this scenario, with callbox requesting maximum power from Sub6 NR, measured conducted Tx power corresponds to radio2 $\underline{P_{limit}}$ (as radio1 LTE is at all-down bits)
2. Set *Reserve_power_margin* to actual (intended) value with EUT setup for LTE + Sub6 NR call. First, establish LTE connection in all-up bits with the callbox, and then Sub6 NR connection is added with callbox requesting UE to transmit at maximum power in Sub6 NR. As soon as the Sub6 NR connection is established, request all-down bits on LTE link (otherwise, Sub6 NR will not have sufficient RF exposure margin to sustain the call with LTE in all-up bits). Continue LTE (all-down bits)+Sub6 NR transmission for more than one time-window duration to test predominantly Sub6 NR SAR exposure scenario (as SAR exposure is negligible from all-down bits in LTE). After at least one time-window, request LTE to go all-up bits to test LTE SAR

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and Sub6 NR SAR exposure scenario. After at least one more time-window, drop (or request all-down bits) Sub6 NR transmission to test predominantly LTE SAR exposure scenario. Continue the test for at least one more time-window. Record the conducted Tx powers for both LTE and Sub6 NR for the entire duration of this test.

3. Once the measurement is done, extract instantaneous Tx power versus time for both LTE and Sub6 NR links. Similar to technology/band switch test in Section 4.3.3, convert the conducted Tx power for both these radios into 1gSAR value (see Eq. (6a) and (6b)) using corresponding technology/band P_{limit} measured in Step 1, and then perform 100s running average to determine time-averaged 1gSAR versus time as illustrated in Figure 4-1. Note that here it is assumed both radios have Tx frequencies < 3GHz, otherwise, 60s running average should be performed for radios having Tx frequency between 3GHz and 6GHz.
4. Make one plot containing: (a) instantaneous Tx power versus time measured in Step 2.
5. Make another plot containing: (a) instantaneous 1gSAR versus time determined in Step 3, (b) computed time-averaged 1gSAR versus time determined in Step 3, and (c) corresponding regulatory $1gSAR_{limit}$ of 1.6W/kg.

The validation criteria is, at all times, the time-averaged 1gSAR versus time shall not exceed the regulatory $1gSAR_{limit}$ of 1.6W/kg.

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APPENDIX E: CALIBRATION CERTIFICATES

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland

S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 0108

Client **PC Test**

Certificate No: EUmmWV3-9415_Feb20

CALIBRATION CERTIFICATE

Object	EUmmWV3 - SN:9415
Calibration procedure(s)	QA CAL-02.v9, QA CAL-25.v7, QA CAL-42.v2 Calibration procedure for E-field probes optimized for close near field evaluations in air
Calibration date:	February 14, 2020

MAB 4/8/20

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP	SN: 104778	03-Apr-19 (No. 217-02892/02893)	Apr-20
Power sensor NRP-Z91	SN: 103244	03-Apr-19 (No. 217-02892)	Apr-20
Power sensor NRP-Z91	SN: 103245	03-Apr-19 (No. 217-02893)	Apr-20
Reference 20 dB Attenuator	SN: S5277 (20x)	04-Apr-19 (No. 217-02894)	Apr-20
Reference Probe ER3DV6	SN: 2328	05-Oct-19 (No. ER3-2328_Oct19)	Oct-20
DAE4	SN: 789	27-Dec-19 (No. DAE4-789_Dec19)	Dec-20
Secondary Standards	ID	Check Date (in house)	Scheduled Check
Power meter E4419B	SN: GB41293874	06-Apr-16 (in house check Jun-18)	In house check: Jun-20
Power sensor E4412A	SN: MY41498087	06-Apr-16 (in house check Jun-18)	In house check: Jun-20
Power sensor E4412A	SN: 000110210	06-Apr-16 (in house check Jun-18)	In house check: Jun-20
RF generator HP 8648C	SN: US3642U01700	04-Aug-99 (in house check Jun-18)	In house check: Jun-20
Network Analyzer HP 8753E	SN: US37390585	18-Oct-01 (in house check Oct-19)	In house check: Oct-20

	Name	Function	Signature
Calibrated by:	Jeton Kastrati	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	

Issued: February 15, 2020

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Glossary:

NORMx,y,z	sensitivity in free space
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C, D	modulation dependent linearization parameters
Polarization φ	φ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., ϑ = 0 is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system
Sensor Angles	sensor deviation from the probe axis, used to calculate the field orientation and polarization
k	is the wave propagation direction

Calibration is Performed According to the Following Standards:

a) IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005

Methods Applied and Interpretation of Parameters:

- *NORMx,y,z:* Assessed for E-field polarization ϑ = 0 for XY sensors and ϑ = 90 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide). For frequencies > 6 GHz, the far field in front of waveguide horn antennas is measured for a set of frequencies in various waveguide bands up to 110 GHz.
- *DCPx,y,z:* DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- *PAR:* PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- The frequency sensor model parameters are determined prior to calibration based on a frequency sweep (sensor model involving resistors R, R_p, inductance L and capacitors C, C_p).
- *Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z: A, B, C, D* are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. *VR* is the maximum calibration range expressed in RMS voltage across the diode.
- *Sensor Offset*: The sensor offset corresponds to the mechanical from the probe tip (on probe axis). No tolerance required.
- *Connector Angle*: The angle is assessed using the information gained by determining the *NORMx* (no uncertainty required).
- *Equivalent Sensor Angle*: The two probe sensors are mounted in the same plane at different angles. The angles are assessed using the information gained by determining the *NORMx* (no uncertainty required).
- *Spherical isotropy (3D deviation from isotropy)*: in a locally homogeneous field realized using an open waveguide / horn setup.

DASY - Parameters of Probe: EUmmWV3 - SN:9415

Basic Calibration Parameters

	Sensor X	Sensor Y	Unc (k=2)
Norm ($\mu V/(V/m)^2$)	0.02252	0.02610	± 10.1 %
DCP (mV)[B]	100.0	113.0	
Equivalent Sensor Angle	-60.2	34.7	

Calibration results for Frequency Response (750 MHz – 110 GHz)

Frequency GHz	Target E-Field V/m	Deviation Sensor X dB	Deviation Sensor Y dB	Unc (k=2) dB
0.75	77.2	0.01	0.12	± 0.43 dB
1.8	140.4	0.09	0.12	± 0.43 dB
2	133.0	0.04	0.07	± 0.43 dB
2.2	124.8	0.04	0.04	± 0.43 dB
2.5	123.0	-0.06	-0.08	± 0.43 dB
3.5	256.2	0.07	-0.02	± 0.43 dB
3.7	249.8	0.12	0.04	± 0.43 dB
6.6	41.8	0.57	0.29	± 0.98 dB
8	48.4	0.12	-0.21	± 0.98 dB
10	54.4	-0.05	-0.01	± 0.98 dB
15	71.5	-0.13	-0.31	± 0.98 dB
18	85.3	0.03	0.23	± 0.98 dB
26.6	96.9	-0.04	0.11	± 0.98 dB
30	92.6	0.12	0.12	± 0.98 dB
35	93.7	-0.40	-0.14	± 0.98 dB
40	91.5	-0.48	-0.49	± 0.98 dB
50	19.6	-0.21	-0.42	± 0.98 dB
55	22.4	0.75	0.21	± 0.98 dB
60	23.0	0.02	-0.01	± 0.98 dB
65	27.4	-0.31	0.05	± 0.98 dB
70	23.9	0.13	0.07	± 0.98 dB
75	20.0	-0.07	0.07	± 0.98 dB
75	14.8	-0.06	-0.08	± 0.98 dB
80	22.5	0.04	0.18	± 0.98 dB
85	22.8	0.01	-0.05	± 0.98 dB
90	23.8	0.03	0.06	± 0.98 dB
92	23.9	-0.09	-0.16	± 0.98 dB
95	20.5	-0.10	-0.17	± 0.98 dB
97	24.4	0.02	-0.07	± 0.98 dB
100	22.6	-0.04	-0.04	± 0.98 dB
105	22.7	-0.08	0.00	± 0.98 dB
110	19.7	0.14	0.14	± 0.98 dB

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

[B] Numerical linearization parameter: uncertainty not required.

[E] Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

DASY - Parameters of Probe: EUmmWV3 - SN:9415

Calibration Results for Modulation Response

UID	Communication System Name		A dB	B dB√μV	C	D dB	VR mV	Max dev.	Max Unc[E] (k=2)
0	CW	X	0.00	0.00	1.00	0.00	110.9	± 3.8 %	± 4.7 %
		Y	0.00	0.00	1.00		95.6		
10352-AAA	Pulse Waveform (200Hz, 10%)	X	2.49	60.00	13.67	10.00	6.0	± 1.2 %	± 9.6 %
		Y	2.06	60.00	14.31		6.0		
10353-AAA	Pulse Waveform (200Hz, 20%)	X	1.63	60.00	12.61	6.99	12.0	± 0.8 %	± 9.6 %
		Y	1.36	60.00	13.35		12.0		
10354-AAA	Pulse Waveform (200Hz, 40%)	X	0.92	60.00	11.37	3.98	23.0	± 0.9 %	± 9.6 %
		Y	0.79	60.00	12.22		23.0		
10355-AAA	Pulse Waveform (200Hz, 60%)	X	0.56	60.00	10.42	2.22	27.0	± 0.8 %	± 9.6 %
		Y	0.50	60.00	11.35		27.0		
10387-AAA	QPSK Waveform, 1 MHz	X	1.00	60.00	11.30	1.00	22.0	± 2.1 %	± 9.6 %
		Y	0.99	60.00	11.63		22.0		
10388-AAA	QPSK Waveform, 10 MHz	X	1.26	60.00	11.64	0.00	22.0	± 0.7 %	± 9.6 %
		Y	1.22	60.00	11.83		22.0		
10396-AAA	64-QAM Waveform, 100 kHz	X	2.61	62.98	15.02	3.01	17.0	± 0.6 %	± 9.6 %
		Y	2.18	61.08	14.03		17.0		
10399-AAA	64-QAM Waveform, 40 MHz	X	2.12	60.00	12.25	0.00	19.0	± 0.7 %	± 9.6 %
		Y	2.00	60.00	12.36		19.0		
10414-AAA	WLAN CCDF, 64-QAM, 40MHz	X	3.22	60.00	12.72	0.00	12.0	± 0.9 %	± 9.6 %
		Y	3.01	60.00	12.79		12.0		

Note: For details on all calibrated UID parameters see Appendix

Calibration Results for Linearity Response

Frequency GHz	Target E-Field V/m	Deviation Sensor X dB	Deviation Sensor Y dB	Unc (k=2) dB
0.9	50.0	-0.14	-0.14	± 0.2 dB
0.9	100.0	-0.11	-0.02	± 0.2 dB
0.9	500.0	0.02	0.01	± 0.2 dB
0.9	1000.0	0.05	0.03	± 0.2 dB
0.9	1500.0	0.04	0.03	± 0.2 dB
0.9	2000.0	0.00	0.01	± 0.2 dB

Sensor Frequency Model Parameters (750 MHz – 78 GHz)

	Sensor X	Sensor Y
R (Ω)	41.29	47.24
R_p (Ω)	94.83	89.63
L (nH)	0.03642	0.04028
C (pF)	0.2073	0.2715
C_p (pF)	0.1227	0.1167

Sensor Frequency Model Parameters (55 GHz – 110 GHz)

	Sensor X	Sensor Y
R (Ω)	29.45	32.76
R_p (Ω)	99.11	94.92
L (nH)	0.03900	0.03350
C (pF)	0.1315	0.1918
C_p (pF)	0.1283	0.1320

DASY - Parameters of Probe: EUmmWV3 - SN:9415

Sensor Model Parameters

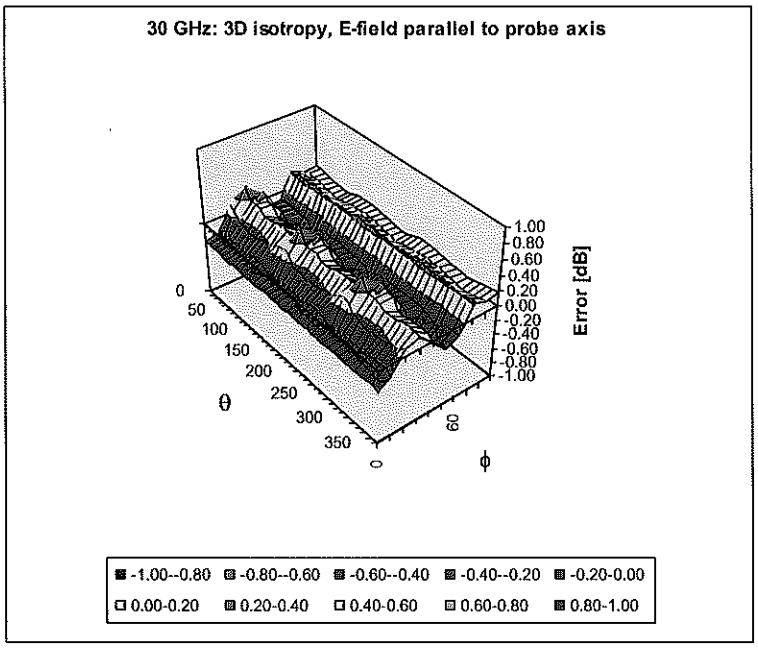
	C1 fF	C2 fF	α V^{-1}	T1 $ms.V^{-2}$	T2 $ms.V^{-1}$	T3 ms	T4 V^{-2}	T5 V^{-1}	T6
X	34.6	259.81	35.60	0.92	5.09	4.98	0.00	1.54	1.01
Y	34.5	242.14	31.75	0.92	4.21	5.00	0.00	1.45	1.01

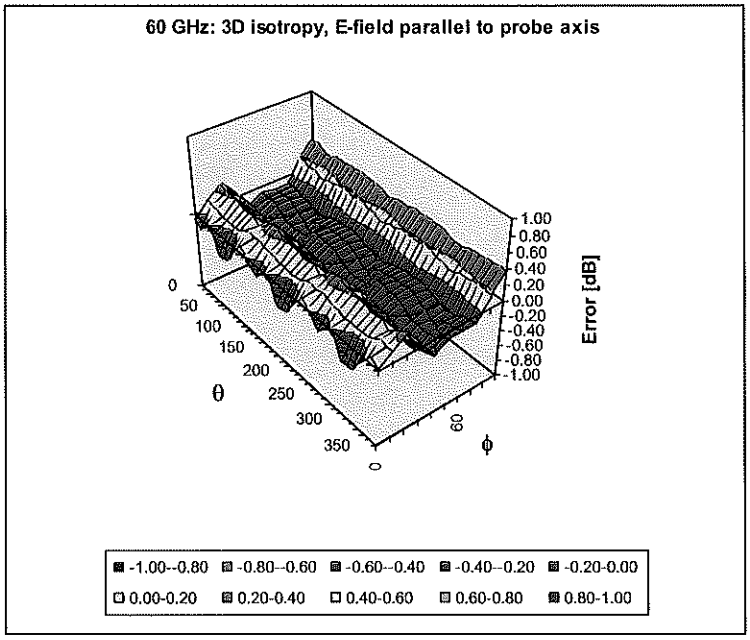
Other Probe Parameters

Sensor Arrangement	Rectangular
Connector Angle (°)	185.2
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	320 mm
Probe Body Diameter	8 mm
Tip Length	23 mm
Tip Diameter	8.0 mm
Probe Tip to Sensor X Calibration Point	1.5 mm
Probe Tip to Sensor Y Calibration Point	1.5 mm

Deviation from Isotropy in Air

f = 30, 60 GHz





Probe isotropy for E_{tot}: probe rotated φ = 0° to 360°, tilted from field propagation direction $\vec{k}$
Parallel to the field propagation (ψ =0° - 90°) at 30 GHz: deviation within ± 0.34 dB
Parallel to the field propagation (ψ =0° - 90°) at 60 GHz: deviation within ± 0.37 dB

Appendix: Modulation Calibration Parameters

UID	Rev	Communication System Name	Group	PAR (dB)	Unc[E] (k=2)
0		CW	CW	0.00	± 4.7 %
10010	CAA	SAR Validation (Square, 100ms, 10ms)	Test	10.00	± 9.6 %
10011	CAB	UMTS-FDD (WCDMA)	WCDMA	2.91	± 9.6 %
10012	CAB	IEEE 802.11b WiFi 2.4 GHz (DSSS, 1 Mbps)	WLAN	1.87	± 9.6 %
10013	CAB	IEEE 802.11g WiFi 2.4 GHz (DSSS-OFDM, 6 Mbps)	WLAN	9.46	± 9.6 %
10021	DAC	GSM-FDD (TDMA, GMSK)	GSM	9.39	± 9.6 %
10023	DAC	GPRS-FDD (TDMA, GMSK, TN 0)	GSM	9.57	± 9.6 %
10024	DAC	GPRS-FDD (TDMA, GMSK, TN 0-1)	GSM	6.56	± 9.6 %
10025	DAC	EDGE-FDD (TDMA, 8PSK, TN 0)	GSM	12.62	± 9.6 %
10026	DAC	EDGE-FDD (TDMA, 8PSK, TN 0-1)	GSM	9.55	± 9.6 %
10027	DAC	GPRS-FDD (TDMA, GMSK, TN 0-1-2)	GSM	4.80	± 9.6 %
10028	DAC	GPRS-FDD (TDMA, GMSK, TN 0-1-2-3)	GSM	3.55	± 9.6 %
10029	DAC	EDGE-FDD (TDMA, 8PSK, TN 0-1-2)	GSM	7.78	± 9.6 %
10030	CAA	IEEE 802.15.1 Bluetooth (GFSK, DH1)	Bluetooth	5.30	± 9.6 %
10031	CAA	IEEE 802.15.1 Bluetooth (GFSK, DH3)	Bluetooth	1.87	± 9.6 %
10032	CAA	IEEE 802.15.1 Bluetooth (GFSK, DH5)	Bluetooth	1.16	± 9.6 %
10033	CAA	IEEE 802.15.1 Bluetooth (PI/4-DQPSK, DH1)	Bluetooth	7.74	± 9.6 %
10034	CAA	IEEE 802.15.1 Bluetooth (PI/4-DQPSK, DH3)	Bluetooth	4.53	± 9.6 %
10035	CAA	IEEE 802.15.1 Bluetooth (PI/4-DQPSK, DH5)	Bluetooth	3.83	± 9.6 %
10036	CAA	IEEE 802.15.1 Bluetooth (8-DPSK, DH1)	Bluetooth	8.01	± 9.6 %
10037	CAA	IEEE 802.15.1 Bluetooth (8-DPSK, DH3)	Bluetooth	4.77	± 9.6 %
10038	CAA	IEEE 802.15.1 Bluetooth (8-DPSK, DH5)	Bluetooth	4.10	± 9.6 %
10039	CAB	CDMA2000 (1xRTT, RC1)	CDMA2000	4.57	± 9.6 %
10042	CAB	IS-54 / IS-136 FDD (TDMA/FDM, PI/4-DQPSK, Halfrate)	AMPS	7.78	± 9.6 %
10044	CAA	IS-91/EIA/TIA-553 FDD (FDMA, FM)	AMPS	0.00	± 9.6 %
10048	CAA	DECT (TDD, TDMA/FDM, GFSK, Full Slot, 24)	DECT	13.80	± 9.6 %
10049	CAA	DECT (TDD, TDMA/FDM, GFSK, Double Slot, 12)	DECT	10.79	± 9.6 %
10056	CAA	UMTS-TDD (TD-SCDMA, 1.28 Mcps)	TD-SCDMA	11.01	± 9.6 %
10058	DAC	EDGE-FDD (TDMA, 8PSK, TN 0-1-2-3)	GSM	6.52	± 9.6 %
10059	CAB	IEEE 802.11b WiFi 2.4 GHz (DSSS, 2 Mbps)	WLAN	2.12	± 9.6 %
10060	CAB	IEEE 802.11b WiFi 2.4 GHz (DSSS, 5.5 Mbps)	WLAN	2.83	± 9.6 %
10061	CAB	IEEE 802.11b WiFi 2.4 GHz (DSSS, 11 Mbps)	WLAN	3.60	± 9.6 %
10062	CAC	IEEE 802.11a/h WiFi 5 GHz (OFDM, 6 Mbps)	WLAN	8.68	± 9.6 %
10063	CAC	IEEE 802.11a/h WiFi 5 GHz (OFDM, 9 Mbps)	WLAN	8.63	± 9.6 %
10064	CAC	IEEE 802.11a/h WiFi 5 GHz (OFDM, 12 Mbps)	WLAN	9.09	± 9.6 %
10065	CAC	IEEE 802.11a/h WiFi 5 GHz (OFDM, 18 Mbps)	WLAN	9.00	± 9.6 %
10066	CAC	IEEE 802.11a/h WiFi 5 GHz (OFDM, 24 Mbps)	WLAN	9.38	± 9.6 %
10067	CAC	IEEE 802.11a/h WiFi 5 GHz (OFDM, 36 Mbps)	WLAN	10.12	± 9.6 %
10068	CAC	IEEE 802.11a/h WiFi 5 GHz (OFDM, 48 Mbps)	WLAN	10.24	± 9.6 %
10069	CAC	IEEE 802.11a/h WiFi 5 GHz (OFDM, 54 Mbps)	WLAN	10.56	± 9.6 %
10071	CAB	IEEE 802.11g WiFi 2.4 GHz (DSSS/OFDM, 9 Mbps)	WLAN	9.83	± 9.6 %
10072	CAB	IEEE 802.11g WiFi 2.4 GHz (DSSS/OFDM, 12 Mbps)	WLAN	9.62	± 9.6 %
10073	CAB	IEEE 802.11g WiFi 2.4 GHz (DSSS/OFDM, 18 Mbps)	WLAN	9.94	± 9.6 %
10074	CAB	IEEE 802.11g WiFi 2.4 GHz (DSSS/OFDM, 24 Mbps)	WLAN	10.30	± 9.6 %
10075	CAB	IEEE 802.11g WiFi 2.4 GHz (DSSS/OFDM, 36 Mbps)	WLAN	10.77	± 9.6 %
10076	CAB	IEEE 802.11g WiFi 2.4 GHz (DSSS/OFDM, 48 Mbps)	WLAN	10.94	± 9.6 %
10077	CAB	IEEE 802.11g WiFi 2.4 GHz (DSSS/OFDM, 54 Mbps)	WLAN	11.00	± 9.6 %
10081	CAB	CDMA2000 (1xRTT, RC3)	CDMA2000	3.97	± 9.6 %
10082	CAB	IS-54 / IS-136 FDD (TDMA/FDM, PI/4-DQPSK, Fullrate)	AMPS	4.77	± 9.6 %
10090	DAC	GPRS-FDD (TDMA, GMSK, TN 0-4)	GSM	6.56	± 9.6 %
10097	CAB	UMTS-FDD (HSDPA)	WCDMA	3.98	± 9.6 %
10098	CAB	UMTS-FDD (HSUPA, Subtest 2)	WCDMA	3.98	± 9.6 %
10099	DAC	EDGE-FDD (TDMA, 8PSK, TN 0-4)	GSM	9.55	± 9.6 %
10100	CAE	LTE-FDD (SC-FDMA, 100% RB, 20 MHz, QPSK)	LTE-FDD	5.67	± 9.6 %
10101	CAE	LTE-FDD (SC-FDMA, 100% RB, 20 MHz, 16-QAM)	LTE-FDD	6.42	± 9.6 %
10102	CAE	LTE-FDD (SC-FDMA, 100% RB, 20 MHz, 64-QAM)	LTE-FDD	6.60	± 9.6 %
10103	CAG	LTE-TDD (SC-FDMA, 100% RB, 20 MHz, QPSK)	LTE-TDD	9.29	± 9.6 %
10104	CAG	LTE-TDD (SC-FDMA, 100% RB, 20 MHz, 16-QAM)	LTE-TDD	9.97	± 9.6 %
10105	CAG	LTE-TDD (SC-FDMA, 100% RB, 20 MHz, 64-QAM)	LTE-TDD	10.01	± 9.6 %
10108	CAG	LTE-FDD (SC-FDMA, 100% RB, 10 MHz, QPSK)	LTE-FDD	5.80	± 9.6 %

10109	CAG	LTE-FDD (SC-FDMA, 100% RB, 10 MHz, 16-QAM)	LTE-FDD	6.43	± 9.6 %
10110	CAG	LTE-FDD (SC-FDMA, 100% RB, 5 MHz, QPSK)	LTE-FDD	5.75	± 9.6 %
10111	CAG	LTE-FDD (SC-FDMA, 100% RB, 5 MHz, 16-QAM)	LTE-FDD	6.44	± 9.6 %
10112	CAG	LTE-FDD (SC-FDMA, 100% RB, 10 MHz, 64-QAM)	LTE-FDD	6.59	± 9.6 %
10113	CAG	LTE-FDD (SC-FDMA, 100% RB, 5 MHz, 64-QAM)	LTE-FDD	6.62	± 9.6 %
10114	CAC	IEEE 802.11n (HT Greenfield, 13.5 Mbps, BPSK)	WLAN	8.10	± 9.6 %
10115	CAC	IEEE 802.11n (HT Greenfield, 81 Mbps, 16-QAM)	WLAN	8.46	± 9.6 %
10116	CAC	IEEE 802.11n (HT Greenfield, 135 Mbps, 64-QAM)	WLAN	8.15	± 9.6 %
10117	CAC	IEEE 802.11n (HT Mixed, 13.5 Mbps, BPSK)	WLAN	8.07	± 9.6 %
10118	CAC	IEEE 802.11n (HT Mixed, 81 Mbps, 16-QAM)	WLAN	8.59	± 9.6 %
10119	CAC	IEEE 802.11n (HT Mixed, 135 Mbps, 64-QAM)	WLAN	8.13	± 9.6 %
10140	CAE	LTE-FDD (SC-FDMA, 100% RB, 15 MHz, 16-QAM)	LTE-FDD	6.49	± 9.6 %
10141	CAE	LTE-FDD (SC-FDMA, 100% RB, 15 MHz, 64-QAM)	LTE-FDD	6.53	± 9.6 %
10142	CAE	LTE-FDD (SC-FDMA, 100% RB, 3 MHz, QPSK)	LTE-FDD	5.73	± 9.6 %
10143	CAE	LTE-FDD (SC-FDMA, 100% RB, 3 MHz, 16-QAM)	LTE-FDD	6.35	± 9.6 %
10144	CAE	LTE-FDD (SC-FDMA, 100% RB, 3 MHz, 64-QAM)	LTE-FDD	6.65	± 9.6 %
10145	CAF	LTE-FDD (SC-FDMA, 100% RB, 1.4 MHz, QPSK)	LTE-FDD	5.76	± 9.6 %
10146	CAF	LTE-FDD (SC-FDMA, 100% RB, 1.4 MHz, 16-QAM)	LTE-FDD	6.41	± 9.6 %
10147	CAF	LTE-FDD (SC-FDMA, 100% RB, 1.4 MHz, 64-QAM)	LTE-FDD	6.72	± 9.6 %
10149	CAE	LTE-FDD (SC-FDMA, 50% RB, 20 MHz, 16-QAM)	LTE-FDD	6.42	± 9.6 %
10150	CAE	LTE-FDD (SC-FDMA, 50% RB, 20 MHz, 64-QAM)	LTE-FDD	6.60	± 9.6 %
10151	CAG	LTE-TDD (SC-FDMA, 50% RB, 20 MHz, QPSK)	LTE-TDD	9.28	± 9.6 %
10152	CAG	LTE-TDD (SC-FDMA, 50% RB, 20 MHz, 16-QAM)	LTE-TDD	9.92	± 9.6 %
10153	CAG	LTE-TDD (SC-FDMA, 50% RB, 20 MHz, 64-QAM)	LTE-TDD	10.05	± 9.6 %
10154	CAG	LTE-FDD (SC-FDMA, 50% RB, 10 MHz, QPSK)	LTE-FDD	5.75	± 9.6 %
10155	CAG	LTE-FDD (SC-FDMA, 50% RB, 10 MHz, 16-QAM)	LTE-FDD	6.43	± 9.6 %
10156	CAG	LTE-FDD (SC-FDMA, 50% RB, 5 MHz, QPSK)	LTE-FDD	5.79	± 9.6 %
10157	CAG	LTE-FDD (SC-FDMA, 50% RB, 5 MHz, 16-QAM)	LTE-FDD	6.49	± 9.6 %
10158	CAG	LTE-FDD (SC-FDMA, 50% RB, 10 MHz, 64-QAM)	LTE-FDD	6.62	± 9.6 %
10159	CAG	LTE-FDD (SC-FDMA, 50% RB, 5 MHz, 64-QAM)	LTE-FDD	6.56	± 9.6 %
10160	CAE	LTE-FDD (SC-FDMA, 50% RB, 15 MHz, QPSK)	LTE-FDD	5.82	± 9.6 %
10161	CAE	LTE-FDD (SC-FDMA, 50% RB, 15 MHz, 16-QAM)	LTE-FDD	6.43	± 9.6 %
10162	CAE	LTE-FDD (SC-FDMA, 50% RB, 15 MHz, 64-QAM)	LTE-FDD	6.58	± 9.6 %
10166	CAF	LTE-FDD (SC-FDMA, 50% RB, 1.4 MHz, QPSK)	LTE-FDD	5.46	± 9.6 %
10167	CAF	LTE-FDD (SC-FDMA, 50% RB, 1.4 MHz, 16-QAM)	LTE-FDD	6.21	± 9.6 %
10168	CAF	LTE-FDD (SC-FDMA, 50% RB, 1.4 MHz, 64-QAM)	LTE-FDD	6.79	± 9.6 %
10169	CAE	LTE-FDD (SC-FDMA, 1 RB, 20 MHz, QPSK)	LTE-FDD	5.73	± 9.6 %
10170	CAE	LTE-FDD (SC-FDMA, 1 RB, 20 MHz, 16-QAM)	LTE-FDD	6.52	± 9.6 %
10171	AAE	LTE-FDD (SC-FDMA, 1 RB, 20 MHz, 64-QAM)	LTE-FDD	6.49	± 9.6 %
10172	CAG	LTE-TDD (SC-FDMA, 1 RB, 20 MHz, QPSK)	LTE-TDD	9.21	± 9.6 %
10173	CAG	LTE-TDD (SC-FDMA, 1 RB, 20 MHz, 16-QAM)	LTE-TDD	9.48	± 9.6 %
10174	CAG	LTE-TDD (SC-FDMA, 1 RB, 20 MHz, 64-QAM)	LTE-TDD	10.25	± 9.6 %
10175	CAG	LTE-FDD (SC-FDMA, 1 RB, 10 MHz, QPSK)	LTE-FDD	5.72	± 9.6 %
10176	CAG	LTE-FDD (SC-FDMA, 1 RB, 10 MHz, 16-QAM)	LTE-FDD	6.52	± 9.6 %
10177	CAI	LTE-FDD (SC-FDMA, 1 RB, 5 MHz, QPSK)	LTE-FDD	5.73	± 9.6 %
10178	CAG	LTE-FDD (SC-FDMA, 1 RB, 5 MHz, 16-QAM)	LTE-FDD	6.52	± 9.6 %
10179	CAG	LTE-FDD (SC-FDMA, 1 RB, 10 MHz, 64-QAM)	LTE-FDD	6.50	± 9.6 %
10180	CAG	LTE-FDD (SC-FDMA, 1 RB, 5 MHz, 64-QAM)	LTE-FDD	6.50	± 9.6 %
10181	CAE	LTE-FDD (SC-FDMA, 1 RB, 15 MHz, QPSK)	LTE-FDD	5.72	± 9.6 %
10182	CAE	LTE-FDD (SC-FDMA, 1 RB, 15 MHz, 16-QAM)	LTE-FDD	6.52	± 9.6 %
10183	AAD	LTE-FDD (SC-FDMA, 1 RB, 15 MHz, 64-QAM)	LTE-FDD	6.50	± 9.6 %
10184	CAE	LTE-FDD (SC-FDMA, 1 RB, 3 MHz, QPSK)	LTE-FDD	5.73	± 9.6 %
10185	CAE	LTE-FDD (SC-FDMA, 1 RB, 3 MHz, 16-QAM)	LTE-FDD	6.51	± 9.6 %
10186	AAE	LTE-FDD (SC-FDMA, 1 RB, 3 MHz, 64-QAM)	LTE-FDD	6.50	± 9.6 %
10187	CAF	LTE-FDD (SC-FDMA, 1 RB, 1.4 MHz, QPSK)	LTE-FDD	5.73	± 9.6 %
10188	CAF	LTE-FDD (SC-FDMA, 1 RB, 1.4 MHz, 16-QAM)	LTE-FDD	6.52	± 9.6 %
10189	AAF	LTE-FDD (SC-FDMA, 1 RB, 1.4 MHz, 64-QAM)	LTE-FDD	6.50	± 9.6 %
10193	CAC	IEEE 802.11n (HT Greenfield, 6.5 Mbps, BPSK)	WLAN	8.09	± 9.6 %
10194	CAC	IEEE 802.11n (HT Greenfield, 39 Mbps, 16-QAM)	WLAN	8.12	± 9.6 %
10195	CAC	IEEE 802.11n (HT Greenfield, 65 Mbps, 64-QAM)	WLAN	8.21	± 9.6 %
10196	CAC	IEEE 802.11n (HT Mixed, 6.5 Mbps, BPSK)	WLAN	8.10	± 9.6 %
10197	CAC	IEEE 802.11n (HT Mixed, 39 Mbps, 16-QAM)	WLAN	8.13	± 9.6 %
10198	CAC	IEEE 802.11n (HT Mixed, 65 Mbps, 64-QAM)	WLAN	8.27	± 9.6 %
10219	CAC	IEEE 802.11n (HT Mixed, 7.2 Mbps, BPSK)	WLAN	8.03	± 9.6 %

10220	CAC	IEEE 802.11n (HT Mixed, 43.3 Mbps, 16-QAM)	WLAN	8.13	± 9.6 %
10221	CAC	IEEE 802.11n (HT Mixed, 72.2 Mbps, 64-QAM)	WLAN	8.27	± 9.6 %
10222	CAC	IEEE 802.11n (HT Mixed, 15 Mbps, BPSK)	WLAN	8.06	± 9.6 %
10223	CAC	IEEE 802.11n (HT Mixed, 90 Mbps, 16-QAM)	WLAN	8.48	± 9.6 %
10224	CAC	IEEE 802.11n (HT Mixed, 150 Mbps, 64-QAM)	WLAN	8.08	± 9.6 %
10225	CAB	UMTS-FDD (HSPA+)	WCDMA	5.97	± 9.6 %
10226	CAB	LTE-TDD (SC-FDMA, 1 RB, 1.4 MHz, 16-QAM)	LTE-TDD	9.49	± 9.6 %
10227	CAB	LTE-TDD (SC-FDMA, 1 RB, 1.4 MHz, 64-QAM)	LTE-TDD	10.26	± 9.6 %
10228	CAB	LTE-TDD (SC-FDMA, 1 RB, 1.4 MHz, QPSK)	LTE-TDD	9.22	± 9.6 %
10229	CAD	LTE-TDD (SC-FDMA, 1 RB, 3 MHz, 16-QAM)	LTE-TDD	9.48	± 9.6 %
10230	CAD	LTE-TDD (SC-FDMA, 1 RB, 3 MHz, 64-QAM)	LTE-TDD	10.25	± 9.6 %
10231	CAD	LTE-TDD (SC-FDMA, 1 RB, 3 MHz, QPSK)	LTE-TDD	9.19	± 9.6 %
10232	CAG	LTE-TDD (SC-FDMA, 1 RB, 5 MHz, 16-QAM)	LTE-TDD	9.48	± 9.6 %
10233	CAG	LTE-TDD (SC-FDMA, 1 RB, 5 MHz, 64-QAM)	LTE-TDD	10.25	± 9.6 %
10234	CAG	LTE-TDD (SC-FDMA, 1 RB, 5 MHz, QPSK)	LTE-TDD	9.21	± 9.6 %
10235	CAG	LTE-TDD (SC-FDMA, 1 RB, 10 MHz, 16-QAM)	LTE-TDD	9.48	± 9.6 %
10236	CAG	LTE-TDD (SC-FDMA, 1 RB, 10 MHz, 64-QAM)	LTE-TDD	10.25	± 9.6 %
10237	CAG	LTE-TDD (SC-FDMA, 1 RB, 10 MHz, QPSK)	LTE-TDD	9.21	± 9.6 %
10238	CAF	LTE-TDD (SC-FDMA, 1 RB, 15 MHz, 16-QAM)	LTE-TDD	9.48	± 9.6 %
10239	CAF	LTE-TDD (SC-FDMA, 1 RB, 15 MHz, 64-QAM)	LTE-TDD	10.25	± 9.6 %
10240	CAF	LTE-TDD (SC-FDMA, 1 RB, 15 MHz, QPSK)	LTE-TDD	9.21	± 9.6 %
10241	CAB	LTE-TDD (SC-FDMA, 50% RB, 1.4 MHz, 16-QAM)	LTE-TDD	9.82	± 9.6 %
10242	CAB	LTE-TDD (SC-FDMA, 50% RB, 1.4 MHz, 64-QAM)	LTE-TDD	9.86	± 9.6 %
10243	CAB	LTE-TDD (SC-FDMA, 50% RB, 1.4 MHz, QPSK)	LTE-TDD	9.46	± 9.6 %
10244	CAD	LTE-TDD (SC-FDMA, 50% RB, 3 MHz, 16-QAM)	LTE-TDD	10.06	± 9.6 %
10245	CAD	LTE-TDD (SC-FDMA, 50% RB, 3 MHz, 64-QAM)	LTE-TDD	10.06	± 9.6 %
10246	CAD	LTE-TDD (SC-FDMA, 50% RB, 3 MHz, QPSK)	LTE-TDD	9.30	± 9.6 %
10247	CAG	LTE-TDD (SC-FDMA, 50% RB, 5 MHz, 16-QAM)	LTE-TDD	9.91	± 9.6 %
10248	CAG	LTE-TDD (SC-FDMA, 50% RB, 5 MHz, 64-QAM)	LTE-TDD	10.09	± 9.6 %
10249	CAG	LTE-TDD (SC-FDMA, 50% RB, 5 MHz, QPSK)	LTE-TDD	9.29	± 9.6 %
10250	CAG	LTE-TDD (SC-FDMA, 50% RB, 10 MHz, 16-QAM)	LTE-TDD	9.81	± 9.6 %
10251	CAG	LTE-TDD (SC-FDMA, 50% RB, 10 MHz, 64-QAM)	LTE-TDD	10.17	± 9.6 %
10252	CAG	LTE-TDD (SC-FDMA, 50% RB, 10 MHz, QPSK)	LTE-TDD	9.24	± 9.6 %
10253	CAF	LTE-TDD (SC-FDMA, 50% RB, 15 MHz, 16-QAM)	LTE-TDD	9.90	± 9.6 %
10254	CAF	LTE-TDD (SC-FDMA, 50% RB, 15 MHz, 64-QAM)	LTE-TDD	10.14	± 9.6 %
10255	CAF	LTE-TDD (SC-FDMA, 50% RB, 15 MHz, QPSK)	LTE-TDD	9.20	± 9.6 %
10256	CAB	LTE-TDD (SC-FDMA, 100% RB, 1.4 MHz, 16-QAM)	LTE-TDD	9.96	± 9.6 %
10257	CAB	LTE-TDD (SC-FDMA, 100% RB, 1.4 MHz, 64-QAM)	LTE-TDD	10.08	± 9.6 %
10258	CAB	LTE-TDD (SC-FDMA, 100% RB, 1.4 MHz, QPSK)	LTE-TDD	9.34	± 9.6 %
10259	CAD	LTE-TDD (SC-FDMA, 100% RB, 3 MHz, 16-QAM)	LTE-TDD	9.98	± 9.6 %
10260	CAD	LTE-TDD (SC-FDMA, 100% RB, 3 MHz, 64-QAM)	LTE-TDD	9.97	± 9.6 %
10261	CAD	LTE-TDD (SC-FDMA, 100% RB, 3 MHz, QPSK)	LTE-TDD	9.24	± 9.6 %
10262	CAG	LTE-TDD (SC-FDMA, 100% RB, 5 MHz, 16-QAM)	LTE-TDD	9.83	± 9.6 %
10263	CAG	LTE-TDD (SC-FDMA, 100% RB, 5 MHz, 64-QAM)	LTE-TDD	10.16	± 9.6 %
10264	CAG	LTE-TDD (SC-FDMA, 100% RB, 5 MHz, QPSK)	LTE-TDD	9.23	± 9.6 %
10265	CAG	LTE-TDD (SC-FDMA, 100% RB, 10 MHz, 16-QAM)	LTE-TDD	9.92	± 9.6 %
10266	CAG	LTE-TDD (SC-FDMA, 100% RB, 10 MHz, 64-QAM)	LTE-TDD	10.07	± 9.6 %
10267	CAG	LTE-TDD (SC-FDMA, 100% RB, 10 MHz, QPSK)	LTE-TDD	9.30	± 9.6 %
10268	CAF	LTE-TDD (SC-FDMA, 100% RB, 15 MHz, 16-QAM)	LTE-TDD	10.06	± 9.6 %
10269	CAF	LTE-TDD (SC-FDMA, 100% RB, 15 MHz, 64-QAM)	LTE-TDD	10.13	± 9.6 %
10270	CAF	LTE-TDD (SC-FDMA, 100% RB, 15 MHz, QPSK)	LTE-TDD	9.58	± 9.6 %
10274	CAB	UMTS-FDD (HSUPA, Subtest 5, 3GPP Rel8.10)	WCDMA	4.87	± 9.6 %
10275	CAB	UMTS-FDD (HSUPA, Subtest 5, 3GPP Rel8.4)	WCDMA	3.96	± 9.6 %
10277	CAA	PHS (QPSK)	PHS	11.81	± 9.6 %
10278	CAA	PHS (QPSK, BW 884MHz, Rolloff 0.5)	PHS	11.81	± 9.6 %
10279	CAA	PHS (QPSK, BW 884MHz, Rolloff 0.38)	PHS	12.18	± 9.6 %
10290	AAB	CDMA2000, RC1, SO55, Full Rate	CDMA2000	3.91	± 9.6 %
10291	AAB	CDMA2000, RC3, SO55, Full Rate	CDMA2000	3.46	± 9.6 %
10292	AAB	CDMA2000, RC3, SO32, Full Rate	CDMA2000	3.39	± 9.6 %
10293	AAB	CDMA2000, RC3, SO3, Full Rate	CDMA2000	3.50	± 9.6 %
10295	AAB	CDMA2000, RC1, SO3, 1/8th Rate 25 fr.	CDMA2000	12.49	± 9.6 %
10297	AAD	LTE-FDD (SC-FDMA, 50% RB, 20 MHz, QPSK)	LTE-FDD	5.81	± 9.6 %
10298	AAD	LTE-FDD (SC-FDMA, 50% RB, 3 MHz, QPSK)	LTE-FDD	5.72	± 9.6 %
10299	AAD	LTE-FDD (SC-FDMA, 50% RB, 3 MHz, 16-QAM)	LTE-FDD	6.39	± 9.6 %

10300	AAD	LTE-FDD (SC-FDMA, 50% RB, 3 MHz, 64-QAM)	LTE-FDD	6.60	± 9.6 %
10301	AAA	IEEE 802.16e WiMAX (29:18, 5ms, 10MHz, QPSK, PUSC)	WiMAX	12.03	± 9.6 %
10302	AAA	IEEE 802.16e WiMAX (29:18, 5ms, 10MHz, QPSK, PUSC, 3 CTRL symbols)	WiMAX	12.57	± 9.6 %
10303	AAA	IEEE 802.16e WiMAX (31:15, 5ms, 10MHz, 64QAM, PUSC)	WiMAX	12.52	± 9.6 %
10304	AAA	IEEE 802.16e WiMAX (29:18, 5ms, 10MHz, 64QAM, PUSC)	WiMAX	11.86	± 9.6 %
10305	AAA	IEEE 802.16e WiMAX (31:15, 10ms, 10MHz, 64QAM, PUSC, 15 symbols)	WiMAX	15.24	± 9.6 %
10306	AAA	IEEE 802.16e WiMAX (29:18, 10ms, 10MHz, 64QAM, PUSC, 18 symbols)	WiMAX	14.67	± 9.6 %
10307	AAA	IEEE 802.16e WiMAX (29:18, 10ms, 10MHz, QPSK, PUSC, 18 symbols)	WiMAX	14.49	± 9.6 %
10308	AAA	IEEE 802.16e WiMAX (29:18, 10ms, 10MHz, 16QAM, PUSC)	WiMAX	14.46	± 9.6 %
10309	AAA	IEEE 802.16e WiMAX (29:18, 10ms, 10MHz, 16QAM, AMC 2x3, 18 symbols)	WiMAX	14.58	± 9.6 %
10310	AAA	IEEE 802.16e WiMAX (29:18, 10ms, 10MHz, QPSK, AMC 2x3, 18 symbols)	WiMAX	14.57	± 9.6 %
10311	AAD	LTE-FDD (SC-FDMA, 100% RB, 15 MHz, QPSK)	LTE-FDD	6.06	± 9.6 %
10313	AAA	iDEN 1:3	iDEN	10.51	± 9.6 %
10314	AAA	iDEN 1:6	iDEN	13.48	± 9.6 %
10315	AAB	IEEE 802.11b WiFi 2.4 GHz (DSSS, 1 Mbps, 96pc duty cycle)	WLAN	1.71	± 9.6 %
10316	AAB	IEEE 802.11g WiFi 2.4 GHz (ERP-OFDM, 6 Mbps, 96pc duty cycle)	WLAN	8.36	± 9.6 %
10317	AAC	IEEE 802.11a WiFi 5 GHz (OFDM, 6 Mbps, 96pc duty cycle)	WLAN	8.36	± 9.6 %
10352	AAA	Pulse Waveform (200Hz, 10%)	Generic	10.00	± 9.6 %
10353	AAA	Pulse Waveform (200Hz, 20%)	Generic	6.99	± 9.6 %
10354	AAA	Pulse Waveform (200Hz, 40%)	Generic	3.98	± 9.6 %
10355	AAA	Pulse Waveform (200Hz, 60%)	Generic	2.22	± 9.6 %
10356	AAA	Pulse Waveform (200Hz, 80%)	Generic	0.97	± 9.6 %
10387	AAA	QPSK Waveform, 1 MHz	Generic	5.10	± 9.6 %
10388	AAA	QPSK Waveform, 10 MHz	Generic	5.22	± 9.6 %
10396	AAA	64-QAM Waveform, 100 kHz	Generic	6.27	± 9.6 %
10399	AAA	64-QAM Waveform, 40 MHz	Generic	6.27	± 9.6 %
10400	AAD	IEEE 802.11ac WiFi (20MHz, 64-QAM, 99pc duty cycle)	WLAN	8.37	± 9.6 %
10401	AAD	IEEE 802.11ac WiFi (40MHz, 64-QAM, 99pc duty cycle)	WLAN	8.60	± 9.6 %
10402	AAD	IEEE 802.11ac WiFi (80MHz, 64-QAM, 99pc duty cycle)	WLAN	8.53	± 9.6 %
10403	AAB	CDMA2000 (1xEV-DO, Rev. 0)	CDMA2000	3.76	± 9.6 %
10404	AAB	CDMA2000 (1xEV-DO, Rev. A)	CDMA2000	3.77	± 9.6 %
10406	AAB	CDMA2000, RC3, SO32, SCH0, Full Rate	CDMA2000	5.22	± 9.6 %
10410	AAG	LTE-TDD (SC-FDMA, 1 RB, 10 MHz, QPSK, UL Subframe=2,3,4,7,8,9, Subframe Conf=4)	LTE-TDD	7.82	± 9.6 %
10414	AAA	WLAN CCDF, 64-QAM, 40MHz	Generic	8.54	± 9.6 %
10415	AAA	IEEE 802.11b WiFi 2.4 GHz (DSSS, 1 Mbps, 99pc duty cycle)	WLAN	1.54	± 9.6 %
10416	AAA	IEEE 802.11g WiFi 2.4 GHz (ERP-OFDM, 6 Mbps, 99pc duty cycle)	WLAN	8.23	± 9.6 %
10417	AAB	IEEE 802.11a/h WiFi 5 GHz (OFDM, 6 Mbps, 99pc duty cycle)	WLAN	8.23	± 9.6 %
10418	AAA	IEEE 802.11g WiFi 2.4 GHz (DSSS-OFDM, 6 Mbps, 99pc duty cycle, Long preambule)	WLAN	8.14	± 9.6 %
10419	AAA	IEEE 802.11g WiFi 2.4 GHz (DSSS-OFDM, 6 Mbps, 99pc duty cycle, Short preambule)	WLAN	8.19	± 9.6 %
10422	AAB	IEEE 802.11n (HT Greenfield, 7.2 Mbps, BPSK)	WLAN	8.32	± 9.6 %
10423	AAB	IEEE 802.11n (HT Greenfield, 43.3 Mbps, 16-QAM)	WLAN	8.47	± 9.6 %
10424	AAB	IEEE 802.11n (HT Greenfield, 72.2 Mbps, 64-QAM)	WLAN	8.40	± 9.6 %
10425	AAB	IEEE 802.11n (HT Greenfield, 15 Mbps, BPSK)	WLAN	8.41	± 9.6 %
10426	AAB	IEEE 802.11n (HT Greenfield, 90 Mbps, 16-QAM)	WLAN	8.45	± 9.6 %
10427	AAB	IEEE 802.11n (HT Greenfield, 150 Mbps, 64-QAM)	WLAN	8.41	± 9.6 %
10430	AAD	LTE-FDD (OFDMA, 5 MHz, E-TM 3.1)	LTE-FDD	8.28	± 9.6 %
10431	AAD	LTE-FDD (OFDMA, 10 MHz, E-TM 3.1)	LTE-FDD	8.38	± 9.6 %
10432	AAC	LTE-FDD (OFDMA, 15 MHz, E-TM 3.1)	LTE-FDD	8.34	± 9.6 %
10433	AAC	LTE-FDD (OFDMA, 20 MHz, E-TM 3.1)	LTE-FDD	8.34	± 9.6 %
10434	AAA	W-CDMA (BS Test Model 1, 64 DPCH)	WCDMA	8.60	± 9.6 %
10435	AAF	LTE-TDD (SC-FDMA, 1 RB, 20 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.82	± 9.6 %
10447	AAD	LTE-FDD (OFDMA, 5 MHz, E-TM 3.1, Clipping 44%)	LTE-FDD	7.56	± 9.6 %
10448	AAD	LTE-FDD (OFDMA, 10 MHz, E-TM 3.1, Clippin 44%)	LTE-FDD	7.53	± 9.6 %
10449	AAC	LTE-FDD (OFDMA, 15 MHz, E-TM 3.1, Cliping 44%)	LTE-FDD	7.51	± 9.6 %

10450	AAC	LTE-FDD (OFDMA, 20 MHz, E-TM 3.1, Clipping 44%)	LTE-FDD	7.48	± 9.6 %
10451	AAA	W-CDMA (BS Test Model 1, 64 DPCH, Clipping 44%)	WCDMA	7.59	± 9.6 %
10453	AAD	Validation (Square, 10ms, 1ms)	Test	10.00	± 9.6 %
10456	AAB	IEEE 802.11ac WiFi (160MHz, 64-QAM, 99pc duty cycle)	WLAN	8.63	± 9.6 %
10457	AAA	UMTS-FDD (DC-HSDPA)	WCDMA	6.62	± 9.6 %
10458	AAA	CDMA2000 (1xEV-DO, Rev. B, 2 carriers)	CDMA2000	6.55	± 9.6 %
10459	AAA	CDMA2000 (1xEV-DO, Rev. B, 3 carriers)	CDMA2000	8.25	± 9.6 %
10460	AAA	UMTS-FDD (WCDMA, AMR)	WCDMA	2.39	± 9.6 %
10461	AAB	LTE-TDD (SC-FDMA, 1 RB, 1.4 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.82	± 9.6 %
10462	AAB	LTE-TDD (SC-FDMA, 1 RB, 1.4 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.30	± 9.6 %
10463	AAB	LTE-TDD (SC-FDMA, 1 RB, 1.4 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.56	± 9.6 %
10464	AAC	LTE-TDD (SC-FDMA, 1 RB, 3 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.82	± 9.6 %
10465	AAC	LTE-TDD (SC-FDMA, 1 RB, 3 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.32	± 9.6 %
10466	AAC	LTE-TDD (SC-FDMA, 1 RB, 3 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.57	± 9.6 %
10467	AAF	LTE-TDD (SC-FDMA, 1 RB, 5 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.82	± 9.6 %
10468	AAF	LTE-TDD (SC-FDMA, 1 RB, 5 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.32	± 9.6 %
10469	AAF	LTE-TDD (SC-FDMA, 1 RB, 5 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.56	± 9.6 %
10470	AAF	LTE-TDD (SC-FDMA, 1 RB, 10 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.82	± 9.6 %
10471	AAF	LTE-TDD (SC-FDMA, 1 RB, 10 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.32	± 9.6 %
10472	AAF	LTE-TDD (SC-FDMA, 1 RB, 10 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.57	± 9.6 %
10473	AAE	LTE-TDD (SC-FDMA, 1 RB, 15 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.82	± 9.6 %
10474	AAE	LTE-TDD (SC-FDMA, 1 RB, 15 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.32	± 9.6 %
10475	AAE	LTE-TDD (SC-FDMA, 1 RB, 15 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.57	± 9.6 %
10477	AAF	LTE-TDD (SC-FDMA, 1 RB, 20 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.32	± 9.6 %
10478	AAF	LTE-TDD (SC-FDMA, 1 RB, 20 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.57	± 9.6 %
10479	AAB	LTE-TDD (SC-FDMA, 50% RB, 1.4 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.74	± 9.6 %
10480	AAB	LTE-TDD (SC-FDMA, 50% RB, 1.4 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.18	± 9.6 %
10481	AAB	LTE-TDD (SC-FDMA, 50% RB, 1.4 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.45	± 9.6 %
10482	AAC	LTE-TDD (SC-FDMA, 50% RB, 3 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.71	± 9.6 %
10483	AAC	LTE-TDD (SC-FDMA, 50% RB, 3 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.39	± 9.6 %
10484	AAC	LTE-TDD (SC-FDMA, 50% RB, 3 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.47	± 9.6 %
10485	AAF	LTE-TDD (SC-FDMA, 50% RB, 5 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.59	± 9.6 %
10486	AAF	LTE-TDD (SC-FDMA, 50% RB, 5 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.38	± 9.6 %
10487	AAF	LTE-TDD (SC-FDMA, 50% RB, 5 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.60	± 9.6 %
10488	AAF	LTE-TDD (SC-FDMA, 50% RB, 10 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.70	± 9.6 %
10489	AAF	LTE-TDD (SC-FDMA, 50% RB, 10 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.31	± 9.6 %
10490	AAF	LTE-TDD (SC-FDMA, 50% RB, 10 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.54	± 9.6 %

10491	AAE	LTE-TDD (SC-FDMA, 50% RB, 15 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.74	± 9.6 %
10492	AAE	LTE-TDD (SC-FDMA, 50% RB, 15 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.41	± 9.6 %
10493	AAE	LTE-TDD (SC-FDMA, 50% RB, 15 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.55	± 9.6 %
10494	AAF	LTE-TDD (SC-FDMA, 50% RB, 20 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.74	± 9.6 %
10495	AAF	LTE-TDD (SC-FDMA, 50% RB, 20 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.37	± 9.6 %
10496	AAF	LTE-TDD (SC-FDMA, 50% RB, 20 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.54	± 9.6 %
10497	AAB	LTE-TDD (SC-FDMA, 100% RB, 1.4 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.67	± 9.6 %
10498	AAB	LTE-TDD (SC-FDMA, 100% RB, 1.4 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.40	± 9.6 %
10499	AAB	LTE-TDD (SC-FDMA, 100% RB, 1.4 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.68	± 9.6 %
10500	AAC	LTE-TDD (SC-FDMA, 100% RB, 3 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.67	± 9.6 %
10501	AAC	LTE-TDD (SC-FDMA, 100% RB, 3 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.44	± 9.6 %
10502	AAC	LTE-TDD (SC-FDMA, 100% RB, 3 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.52	± 9.6 %
10503	AAF	LTE-TDD (SC-FDMA, 100% RB, 5 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.72	± 9.6 %
10504	AAF	LTE-TDD (SC-FDMA, 100% RB, 5 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.31	± 9.6 %
10505	AAF	LTE-TDD (SC-FDMA, 100% RB, 5 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.54	± 9.6 %
10506	AAF	LTE-TDD (SC-FDMA, 100% RB, 10 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.74	± 9.6 %
10507	AAF	LTE-TDD (SC-FDMA, 100% RB, 10 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.36	± 9.6 %
10508	AAF	LTE-TDD (SC-FDMA, 100% RB, 10 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.55	± 9.6 %
10509	AAE	LTE-TDD (SC-FDMA, 100% RB, 15 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.99	± 9.6 %
10510	AAE	LTE-TDD (SC-FDMA, 100% RB, 15 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.49	± 9.6 %
10511	AAE	LTE-TDD (SC-FDMA, 100% RB, 15 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.51	± 9.6 %
10512	AAF	LTE-TDD (SC-FDMA, 100% RB, 20 MHz, QPSK, UL Subframe=2,3,4,7,8,9)	LTE-TDD	7.74	± 9.6 %
10513	AAF	LTE-TDD (SC-FDMA, 100% RB, 20 MHz, 16-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.42	± 9.6 %
10514	AAF	LTE-TDD (SC-FDMA, 100% RB, 20 MHz, 64-QAM, UL Subframe=2,3,4,7,8,9)	LTE-TDD	8.45	± 9.6 %
10515	AAA	IEEE 802.11b WiFi 2.4 GHz (DSSS, 2 Mbps, 99pc duty cycle)	WLAN	1.58	± 9.6 %
10516	AAA	IEEE 802.11b WiFi 2.4 GHz (DSSS, 5.5 Mbps, 99pc duty cycle)	WLAN	1.57	± 9.6 %
10517	AAA	IEEE 802.11b WiFi 2.4 GHz (DSSS, 11 Mbps, 99pc duty cycle)	WLAN	1.58	± 9.6 %
10518	AAB	IEEE 802.11a/h WiFi 5 GHz (OFDM, 9 Mbps, 99pc duty cycle)	WLAN	8.23	± 9.6 %
10519	AAB	IEEE 802.11a/h WiFi 5 GHz (OFDM, 12 Mbps, 99pc duty cycle)	WLAN	8.39	± 9.6 %
10520	AAB	IEEE 802.11a/h WiFi 5 GHz (OFDM, 18 Mbps, 99pc duty cycle)	WLAN	8.12	± 9.6 %
10521	AAB	IEEE 802.11a/h WiFi 5 GHz (OFDM, 24 Mbps, 99pc duty cycle)	WLAN	7.97	± 9.6 %
10522	AAB	IEEE 802.11a/h WiFi 5 GHz (OFDM, 36 Mbps, 99pc duty cycle)	WLAN	8.45	± 9.6 %
10523	AAB	IEEE 802.11a/h WiFi 5 GHz (OFDM, 48 Mbps, 99pc duty cycle)	WLAN	8.08	± 9.6 %
10524	AAB	IEEE 802.11a/h WiFi 5 GHz (OFDM, 54 Mbps, 99pc duty cycle)	WLAN	8.27	± 9.6 %
10525	AAB	IEEE 802.11ac WiFi (20MHz, MCS0, 99pc duty cycle)	WLAN	8.36	± 9.6 %
10526	AAB	IEEE 802.11ac WiFi (20MHz, MCS1, 99pc duty cycle)	WLAN	8.42	± 9.6 %
10527	AAB	IEEE 802.11ac WiFi (20MHz, MCS2, 99pc duty cycle)	WLAN	8.21	± 9.6 %
10528	AAB	IEEE 802.11ac WiFi (20MHz, MCS3, 99pc duty cycle)	WLAN	8.36	± 9.6 %
10529	AAB	IEEE 802.11ac WiFi (20MHz, MCS4, 99pc duty cycle)	WLAN	8.36	± 9.6 %
10531	AAB	IEEE 802.11ac WiFi (20MHz, MCS6, 99pc duty cycle)	WLAN	8.43	± 9.6 %
10532	AAB	IEEE 802.11ac WiFi (20MHz, MCS7, 99pc duty cycle)	WLAN	8.29	± 9.6 %
10533	AAB	IEEE 802.11ac WiFi (20MHz, MCS8, 99pc duty cycle)	WLAN	8.38	± 9.6 %

10534	AAB	IEEE 802.11ac WiFi (40MHz, MCS0, 99pc duty cycle)	WLAN	8.45	± 9.6 %
10535	AAB	IEEE 802.11ac WiFi (40MHz, MCS1, 99pc duty cycle)	WLAN	8.45	± 9.6 %
10536	AAB	IEEE 802.11ac WiFi (40MHz, MCS2, 99pc duty cycle)	WLAN	8.32	± 9.6 %
10537	AAB	IEEE 802.11ac WiFi (40MHz, MCS3, 99pc duty cycle)	WLAN	8.44	± 9.6 %
10538	AAB	IEEE 802.11ac WiFi (40MHz, MCS4, 99pc duty cycle)	WLAN	8.54	± 9.6 %
10540	AAB	IEEE 802.11ac WiFi (40MHz, MCS6, 99pc duty cycle)	WLAN	8.39	± 9.6 %
10541	AAB	IEEE 802.11ac WiFi (40MHz, MCS7, 99pc duty cycle)	WLAN	8.46	± 9.6 %
10542	AAB	IEEE 802.11ac WiFi (40MHz, MCS8, 99pc duty cycle)	WLAN	8.65	± 9.6 %
10543	AAB	IEEE 802.11ac WiFi (40MHz, MCS9, 99pc duty cycle)	WLAN	8.65	± 9.6 %
10544	AAB	IEEE 802.11ac WiFi (80MHz, MCS0, 99pc duty cycle)	WLAN	8.47	± 9.6 %
10545	AAB	IEEE 802.11ac WiFi (80MHz, MCS1, 99pc duty cycle)	WLAN	8.55	± 9.6 %
10546	AAB	IEEE 802.11ac WiFi (80MHz, MCS2, 99pc duty cycle)	WLAN	8.35	± 9.6 %
10547	AAB	IEEE 802.11ac WiFi (80MHz, MCS3, 99pc duty cycle)	WLAN	8.49	± 9.6 %
10548	AAB	IEEE 802.11ac WiFi (80MHz, MCS4, 99pc duty cycle)	WLAN	8.37	± 9.6 %
10550	AAB	IEEE 802.11ac WiFi (80MHz, MCS6, 99pc duty cycle)	WLAN	8.38	± 9.6 %
10551	AAB	IEEE 802.11ac WiFi (80MHz, MCS7, 99pc duty cycle)	WLAN	8.50	± 9.6 %
10552	AAB	IEEE 802.11ac WiFi (80MHz, MCS8, 99pc duty cycle)	WLAN	8.42	± 9.6 %
10553	AAB	IEEE 802.11ac WiFi (80MHz, MCS9, 99pc duty cycle)	WLAN	8.45	± 9.6 %
10554	AAC	IEEE 802.11ac WiFi (160MHz, MCS0, 99pc duty cycle)	WLAN	8.48	± 9.6 %
10555	AAC	IEEE 802.11ac WiFi (160MHz, MCS1, 99pc duty cycle)	WLAN	8.47	± 9.6 %
10556	AAC	IEEE 802.11ac WiFi (160MHz, MCS2, 99pc duty cycle)	WLAN	8.50	± 9.6 %
10557	AAC	IEEE 802.11ac WiFi (160MHz, MCS3, 99pc duty cycle)	WLAN	8.52	± 9.6 %
10558	AAC	IEEE 802.11ac WiFi (160MHz, MCS4, 99pc duty cycle)	WLAN	8.61	± 9.6 %
10560	AAC	IEEE 802.11ac WiFi (160MHz, MCS6, 99pc duty cycle)	WLAN	8.73	± 9.6 %
10561	AAC	IEEE 802.11ac WiFi (160MHz, MCS7, 99pc duty cycle)	WLAN	8.56	± 9.6 %
10562	AAC	IEEE 802.11ac WiFi (160MHz, MCS8, 99pc duty cycle)	WLAN	8.69	± 9.6 %
10563	AAC	IEEE 802.11ac WiFi (160MHz, MCS9, 99pc duty cycle)	WLAN	8.77	± 9.6 %
10564	AAA	IEEE 802.11g WiFi 2.4 GHz (DSSS-OFDM, 9 Mbps, 99pc duty cycle)	WLAN	8.25	± 9.6 %
10565	AAA	IEEE 802.11g WiFi 2.4 GHz (DSSS-OFDM, 12 Mbps, 99pc duty cycle)	WLAN	8.45	± 9.6 %
10566	AAA	IEEE 802.11g WiFi 2.4 GHz (DSSS-OFDM, 18 Mbps, 99pc duty cycle)	WLAN	8.13	± 9.6 %
10567	AAA	IEEE 802.11g WiFi 2.4 GHz (DSSS-OFDM, 24 Mbps, 99pc duty cycle)	WLAN	8.00	± 9.6 %
10568	AAA	IEEE 802.11g WiFi 2.4 GHz (DSSS-OFDM, 36 Mbps, 99pc duty cycle)	WLAN	8.37	± 9.6 %
10569	AAA	IEEE 802.11g WiFi 2.4 GHz (DSSS-OFDM, 48 Mbps, 99pc duty cycle)	WLAN	8.10	± 9.6 %
10570	AAA	IEEE 802.11g WiFi 2.4 GHz (DSSS-OFDM, 54 Mbps, 99pc duty cycle)	WLAN	8.30	± 9.6 %
10571	AAA	IEEE 802.11b WiFi 2.4 GHz (DSSS, 1 Mbps, 90pc duty cycle)	WLAN	1.99	± 9.6 %
10572	AAA	IEEE 802.11b WiFi 2.4 GHz (DSSS, 2 Mbps, 90pc duty cycle)	WLAN	1.99	± 9.6 %
10573	AAA	IEEE 802.11b WiFi 2.4 GHz (DSSS, 5.5 Mbps, 90pc duty cycle)	WLAN	1.98	± 9.6 %
10574	AAA	IEEE 802.11b WiFi 2.4 GHz (DSSS, 11 Mbps, 90pc duty cycle)	WLAN	1.98	± 9.6 %
10575	AAA	IEEE 802.11g WiFi 2.4 GHz (DSSS-OFDM, 6 Mbps, 90pc duty cycle)	WLAN	8.59	± 9.6 %
10576	AAA	IEEE 802.11g WiFi 2.4 GHz (DSSS-OFDM, 9 Mbps, 90pc duty cycle)	WLAN	8.60	± 9.6 %
10577	AAA	IEEE 802.11g WiFi 2.4 GHz (DSSS-OFDM, 12 Mbps, 90pc duty cycle)	WLAN	8.70	± 9.6 %
10578	AAA	IEEE 802.11g WiFi 2.4 GHz (DSSS-OFDM, 18 Mbps, 90pc duty cycle)	WLAN	8.49	± 9.6 %
10579	AAA	IEEE 802.11g WiFi 2.4 GHz (DSSS-OFDM, 24 Mbps, 90pc duty cycle)	WLAN	8.36	± 9.6 %
10580	AAA	IEEE 802.11g WiFi 2.4 GHz (DSSS-OFDM, 36 Mbps, 90pc duty cycle)	WLAN	8.76	± 9.6 %
10581	AAA	IEEE 802.11g WiFi 2.4 GHz (DSSS-OFDM, 48 Mbps, 90pc duty cycle)	WLAN	8.35	± 9.6 %
10582	AAA	IEEE 802.11g WiFi 2.4 GHz (DSSS-OFDM, 54 Mbps, 90pc duty cycle)	WLAN	8.67	± 9.6 %
10583	AAB	IEEE 802.11a/h WiFi 5 GHz (OFDM, 6 Mbps, 90pc duty cycle)	WLAN	8.59	± 9.6 %
10584	AAB	IEEE 802.11a/h WiFi 5 GHz (OFDM, 9 Mbps, 90pc duty cycle)	WLAN	8.60	± 9.6 %
10585	AAB	IEEE 802.11a/h WiFi 5 GHz (OFDM, 12 Mbps, 90pc duty cycle)	WLAN	8.70	± 9.6 %
10586	AAB	IEEE 802.11a/h WiFi 5 GHz (OFDM, 18 Mbps, 90pc duty cycle)	WLAN	8.49	± 9.6 %

10587	AAB	IEEE 802.11a/h WiFi 5 GHz (OFDM, 24 Mbps, 90pc duty cycle)	WLAN	8.36	± 9.6 %
10588	AAB	IEEE 802.11a/h WiFi 5 GHz (OFDM, 36 Mbps, 90pc duty cycle)	WLAN	8.76	± 9.6 %
10589	AAB	IEEE 802.11a/h WiFi 5 GHz (OFDM, 48 Mbps, 90pc duty cycle)	WLAN	8.35	± 9.6 %
10590	AAB	IEEE 802.11a/h WiFi 5 GHz (OFDM, 54 Mbps, 90pc duty cycle)	WLAN	8.67	± 9.6 %
10591	AAB	IEEE 802.11n (HT Mixed, 20MHz, MCS0, 90pc duty cycle)	WLAN	8.63	± 9.6 %
10592	AAB	IEEE 802.11n (HT Mixed, 20MHz, MCS1, 90pc duty cycle)	WLAN	8.79	± 9.6 %
10593	AAB	IEEE 802.11n (HT Mixed, 20MHz, MCS2, 90pc duty cycle)	WLAN	8.64	± 9.6 %
10594	AAB	IEEE 802.11n (HT Mixed, 20MHz, MCS3, 90pc duty cycle)	WLAN	8.74	± 9.6 %
10595	AAB	IEEE 802.11n (HT Mixed, 20MHz, MCS4, 90pc duty cycle)	WLAN	8.74	± 9.6 %
10596	AAB	IEEE 802.11n (HT Mixed, 20MHz, MCS5, 90pc duty cycle)	WLAN	8.71	± 9.6 %
10597	AAB	IEEE 802.11n (HT Mixed, 20MHz, MCS6, 90pc duty cycle)	WLAN	8.72	± 9.6 %
10598	AAB	IEEE 802.11n (HT Mixed, 20MHz, MCS7, 90pc duty cycle)	WLAN	8.50	± 9.6 %
10599	AAB	IEEE 802.11n (HT Mixed, 40MHz, MCS0, 90pc duty cycle)	WLAN	8.79	± 9.6 %
10600	AAB	IEEE 802.11n (HT Mixed, 40MHz, MCS1, 90pc duty cycle)	WLAN	8.88	± 9.6 %
10601	AAB	IEEE 802.11n (HT Mixed, 40MHz, MCS2, 90pc duty cycle)	WLAN	8.82	± 9.6 %
10602	AAB	IEEE 802.11n (HT Mixed, 40MHz, MCS3, 90pc duty cycle)	WLAN	8.94	± 9.6 %
10603	AAB	IEEE 802.11n (HT Mixed, 40MHz, MCS4, 90pc duty cycle)	WLAN	9.03	± 9.6 %
10604	AAB	IEEE 802.11n (HT Mixed, 40MHz, MCS5, 90pc duty cycle)	WLAN	8.76	± 9.6 %
10605	AAB	IEEE 802.11n (HT Mixed, 40MHz, MCS6, 90pc duty cycle)	WLAN	8.97	± 9.6 %
10606	AAB	IEEE 802.11n (HT Mixed, 40MHz, MCS7, 90pc duty cycle)	WLAN	8.82	± 9.6 %
10607	AAB	IEEE 802.11ac WiFi (20MHz, MCS0, 90pc duty cycle)	WLAN	8.64	± 9.6 %
10608	AAB	IEEE 802.11ac WiFi (20MHz, MCS1, 90pc duty cycle)	WLAN	8.77	± 9.6 %
10609	AAB	IEEE 802.11ac WiFi (20MHz, MCS2, 90pc duty cycle)	WLAN	8.57	± 9.6 %
10610	AAB	IEEE 802.11ac WiFi (20MHz, MCS3, 90pc duty cycle)	WLAN	8.78	± 9.6 %
10611	AAB	IEEE 802.11ac WiFi (20MHz, MCS4, 90pc duty cycle)	WLAN	8.70	± 9.6 %
10612	AAB	IEEE 802.11ac WiFi (20MHz, MCS5, 90pc duty cycle)	WLAN	8.77	± 9.6 %
10613	AAB	IEEE 802.11ac WiFi (20MHz, MCS6, 90pc duty cycle)	WLAN	8.94	± 9.6 %
10614	AAB	IEEE 802.11ac WiFi (20MHz, MCS7, 90pc duty cycle)	WLAN	8.59	± 9.6 %
10615	AAB	IEEE 802.11ac WiFi (20MHz, MCS8, 90pc duty cycle)	WLAN	8.82	± 9.6 %
10616	AAB	IEEE 802.11ac WiFi (40MHz, MCS0, 90pc duty cycle)	WLAN	8.82	± 9.6 %
10617	AAB	IEEE 802.11ac WiFi (40MHz, MCS1, 90pc duty cycle)	WLAN	8.81	± 9.6 %
10618	AAB	IEEE 802.11ac WiFi (40MHz, MCS2, 90pc duty cycle)	WLAN	8.58	± 9.6 %
10619	AAB	IEEE 802.11ac WiFi (40MHz, MCS3, 90pc duty cycle)	WLAN	8.86	± 9.6 %
10620	AAB	IEEE 802.11ac WiFi (40MHz, MCS4, 90pc duty cycle)	WLAN	8.87	± 9.6 %
10621	AAB	IEEE 802.11ac WiFi (40MHz, MCS5, 90pc duty cycle)	WLAN	8.77	± 9.6 %
10622	AAB	IEEE 802.11ac WiFi (40MHz, MCS6, 90pc duty cycle)	WLAN	8.68	± 9.6 %
10623	AAB	IEEE 802.11ac WiFi (40MHz, MCS7, 90pc duty cycle)	WLAN	8.82	± 9.6 %
10624	AAB	IEEE 802.11ac WiFi (40MHz, MCS8, 90pc duty cycle)	WLAN	8.96	± 9.6 %
10625	AAB	IEEE 802.11ac WiFi (40MHz, MCS9, 90pc duty cycle)	WLAN	8.96	± 9.6 %
10626	AAB	IEEE 802.11ac WiFi (80MHz, MCS0, 90pc duty cycle)	WLAN	8.83	± 9.6 %
10627	AAB	IEEE 802.11ac WiFi (80MHz, MCS1, 90pc duty cycle)	WLAN	8.88	± 9.6 %
10628	AAB	IEEE 802.11ac WiFi (80MHz, MCS2, 90pc duty cycle)	WLAN	8.71	± 9.6 %
10629	AAB	IEEE 802.11ac WiFi (80MHz, MCS3, 90pc duty cycle)	WLAN	8.85	± 9.6 %
10630	AAB	IEEE 802.11ac WiFi (80MHz, MCS4, 90pc duty cycle)	WLAN	8.72	± 9.6 %
10631	AAB	IEEE 802.11ac WiFi (80MHz, MCS5, 90pc duty cycle)	WLAN	8.81	± 9.6 %
10632	AAB	IEEE 802.11ac WiFi (80MHz, MCS6, 90pc duty cycle)	WLAN	8.74	± 9.6 %
10633	AAB	IEEE 802.11ac WiFi (80MHz, MCS7, 90pc duty cycle)	WLAN	8.83	± 9.6 %
10634	AAB	IEEE 802.11ac WiFi (80MHz, MCS8, 90pc duty cycle)	WLAN	8.80	± 9.6 %
10635	AAB	IEEE 802.11ac WiFi (80MHz, MCS9, 90pc duty cycle)	WLAN	8.81	± 9.6 %
10636	AAC	IEEE 802.11ac WiFi (160MHz, MCS0, 90pc duty cycle)	WLAN	8.83	± 9.6 %
10637	AAC	IEEE 802.11ac WiFi (160MHz, MCS1, 90pc duty cycle)	WLAN	8.79	± 9.6 %
10638	AAC	IEEE 802.11ac WiFi (160MHz, MCS2, 90pc duty cycle)	WLAN	8.86	± 9.6 %
10639	AAC	IEEE 802.11ac WiFi (160MHz, MCS3, 90pc duty cycle)	WLAN	8.85	± 9.6 %
10640	AAC	IEEE 802.11ac WiFi (160MHz, MCS4, 90pc duty cycle)	WLAN	8.98	± 9.6 %
10641	AAC	IEEE 802.11ac WiFi (160MHz, MCS5, 90pc duty cycle)	WLAN	9.06	± 9.6 %
10642	AAC	IEEE 802.11ac WiFi (160MHz, MCS6, 90pc duty cycle)	WLAN	9.06	± 9.6 %
10643	AAC	IEEE 802.11ac WiFi (160MHz, MCS7, 90pc duty cycle)	WLAN	8.89	± 9.6 %
10644	AAC	IEEE 802.11ac WiFi (160MHz, MCS8, 90pc duty cycle)	WLAN	9.05	± 9.6 %
10645	AAC	IEEE 802.11ac WiFi (160MHz, MCS9, 90pc duty cycle)	WLAN	9.11	± 9.6 %
10646	AAG	LTE-TDD (SC-FDMA, 1 RB, 5 MHz, QPSK, UL Subframe=2,7)	LTE-TDD	11.96	± 9.6 %
10647	AAF	LTE-TDD (SC-FDMA, 1 RB, 20 MHz, QPSK, UL Subframe=2,7)	LTE-TDD	11.96	± 9.6 %
10648	AAA	CDMA2000 (1x Advanced)	CDMA2000	3.45	± 9.6 %
10652	AAE	LTE-TDD (OFDMA, 5 MHz, E-TM 3.1, Clipping 44%)	LTE-TDD	6.91	± 9.6 %
10653	AAE	LTE-TDD (OFDMA, 10 MHz, E-TM 3.1, Clipping 44%)	LTE-TDD	7.42	± 9.6 %

10654	AAD	LTE-TDD (OFDMA, 15 MHz, E-TM 3.1, Clipping 44%)	LTE-TDD	6.96	± 9.6 %
10655	AAE	LTE-TDD (OFDMA, 20 MHz, E-TM 3.1, Clipping 44%)	LTE-TDD	7.21	± 9.6 %
10658	AAA	Pulse Waveform (200Hz, 10%)	Test	10.00	± 9.6 %
10659	AAA	Pulse Waveform (200Hz, 20%)	Test	6.99	± 9.6 %
10660	AAA	Pulse Waveform (200Hz, 40%)	Test	3.98	± 9.6 %
10661	AAA	Pulse Waveform (200Hz, 60%)	Test	2.22	± 9.6 %
10662	AAA	Pulse Waveform (200Hz, 80%)	Test	0.97	± 9.6 %
10670	AAA	Bluetooth Low Energy	Bluetooth	2.19	± 9.6 %
10671	AAA	IEEE 802.11ax (20MHz, MCS0, 90pc duty cycle)	WLAN	9.09	± 9.6 %
10672	AAA	IEEE 802.11ax (20MHz, MCS1, 90pc duty cycle)	WLAN	8.57	± 9.6 %
10673	AAA	IEEE 802.11ax (20MHz, MCS2, 90pc duty cycle)	WLAN	8.78	± 9.6 %
10674	AAA	IEEE 802.11ax (20MHz, MCS3, 90pc duty cycle)	WLAN	8.74	± 9.6 %
10675	AAA	IEEE 802.11ax (20MHz, MCS4, 90pc duty cycle)	WLAN	8.90	± 9.6 %
10676	AAA	IEEE 802.11ax (20MHz, MCS5, 90pc duty cycle)	WLAN	8.77	± 9.6 %
10677	AAA	IEEE 802.11ax (20MHz, MCS6, 90pc duty cycle)	WLAN	8.73	± 9.6 %
10678	AAA	IEEE 802.11ax (20MHz, MCS7, 90pc duty cycle)	WLAN	8.78	± 9.6 %
10679	AAA	IEEE 802.11ax (20MHz, MCS8, 90pc duty cycle)	WLAN	8.89	± 9.6 %
10680	AAA	IEEE 802.11ax (20MHz, MCS9, 90pc duty cycle)	WLAN	8.80	± 9.6 %
10681	AAA	IEEE 802.11ax (20MHz, MCS10, 90pc duty cycle)	WLAN	8.62	± 9.6 %
10682	AAA	IEEE 802.11ax (20MHz, MCS11, 90pc duty cycle)	WLAN	8.83	± 9.6 %
10683	AAA	IEEE 802.11ax (20MHz, MCS0, 99pc duty cycle)	WLAN	8.42	± 9.6 %
10684	AAA	IEEE 802.11ax (20MHz, MCS1, 99pc duty cycle)	WLAN	8.26	± 9.6 %
10685	AAA	IEEE 802.11ax (20MHz, MCS2, 99pc duty cycle)	WLAN	8.33	± 9.6 %
10686	AAA	IEEE 802.11ax (20MHz, MCS3, 99pc duty cycle)	WLAN	8.28	± 9.6 %
10687	AAA	IEEE 802.11ax (20MHz, MCS4, 99pc duty cycle)	WLAN	8.45	± 9.6 %
10688	AAA	IEEE 802.11ax (20MHz, MCS5, 99pc duty cycle)	WLAN	8.29	± 9.6 %
10689	AAA	IEEE 802.11ax (20MHz, MCS6, 99pc duty cycle)	WLAN	8.55	± 9.6 %
10690	AAA	IEEE 802.11ax (20MHz, MCS7, 99pc duty cycle)	WLAN	8.29	± 9.6 %
10691	AAA	IEEE 802.11ax (20MHz, MCS8, 99pc duty cycle)	WLAN	8.25	± 9.6 %
10692	AAA	IEEE 802.11ax (20MHz, MCS9, 99pc duty cycle)	WLAN	8.29	± 9.6 %
10693	AAA	IEEE 802.11ax (20MHz, MCS10, 99pc duty cycle)	WLAN	8.25	± 9.6 %
10694	AAA	IEEE 802.11ax (20MHz, MCS11, 99pc duty cycle)	WLAN	8.57	± 9.6 %
10695	AAA	IEEE 802.11ax (40MHz, MCS0, 90pc duty cycle)	WLAN	8.78	± 9.6 %
10696	AAA	IEEE 802.11ax (40MHz, MCS1, 90pc duty cycle)	WLAN	8.91	± 9.6 %
10697	AAA	IEEE 802.11ax (40MHz, MCS2, 90pc duty cycle)	WLAN	8.61	± 9.6 %
10698	AAA	IEEE 802.11ax (40MHz, MCS3, 90pc duty cycle)	WLAN	8.89	± 9.6 %
10699	AAA	IEEE 802.11ax (40MHz, MCS4, 90pc duty cycle)	WLAN	8.82	± 9.6 %
10700	AAA	IEEE 802.11ax (40MHz, MCS5, 90pc duty cycle)	WLAN	8.73	± 9.6 %
10701	AAA	IEEE 802.11ax (40MHz, MCS6, 90pc duty cycle)	WLAN	8.86	± 9.6 %
10702	AAA	IEEE 802.11ax (40MHz, MCS7, 90pc duty cycle)	WLAN	8.70	± 9.6 %
10703	AAA	IEEE 802.11ax (40MHz, MCS8, 90pc duty cycle)	WLAN	8.82	± 9.6 %
10704	AAA	IEEE 802.11ax (40MHz, MCS9, 90pc duty cycle)	WLAN	8.56	± 9.6 %
10705	AAA	IEEE 802.11ax (40MHz, MCS10, 90pc duty cycle)	WLAN	8.69	± 9.6 %
10706	AAA	IEEE 802.11ax (40MHz, MCS11, 90pc duty cycle)	WLAN	8.66	± 9.6 %
10707	AAA	IEEE 802.11ax (40MHz, MCS0, 99pc duty cycle)	WLAN	8.32	± 9.6 %
10708	AAA	IEEE 802.11ax (40MHz, MCS1, 99pc duty cycle)	WLAN	8.55	± 9.6 %
10709	AAA	IEEE 802.11ax (40MHz, MCS2, 99pc duty cycle)	WLAN	8.33	± 9.6 %
10710	AAA	IEEE 802.11ax (40MHz, MCS3, 99pc duty cycle)	WLAN	8.29	± 9.6 %
10711	AAA	IEEE 802.11ax (40MHz, MCS4, 99pc duty cycle)	WLAN	8.39	± 9.6 %
10712	AAA	IEEE 802.11ax (40MHz, MCS5, 99pc duty cycle)	WLAN	8.67	± 9.6 %
10713	AAA	IEEE 802.11ax (40MHz, MCS6, 99pc duty cycle)	WLAN	8.33	± 9.6 %
10714	AAA	IEEE 802.11ax (40MHz, MCS7, 99pc duty cycle)	WLAN	8.26	± 9.6 %
10715	AAA	IEEE 802.11ax (40MHz, MCS8, 99pc duty cycle)	WLAN	8.45	± 9.6 %
10716	AAA	IEEE 802.11ax (40MHz, MCS9, 99pc duty cycle)	WLAN	8.30	± 9.6 %
10717	AAA	IEEE 802.11ax (40MHz, MCS10, 99pc duty cycle)	WLAN	8.48	± 9.6 %
10718	AAA	IEEE 802.11ax (40MHz, MCS11, 99pc duty cycle)	WLAN	8.24	± 9.6 %
10719	AAA	IEEE 802.11ax (80MHz, MCS0, 90pc duty cycle)	WLAN	8.81	± 9.6 %
10720	AAA	IEEE 802.11ax (80MHz, MCS1, 90pc duty cycle)	WLAN	8.87	± 9.6 %
10721	AAA	IEEE 802.11ax (80MHz, MCS2, 90pc duty cycle)	WLAN	8.76	± 9.6 %
10722	AAA	IEEE 802.11ax (80MHz, MCS3, 90pc duty cycle)	WLAN	8.55	± 9.6 %
10723	AAA	IEEE 802.11ax (80MHz, MCS4, 90pc duty cycle)	WLAN	8.70	± 9.6 %
10724	AAA	IEEE 802.11ax (80MHz, MCS5, 90pc duty cycle)	WLAN	8.90	± 9.6 %
10725	AAA	IEEE 802.11ax (80MHz, MCS6, 90pc duty cycle)	WLAN	8.74	± 9.6 %
10726	AAA	IEEE 802.11ax (80MHz, MCS7, 90pc duty cycle)	WLAN	8.72	± 9.6 %

10727	AAA	IEEE 802.11ax (80MHz, MCS8, 90pc duty cycle)	WLAN	8.66	± 9.6 %
10728	AAA	IEEE 802.11ax (80MHz, MCS9, 90pc duty cycle)	WLAN	8.65	± 9.6 %
10729	AAA	IEEE 802.11ax (80MHz, MCS10, 90pc duty cycle)	WLAN	8.64	± 9.6 %
10730	AAA	IEEE 802.11ax (80MHz, MCS11, 90pc duty cycle)	WLAN	8.67	± 9.6 %
10731	AAA	IEEE 802.11ax (80MHz, MCS0, 99pc duty cycle)	WLAN	8.42	± 9.6 %
10732	AAA	IEEE 802.11ax (80MHz, MCS1, 99pc duty cycle)	WLAN	8.46	± 9.6 %
10733	AAA	IEEE 802.11ax (80MHz, MCS2, 99pc duty cycle)	WLAN	8.40	± 9.6 %
10734	AAA	IEEE 802.11ax (80MHz, MCS3, 99pc duty cycle)	WLAN	8.25	± 9.6 %
10735	AAA	IEEE 802.11ax (80MHz, MCS4, 99pc duty cycle)	WLAN	8.33	± 9.6 %
10736	AAA	IEEE 802.11ax (80MHz, MCS5, 99pc duty cycle)	WLAN	8.27	± 9.6 %
10737	AAA	IEEE 802.11ax (80MHz, MCS6, 99pc duty cycle)	WLAN	8.36	± 9.6 %
10738	AAA	IEEE 802.11ax (80MHz, MCS7, 99pc duty cycle)	WLAN	8.42	± 9.6 %
10739	AAA	IEEE 802.11ax (80MHz, MCS8, 99pc duty cycle)	WLAN	8.29	± 9.6 %
10740	AAA	IEEE 802.11ax (80MHz, MCS9, 99pc duty cycle)	WLAN	8.48	± 9.6 %
10741	AAA	IEEE 802.11ax (80MHz, MCS10, 99pc duty cycle)	WLAN	8.40	± 9.6 %
10742	AAA	IEEE 802.11ax (80MHz, MCS11, 99pc duty cycle)	WLAN	8.43	± 9.6 %
10743	AAA	IEEE 802.11ax (160MHz, MCS0, 90pc duty cycle)	WLAN	8.94	± 9.6 %
10744	AAA	IEEE 802.11ax (160MHz, MCS1, 90pc duty cycle)	WLAN	9.16	± 9.6 %
10745	AAA	IEEE 802.11ax (160MHz, MCS2, 90pc duty cycle)	WLAN	8.93	± 9.6 %
10746	AAA	IEEE 802.11ax (160MHz, MCS3, 90pc duty cycle)	WLAN	9.11	± 9.6 %
10747	AAA	IEEE 802.11ax (160MHz, MCS4, 90pc duty cycle)	WLAN	9.04	± 9.6 %
10748	AAA	IEEE 802.11ax (160MHz, MCS5, 90pc duty cycle)	WLAN	8.93	± 9.6 %
10749	AAA	IEEE 802.11ax (160MHz, MCS6, 90pc duty cycle)	WLAN	8.90	± 9.6 %
10750	AAA	IEEE 802.11ax (160MHz, MCS7, 90pc duty cycle)	WLAN	8.79	± 9.6 %
10751	AAA	IEEE 802.11ax (160MHz, MCS8, 90pc duty cycle)	WLAN	8.82	± 9.6 %
10752	AAA	IEEE 802.11ax (160MHz, MCS9, 90pc duty cycle)	WLAN	8.81	± 9.6 %
10753	AAA	IEEE 802.11ax (160MHz, MCS10, 90pc duty cycle)	WLAN	9.00	± 9.6 %
10754	AAA	IEEE 802.11ax (160MHz, MCS11, 90pc duty cycle)	WLAN	8.94	± 9.6 %
10755	AAA	IEEE 802.11ax (160MHz, MCS0, 99pc duty cycle)	WLAN	8.64	± 9.6 %
10756	AAA	IEEE 802.11ax (160MHz, MCS1, 99pc duty cycle)	WLAN	8.77	± 9.6 %
10757	AAA	IEEE 802.11ax (160MHz, MCS2, 99pc duty cycle)	WLAN	8.77	± 9.6 %
10758	AAA	IEEE 802.11ax (160MHz, MCS3, 99pc duty cycle)	WLAN	8.69	± 9.6 %
10759	AAA	IEEE 802.11ax (160MHz, MCS4, 99pc duty cycle)	WLAN	8.58	± 9.6 %
10760	AAA	IEEE 802.11ax (160MHz, MCS5, 99pc duty cycle)	WLAN	8.49	± 9.6 %
10761	AAA	IEEE 802.11ax (160MHz, MCS6, 99pc duty cycle)	WLAN	8.58	± 9.6 %
10762	AAA	IEEE 802.11ax (160MHz, MCS7, 99pc duty cycle)	WLAN	8.49	± 9.6 %
10763	AAA	IEEE 802.11ax (160MHz, MCS8, 99pc duty cycle)	WLAN	8.53	± 9.6 %
10764	AAA	IEEE 802.11ax (160MHz, MCS9, 99pc duty cycle)	WLAN	8.54	± 9.6 %
10765	AAA	IEEE 802.11ax (160MHz, MCS10, 99pc duty cycle)	WLAN	8.54	± 9.6 %
10766	AAA	IEEE 802.11ax (160MHz, MCS11, 99pc duty cycle)	WLAN	8.51	± 9.6 %
10767	AAB	5G NR (CP-OFDM, 1 RB, 5 MHz, QPSK, 15 kHz)	5G NR FR1 TDD	7.99	± 9.6 %
10768	AAB	5G NR (CP-OFDM, 1 RB, 10 MHz, QPSK, 15 kHz)	5G NR FR1 TDD	8.01	± 9.6 %
10769	AAB	5G NR (CP-OFDM, 1 RB, 15 MHz, QPSK, 15 kHz)	5G NR FR1 TDD	8.01	± 9.6 %
10770	AAB	5G NR (CP-OFDM, 1 RB, 20 MHz, QPSK, 15 kHz)	5G NR FR1 TDD	8.02	± 9.6 %
10771	AAB	5G NR (CP-OFDM, 1 RB, 25 MHz, QPSK, 15 kHz)	5G NR FR1 TDD	8.02	± 9.6 %
10772	AAB	5G NR (CP-OFDM, 1 RB, 30 MHz, QPSK, 15 kHz)	5G NR FR1 TDD	8.23	± 9.6 %
10773	AAB	5G NR (CP-OFDM, 1 RB, 40 MHz, QPSK, 15 kHz)	5G NR FR1 TDD	8.03	± 9.6 %
10774	AAB	5G NR (CP-OFDM, 1 RB, 50 MHz, QPSK, 15 kHz)	5G NR FR1 TDD	8.02	± 9.6 %
10776	AAB	5G NR (CP-OFDM, 50% RB, 10 MHz, QPSK, 15 kHz)	5G NR FR1 TDD	8.30	± 9.6 %
10778	AAB	5G NR (CP-OFDM, 50% RB, 20 MHz, QPSK, 15 kHz)	5G NR FR1 TDD	8.34	± 9.6 %
10780	AAB	5G NR (CP-OFDM, 50% RB, 30 MHz, QPSK, 15 kHz)	5G NR FR1 TDD	8.38	± 9.6 %
10781	AAB	5G NR (CP-OFDM, 50% RB, 40 MHz, QPSK, 15 kHz)	5G NR FR1 TDD	8.38	± 9.6 %

10782	AAB	5G NR (CP-OFDM, 50% RB, 50 MHz, QPSK, 15 kHz)	5G NR FR1 TDD	8.43	± 9.6 %
10783	AAB	5G NR (CP-OFDM, 100% RB, 5 MHz, QPSK, 15 kHz)	5G NR FR1 TDD	8.31	± 9.6 %
10784	AAB	5G NR (CP-OFDM, 100% RB, 10 MHz, QPSK, 15 kHz)	5G NR FR1 TDD	8.29	± 9.6 %
10785	AAB	5G NR (CP-OFDM, 100% RB, 15 MHz, QPSK, 15 kHz)	5G NR FR1 TDD	8.40	± 9.6 %
10786	AAB	5G NR (CP-OFDM, 100% RB, 20 MHz, QPSK, 15 kHz)	5G NR FR1 TDD	8.35	± 9.6 %
10787	AAB	5G NR (CP-OFDM, 100% RB, 25 MHz, QPSK, 15 kHz)	5G NR FR1 TDD	8.44	± 9.6 %
10788	AAB	5G NR (CP-OFDM, 100% RB, 30 MHz, QPSK, 15 kHz)	5G NR FR1 TDD	8.39	± 9.6 %
10789	AAB	5G NR (CP-OFDM, 100% RB, 40 MHz, QPSK, 15 kHz)	5G NR FR1 TDD	8.37	± 9.6 %
10790	AAB	5G NR (CP-OFDM, 100% RB, 50 MHz, QPSK, 15 kHz)	5G NR FR1 TDD	8.39	± 9.6 %
10791	AAB	5G NR (CP-OFDM, 1 RB, 5 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	7.83	± 9.6 %
10792	AAB	5G NR (CP-OFDM, 1 RB, 10 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	7.92	± 9.6 %
10793	AAB	5G NR (CP-OFDM, 1 RB, 15 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	7.95	± 9.6 %
10794	AAB	5G NR (CP-OFDM, 1 RB, 20 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	7.82	± 9.6 %
10795	AAB	5G NR (CP-OFDM, 1 RB, 25 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	7.84	± 9.6 %
10796	AAB	5G NR (CP-OFDM, 1 RB, 30 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	7.82	± 9.6 %
10797	AAB	5G NR (CP-OFDM, 1 RB, 40 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	8.01	± 9.6 %
10798	AAB	5G NR (CP-OFDM, 1 RB, 50 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	7.89	± 9.6 %
10799	AAB	5G NR (CP-OFDM, 1 RB, 60 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	7.93	± 9.6 %
10801	AAB	5G NR (CP-OFDM, 1 RB, 80 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	7.89	± 9.6 %
10802	AAB	5G NR (CP-OFDM, 1 RB, 90 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	7.87	± 9.6 %
10803	AAB	5G NR (CP-OFDM, 1 RB, 100 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	7.93	± 9.6 %
10805	AAB	5G NR (CP-OFDM, 50% RB, 10 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	8.34	± 9.6 %
10806	AAB	5G NR (CP-OFDM, 50% RB, 15 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	8.37	± 9.6 %
10809	AAB	5G NR (CP-OFDM, 50% RB, 30 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	8.34	± 9.6 %
10810	AAB	5G NR (CP-OFDM, 50% RB, 40 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	8.34	± 9.6 %
10812	AAB	5G NR (CP-OFDM, 50% RB, 60 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	8.35	± 9.6 %
10817	AAB	5G NR (CP-OFDM, 100% RB, 5 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	8.35	± 9.6 %
10818	AAB	5G NR (CP-OFDM, 100% RB, 10 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	8.34	± 9.6 %
10819	AAB	5G NR (CP-OFDM, 100% RB, 15 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	8.33	± 9.6 %
10820	AAB	5G NR (CP-OFDM, 100% RB, 20 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	8.30	± 9.6 %
10821	AAB	5G NR (CP-OFDM, 100% RB, 25 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	8.41	± 9.6 %
10822	AAB	5G NR (CP-OFDM, 100% RB, 30 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	8.41	± 9.6 %
10823	AAB	5G NR (CP-OFDM, 100% RB, 40 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	8.36	± 9.6 %

10824	AAB	5G NR (CP-OFDM, 100% RB, 50 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	8.39	± 9.6 %
10825	AAB	5G NR (CP-OFDM, 100% RB, 60 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	8.41	± 9.6 %
10827	AAB	5G NR (CP-OFDM, 100% RB, 80 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	8.42	± 9.6 %
10828	AAB	5G NR (CP-OFDM, 100% RB, 90 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	8.43	± 9.6 %
10829	AAB	5G NR (CP-OFDM, 100% RB, 100 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	8.40	± 9.6 %
10830	AAB	5G NR (CP-OFDM, 1 RB, 10 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	7.63	± 9.6 %
10831	AAB	5G NR (CP-OFDM, 1 RB, 15 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	7.73	± 9.6 %
10832	AAB	5G NR (CP-OFDM, 1 RB, 20 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	7.74	± 9.6 %
10833	AAB	5G NR (CP-OFDM, 1 RB, 25 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	7.70	± 9.6 %
10834	AAB	5G NR (CP-OFDM, 1 RB, 30 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	7.75	± 9.6 %
10835	AAB	5G NR (CP-OFDM, 1 RB, 40 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	7.70	± 9.6 %
10836	AAB	5G NR (CP-OFDM, 1 RB, 50 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	7.66	± 9.6 %
10837	AAB	5G NR (CP-OFDM, 1 RB, 60 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	7.68	± 9.6 %
10839	AAB	5G NR (CP-OFDM, 1 RB, 80 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	7.70	± 9.6 %
10840	AAB	5G NR (CP-OFDM, 1 RB, 90 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	7.67	± 9.6 %
10841	AAB	5G NR (CP-OFDM, 1 RB, 100 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	7.71	± 9.6 %
10843	AAB	5G NR (CP-OFDM, 50% RB, 15 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	8.49	± 9.6 %
10844	AAB	5G NR (CP-OFDM, 50% RB, 20 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	8.34	± 9.6 %
10846	AAB	5G NR (CP-OFDM, 50% RB, 30 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	8.41	± 9.6 %
10854	AAB	5G NR (CP-OFDM, 100% RB, 10 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	8.34	± 9.6 %
10855	AAB	5G NR (CP-OFDM, 100% RB, 15 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	8.36	± 9.6 %
10856	AAB	5G NR (CP-OFDM, 100% RB, 20 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	8.37	± 9.6 %
10857	AAB	5G NR (CP-OFDM, 100% RB, 25 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	8.35	± 9.6 %
10858	AAB	5G NR (CP-OFDM, 100% RB, 30 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	8.36	± 9.6 %
10859	AAB	5G NR (CP-OFDM, 100% RB, 40 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	8.34	± 9.6 %
10860	AAB	5G NR (CP-OFDM, 100% RB, 50 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	8.41	± 9.6 %
10861	AAB	5G NR (CP-OFDM, 100% RB, 60 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	8.40	± 9.6 %
10863	AAB	5G NR (CP-OFDM, 100% RB, 80 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	8.41	± 9.6 %
10864	AAB	5G NR (CP-OFDM, 100% RB, 90 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	8.37	± 9.6 %
10865	AAB	5G NR (CP-OFDM, 100% RB, 100 MHz, QPSK, 60 kHz)	5G NR FR1 TDD	8.41	± 9.6 %
10866	AAB	5G NR (DFT-s-OFDM, 1 RB, 100 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	5.68	± 9.6 %
10868	AAB	5G NR (DFT-s-OFDM, 100% RB, 100 MHz, QPSK, 30 kHz)	5G NR FR1 TDD	5.89	± 9.6 %
10869	AAC	5G NR (DFT-s-OFDM, 1 RB, 100 MHz, QPSK, 120 kHz)	5G NR FR2 TDD	5.75	± 9.6 %

10870	AAC	5G NR (DFT-s-OFDM, 100% RB, 100 MHz, QPSK, 120 kHz)	5G NR FR2 TDD	5.86	± 9.6 %
10871	AAC	5G NR (DFT-s-OFDM, 1 RB, 100 MHz, 16QAM, 120 kHz)	5G NR FR2 TDD	5.75	± 9.6 %
10872	AAC	5G NR (DFT-s-OFDM, 100% RB, 100 MHz, 16QAM, 120 kHz)	5G NR FR2 TDD	6.52	± 9.6 %
10873	AAC	5G NR (DFT-s-OFDM, 1 RB, 100 MHz, 64QAM, 120 kHz)	5G NR FR2 TDD	6.61	± 9.6 %
10874	AAC	5G NR (DFT-s-OFDM, 100% RB, 100 MHz, 64QAM, 120 kHz)	5G NR FR2 TDD	6.65	± 9.6 %
10875	AAC	5G NR (CP-OFDM, 1 RB, 100 MHz, QPSK, 120 kHz)	5G NR FR2 TDD	7.78	± 9.6 %
10876	AAC	5G NR (CP-OFDM, 100% RB, 100 MHz, QPSK, 120 kHz)	5G NR FR2 TDD	8.39	± 9.6 %
10877	AAC	5G NR (CP-OFDM, 1 RB, 100 MHz, 16QAM, 120 kHz)	5G NR FR2 TDD	7.95	± 9.6 %
10878	AAC	5G NR (CP-OFDM, 100% RB, 100 MHz, 16QAM, 120 kHz)	5G NR FR2 TDD	8.41	± 9.6 %
10879	AAC	5G NR (CP-OFDM, 1 RB, 100 MHz, 64QAM, 120 kHz)	5G NR FR2 TDD	8.12	± 9.6 %
10880	AAC	5G NR (CP-OFDM, 100% RB, 100 MHz, 64QAM, 120 kHz)	5G NR FR2 TDD	8.38	± 9.6 %
10881	AAC	5G NR (DFT-s-OFDM, 1 RB, 50 MHz, QPSK, 120 kHz)	5G NR FR2 TDD	5.75	± 9.6 %
10882	AAC	5G NR (DFT-s-OFDM, 100% RB, 50 MHz, QPSK, 120 kHz)	5G NR FR2 TDD	5.96	± 9.6 %
10883	AAC	5G NR (DFT-s-OFDM, 1 RB, 50 MHz, 16QAM, 120 kHz)	5G NR FR2 TDD	6.57	± 9.6 %
10884	AAC	5G NR (DFT-s-OFDM, 100% RB, 50 MHz, 16QAM, 120 kHz)	5G NR FR2 TDD	6.53	± 9.6 %
10885	AAC	5G NR (DFT-s-OFDM, 1 RB, 50 MHz, 64QAM, 120 kHz)	5G NR FR2 TDD	6.61	± 9.6 %
10886	AAC	5G NR (DFT-s-OFDM, 100% RB, 50 MHz, 64QAM, 120 kHz)	5G NR FR2 TDD	6.65	± 9.6 %
10887	AAC	5G NR (CP-OFDM, 1 RB, 50 MHz, QPSK, 120 kHz)	5G NR FR2 TDD	7.78	± 9.6 %
10888	AAC	5G NR (CP-OFDM, 100% RB, 50 MHz, QPSK, 120 kHz)	5G NR FR2 TDD	8.35	± 9.6 %
10889	AAC	5G NR (CP-OFDM, 1 RB, 50 MHz, 16QAM, 120 kHz)	5G NR FR2 TDD	8.02	± 9.6 %
10890	AAC	5G NR (CP-OFDM, 100% RB, 50 MHz, 16QAM, 120 kHz)	5G NR FR2 TDD	8.40	± 9.6 %
10891	AAC	5G NR (CP-OFDM, 1 RB, 50 MHz, 64QAM, 120 kHz)	5G NR FR2 TDD	8.13	± 9.6 %
10892	AAC	5G NR (CP-OFDM, 100% RB, 50 MHz, 64QAM, 120 kHz)	5G NR FR2 TDD	8.41	± 9.6 %

[E] Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

Calibration Laboratory of
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Zeughausstrasse 43, 8004 Zurich, Switzerland

S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
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Accreditation No.: SCS 0108

Client **PC Test**

Certificate No: 5G-Veri30-1035_Feb20

CALIBRATION CERTIFICATE

Object	5G Verification Source 30 GHz - SN: 1035
Calibration procedure(s)	QA CAL-45.v2 Calibration procedure for sources in air above 6 GHz
Calibration date:	February 12, 2020

MAB 4/8/20

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Reference Probe EUmmWV3	SN: 9374	31-Dec-19 (No. EUmmWV3-9374_Dec19)	Dec-20
DAE4ip	SN: 1602	01-Oct-19 (No. DAE4ip-1602_Oct19)	Oct-20

Secondary Standards	ID #	Check Date (in house)	Scheduled Check

	Name	Function	Signature
Calibrated by:	Jeton Kastrati	Laboratory Technician	
Approved by:	Katja Pokovic	Technical Manager	

Issued: February 18, 2020

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Glossary

CW Continuous wave

Calibration is Performed According to the Following Standards

- Internal procedure QA CAL-45-5Gsources
- IEC TR 63170 ED1, "Measurement procedure for the evaluation of power density related to human exposure to radio frequency fields from wireless communication devices operating between 6 GHz and 100 GHz", January 2018

Methods Applied and Interpretation of Parameters

- *Coordinate System:* z-axis in the waveguide horn boresight, x-axis is in the direction of the E-field, y-axis normal to the others in the field scanning plane parallel to the horn flare and horn flange.
- *Measurement Conditions: (1) 10 GHz:* The forward power to the horn antenna is measured prior and after the measurement with a power sensor. During the measurements, the horn is directly connected to the cable and the antenna ohmic and mismatch losses are determined by far-field measurements. *(2) 30, 45, 60 and 90 GHz:* The verification sources are switched on for at least 30 minutes. Absorbers are used around the probe cub and at the ceiling to minimize reflections.
- *Horn Positioning:* The waveguide horn is mounted vertically on the flange of the waveguide source to allow vertical positioning of the EUmmW probe during the scan. The plane is parallel to the phantom surface. Probe distance is verified using mechanical gauges positioned on the flare of the horn.
- *E- field distribution:* E field is measured in two x-y-plane (10mm, 10mm + $\lambda/4$) with a vectorial E-field probe. The E-field value stated as calibration value represents the E-field-maxima and the averaged (1cm^2 and 4cm^2) power density values at 10mm in front of the horn.
- *Field polarization:* Above the open horn, linear polarization of the field is expected. This is verified graphically in the field representation.

Calibrated Quantity

- Local peak E-field (V/m) and peak values of the total and normal component of the poynting vector |Re{S}| and n.Re{S} averaged over the surface area of 1 cm^2 ($pS_{tot}avg1cm^2$ and $pS_n avg1cm^2$) and 4cm^2 ($pS_{tot}avg4cm^2$ and $pS_n avg4cm^2$) at the nominal operational frequency of the verification source.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	cDASY6 Module mmWave	V2.0
Phantom	5G Phantom	
Distance Horn Aperture - plane	10 mm	
XY Scan Resolution	dx, dy = 2.5 mm	
Number of measured planes	2 (10mm, 10mm + λ/4)	
Frequency	30 GHz ± 10 MHz	

Calibration Parameters, 30 GHz

Distance Horn Aperture to Measured Plane	***Prad***[1] ***(mW)***	**Max E-field (V/m)**	Uncertainty (k = 2)	Avg Power Density n.Re{S}, |Re{S}| (W/m2)		Uncertainty (k = 2)
				1 cm^2	**4** cm^2	
10 mm	29.0	**126**	1.27 dB	**36.5, 36.9**	**32.1, 32.5**	1.28 dB

[1] derived from far-field data

DASY Report

Measurement Report for 5G Verification Source 30 GHz, UID 0 -, Channel 30000 (30000.0MHz)

Device under Test Properties

Name, Manufacturer	Dimensions [mm]	IMEI	DUT Type
5G Verification Source 30 GHz	100.0 x 100.0 x 100.0	SN: 1035	-

Exposure Conditions

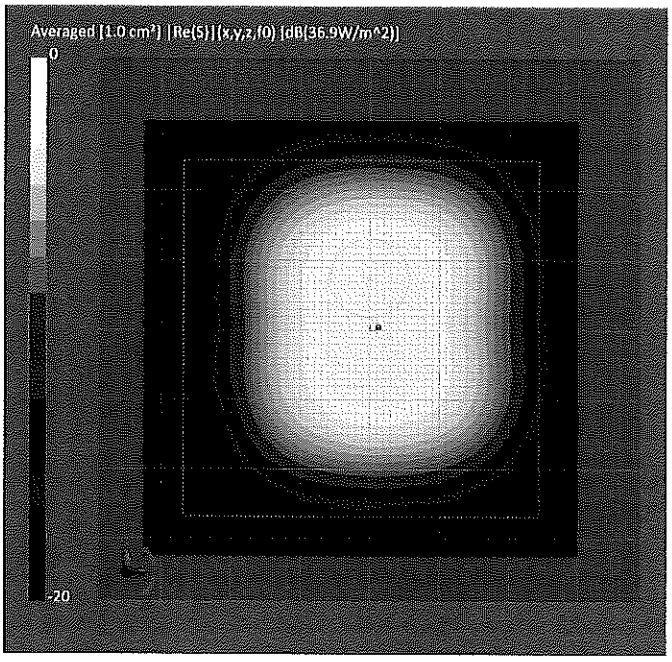
Phantom Section	Position, Test Distance [mm]	Band	Group,	Frequency [MHz], Channel Number	Conversion Factor
5G -	5.55 mm	Validation band	CW	30000.0, 30000	1.0

Hardware Setup

Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date
mmWave Phantom - 1002	Air	EUmmWV3 - SN9374_F1-78GHz, 2019-12-31	DAE4ip Sn1602, 2019-10-01

Scan Setup

	5G Scan
Grid Extents [mm]	60.0 x 60.0
Grid Steps [lambda]	0.25 x 0.25
Sensor Surface [mm]	5.55
MAIA	MAIA not used

Measurement Results

	5G Scan
Date	2020-02-12, 08:14
Avg. Area [cm²]	1.00
pS_{tot} avg [W/m²]	36.9
pS_n avg [W/m²]	36.5
E_{peak} [V/m]	126
Power Drift [dB]	-0.05